SAR Test Report

For

Applicant Name:	**Shenzhen DOOGEE Hengtong Technology CO., LTD**
Address:	B, 2/F, Building A4, Silicon Valley Power Digital Industrial Park, No. 22, Dafu Industrial Zone, Guanlan Aobei Community, Guanlan Street, Longhua New District, Shenzhen, Guangdong China
EUT Name:	Smart Phone
Model Number:	S118
Series Model Number:	V31, V31 GT, S110, S110 GT, V31 Plus, V31 Ultra, S118, S118 Pro, S118 S, S118 E, S118 SE, S118 Plus, S118 Max, S118 Ultra

Issued By

Company Name:	**BTF Testing Lab (Shenzhen) Co., Ltd.**
Address:	F101, 201 and 301, Building 1, Block 2, Tantou Industrial Park, Tantou Community, Songgang Street, Bao'an District, Shenzhen, China
Report Number:	BTF240614R00201
Test Standards:	FCC 47 CFR§2.1093 IEC/IEEE 62209-1528: 2020 IEEE C95.1-2019 KDB447498 D04 KDB865664 D01 KDB865664 D02 KDB941225 D01 KDB941225 D05 KDB248227 D01 KDB941225 D06 KDB648474 D04 KDB690783 D01
FCC ID:	2AX4YS118
Test Conclusion:	Pass
Test Date:	2024-06-18 to 2024-06-27
Date of Issue:	2024-06-28
Prepared By:	Amenda Zhong Amenda Zhong / Project Engineer
Date:	2024-06-28
Approved By:	Ryan.CJ Ryan.CJ / EMC Manager
Date:	2024-06-28

BTF Testing Lab (Shenzhen) Co., Ltd.

Note: All the test results in this report only related to the testing samples. Which can be duplicated completely for the legal use with approval of applicant; it shall not be reproduced except in full without the written approval of BTF Testing Lab (Shenzhen) Co., Ltd., All the objections should be raised within thirty days from the date of issue. To validate the report, you can contact us.

Revision History		
Version	Issue Date	Revisions Content
R_V0	2024-06-28	Original
Note:	*Once the revision has been made, then previous versions reports are invalid.*	

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BTF Testing Lab (Shenzhen) Co., Ltd.
F101, 201 and 301, Building 1, Block 2, Tantou Industrial Park, Tantou Community, Songgang Street, Bao'an District, Shenzhen, China

1. Introduction

1.1 Identification of Testing Laboratory

Company Name:	BTF Testing Lab (Shenzhen) Co., Ltd.
Address:	F101, 201 and 301, Building 1, Block 2, Tantou Industrial Park, Tantou Community, Songgang Street, Bao'an District, Shenzhen, China
Phone Number:	+86-0755-23146130
Fax Number:	+86-0755-23146130

1.2 Identification of the Responsible Testing Location

Test Location:	BTF Testing Lab (Shenzhen) Co., Ltd.
Address:	F101, 201 and 301, Building 1, Block 2, Tantou Industrial Park, Tantou Community, Songgang Street, Bao'an District, Shenzhen, China
Description:	All measurement facilities used to collect the measurement data are located at F101,201 and 301, Building 1, Block 2, Tantou Industrial Park, Tantou Community, Songgang Street, Bao'an District, Shenzhen, China
FCC Registration Number	518915
Designation Number	CN1330

1.3 Laboratory Condition

Ambient Temperature:	21℃ to 25℃
Ambient Relative Humidity:	48% to 59%
Ambient Pressure:	100 kPa to 102 kPa

1.4 Announcement

(1) The test report reference to the report template version v0.

(2) The test report is invalid if not marked with the signatures of the persons responsible for preparing, reviewing and approving the test report.

(3) The test report is invalid if there is any evidence and/or falsification.

(4) This document may not be altered or revised in any way unless done so by BTF and all revisions are duly noted in the revisions section.

(5) Content of the test report, in part or in full, cannot be used for publicity and/or promotional purposes without prior written approval from the laboratory.

(6) The laboratory is only responsible for the data released by the laboratory, except for the part provided by the applicant.

2. Product Information

2.1 Application Information

Company Name:	Shenzhen DOOGEE Hengtong Technology CO., LTD
Address:	B, 2/F, Building A4, Silicon Valley Power Digital Industrial Park, No. 22, Dafu Industrial Zone, Guanlan Aobei Community, Guanlan Street, Longhua New District, Shenzhen, Guangdong China

2.2 Manufacturer Information

Company Name:	Shenzhen DOOGEE Hengtong Technology CO., LTD
Address:	B, 2/F, Building A4, Silicon Valley Power Digital Industrial Park, No. 22, Dafu Industrial Zone, Guanlan Aobei Community, Guanlan Street, Longhua New District, Shenzhen, Guangdong China

2.3 Factory Information

Company Name:	Shenzhen DOOGEE Hengtong Technology CO., LTD
Address:	B, 2/F, Building A4, Silicon Valley Power Digital Industrial Park, No. 22, Dafu Industrial Zone, Guanlan Aobei Community, Guanlan Street, Longhua New District, Shenzhen, Guangdong China

2.4 General Description of Equipment under Test (EUT)

EUT Name	Smart Phone
Under Test Model Name	S118
Sample No.	BTFSN240614019/1 E1
Series Model Name	V31, V31 GT, S110, S110 GT, V31 Plus, V31 Ultra, S118, S118 Pro, S118 S, S118 E, S118 SE, S118 Plus, S118 Max, S118 Ultra
Description of Model name differentiation	Only the model name is different, everything else is the same.

2.5 Equipment under Test Ancillary Equipment

Ancillary Equipment 1	Rechargeable Battery	
	Capacity	10800mAh
	Rated Voltage	3.85V

2.6 Technical Information

Network and Wireless connectivity	2G Network GSM/GPRS/EGPRS 850/1900 3G Network WCDMA/HSDPA/HSUPA Band 2/4/5 4G Network FDD LTE Band 2/4/5/7/19/25/26/66 TDD LTE Band 38/41 2.4G WIFI 802.11b, 802.11g, 802.11n(HT20/40) 5G WIFI 802.11a, 802.11n(HT20/40), 802.11ac(VHT20/40/80) BT (EDR+BLE)

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The requirement for the following technical information of the EUT was tested in this report:

Operating Mode	GSM, WCDMA, LTE, WLAN, Bluetooth		
Frequency Range	GSM 850	TX: 824 ~ 849 MHz	RX: 869 ~ 894 MHz
	GSM 1900	TX: 1850 ~ 1910 MHz	RX: 1930 ~ 1990 MHz
	WCDMA Band 2	TX: 1850 ~ 1910 MHz	RX: 1930 ~ 1990 MHz
	WCDMA Band 4	TX: 1710 ~ 1755 MHz	RX: 2110 ~ 2155 MHz
	WCDMA Band 5	TX: 824 ~ 849 MHz	RX: 869 ~ 894 MHz
	LTE Band 2	TX: 1850 ~ 1910 MHz	RX: 1930 ~ 1990 MHz
	LTE Band 4	TX: 1710 ~ 1755 MHz	RX: 2110 ~ 2155 MHz
	LTE Band 5	TX: 824 ~ 849 MHz	RX: 869 ~ 894 MHz
	LTE Band 7	TX: 2500 ~ 2570 MHz	RX: 2620 ~ 2690 MHz
	LTE band 19	Tx: 830 ~ 845 MHz	Rx: 875 ~ 890 MHz
	LTE Band 25	TX: 1850 ~ 1915 MHz	RX: 1930 ~ 1995 MHz
	LTE Band 26 part 90	TX: 814.7 ~ 823.3 MHz	RX: 859.7 ~ 868.3 MHz
	LTE Band 26 part 22	TX: 824.7 ~ 848.3 MHz	RX: 869.7 ~ 893.3 MHz
	LTE Band 66	TX: 1710 ~ 1780 MHz	RX: 2110 ~ 2200 MHz
	LTE Band 38	2570 ~ 2620 MHz	
	LTE Band 41	2535 ~ 2655 MHz	
	802.11b/g/n(HT20)	2412 ~ 2462 MHz	
	802.11n(HT40)	2422 ~ 2452 MHz	
	802.11a /802.11n(HT20/40) /802.11ac(VHT20/40/80)	5150 ~ 5250 MHz 5250 ~ 5350 MHz 5470 ~ 5725 MHz 5725 ~ 5850 MHz	
	Bluetooth	2402 ~ 2480 MHz	
Antenna Type	WWAN: PIFA Antenna WLAN: PIFA Antenna BT: PIFA Antenna		
Hotspot Function	Support		
Power Reduction	Not Support		
Exposure Category	General Population/Uncontrolled exposure		
EUT Stage	Portable Device		
Product	Type		
	☐ Production unit	☒ Identical prototype	

3. Summary of Test Results

3.1 Test Standards

No.	Identity	Document Title
1	47 CFR Part 2.1093	Radiofrequency radiation exposure evaluation: portable devices
2	IEC/IEEE 62209-1528: 2020	Measurement procedure for the assessment of specific absorption rate of human exposure to radio frequency fields from hand-held and body-mounted wireless communication devices - Part 1528: Human models, instrumentation, and procedures (Frequency range of 4 MHz to 10 GHz)
3	IEEE C95.1-2019	IEEE Standard for Safety Levels with Respect to Human Exposure to Electric, Magnetic, and Electromagnetic Fields, 0 Hz to 300 GHz
4	KDB447498 D04	Interim General RF Exposure Guidance v01
5	KDB865664 D01	SAR measurement 100MHz to 6GHz v01r04
6	KDB865664 D02	RF Exposure Reporting v01r02
7	KDB941225 D01	3G SAR Procedures v03r01
8	KDB941225 D05	SAR for LTE Devices v02r05
9	KDB248227 D01	802.11 Wi-Fi SAR v02r02
10	KDB941225 D06	Hotspot Mode v02r01
11	KDB648474 D04	Handset SAR v01r03
12	KDB690783 D01	SAR Listings on Grant v01r03

3.2 Device Category and SAR Limit

This device belongs to portable device category because its radiating structure is allowed to be used within 20 centimeters of the body of the user. Limit for General Population/Uncontrolled exposure should be applied for this device, it is 1.6 W/kg as averaged over any 1 gram of tissue.

Body Position	SAR Value (W/Kg)	
	General Population/ Uncontrolled Exposure	Occupational/ Controlled Exposure
Whole-Body SAR (averaged over the entire body)	0.08	0.4
Partial-Body SAR (averaged over any 1 gram of tissue)	1.60	8.0
SAR for hands, wrists, feet and ankles (averaged over any 10 grams of tissue)	4.0	20.0

NOTE:
General Population/Uncontrolled Exposure: Locations where there is the exposure of individuals who have no knowledge or control of their exposure. General population/uncontrolled exposure limits are applicable to situations in which the general public may be exposed or in which persons who are exposed as a consequence of their employment may not be made fully aware of the potential for exposure or cannot exercise control over their exposure. Members of the general public would come under this category when exposure is not employment- related; for example, in the case of a wireless transmitter that exposes persons in its vicinity.

Occupational/Controlled Exposure: Locations where there is exposure that may be incurred by persons who are aware of the potential for exposure, In general, occupational/controlled exposure limits are applicable to situations in which persons are exposed as a consequence of their employment, who have been made fully aware of the potential for exposure and can exercise control over their exposure. This exposure category is also applicable when the exposure is of a transient nature due to incidental passage through a location where the exposure levels may be higher than the general population/uncontrolled limits, but the exposed person is fully aware of the potential for exposure and can exercise control over his or her exposure by leaving the area or by some other appropriate means.

3.3 Test Result Summary

The maximum results of Specific Absorption Rate (SAR) found during test as bellows:

<Highest Reported standalone SAR Summary>

Exposure Position	Frequency Band	Reported SAR (W/kg)	Equipment Class	Highest Reported SAR (W/kg)
Head 1-g SAR (0 mm Gap)	GSM 850	0.115	PCE	**0.717**
	GSM 1900	0.061		
	WCDMA Band II	**0.717**		
	WCDMA Band IV	0.520		
	WCDMA Band V	0.174		
	LTE Band 2	0.345		
	LTE Band 4	0.107		
	LTE Band 5	0.153		
	LTE Band 7	0.237		
	LTE Band 19	0.160		
	LTE Band 25	0.183		
	LTE Band 26 part 90	0.145		
	LTE Band 26 part 22	0.165		
	LTE Band 38	0.121		
	LTE Band 41	0.138		
	LTE Band 66	0.117		
	WLAN 2.4 GHz	0.582	DTS	
	WLAN 5.2 GHz	0.259	NII	
	WLAN 5.4 GHz	0.411		
	WLAN 5.6 GHz	0.271		
	WLAN 5.8 GHz	0.633		
	Bluetooth	0.075	DSS	
Exposure Position	**Frequency Band**	**Reported SAR (W/kg)**	**Equipment Class**	**Highest Reported SAR (W/kg)**
Hotspot(Body) 1-g SAR (10 mm Gap)	GSM 850	0.462	PCB	**1.104**
	GSM 1900	0.405		
	WCDMA Band II	1.026		
	WCDMA Band IV	0.981		
	WCDMA Band V	0.328		
	LTE Band 2	1.024		
	LTE Band 4	0.794		
	LTE Band 5	0.312		
	LTE Band 7	0.985		
	LTE Band 19	0.244		
	LTE Band 25	**1.104**		
	LTE Band 26 part 90	0.262		
	LTE Band 26 part 22	0.304		
	LTE Band 38	0.442		
	LTE Band 41	0.466		
	LTE Band 66	0.715		
	WLAN 2.4 GHz	0.191	DTS	
	WLAN 5.2 GHz	0.212	NII	
	WLAN 5.4 GHz	0.165		
	WLAN 5.6 GHz	0.184		
	WLAN 5.8 GHz	0.195		

This device is in compliance with Specific Absorption Rate(SAR) for general population/uncontrolled exposure limits (1.6 W/kg) specified in FCC47 CFR part 2(2.1093) and ANSI/IEEE C95.1-2019, and had been tested in accordance with the measurement methods and procedures specified in IEC/IEEE 62209-1528: 2020.

<Highest Reported Simultaneous SAR>

Exposure Position	Simultaneous Configuration	Highest Reported Simultaneous Transmission SAR (W/kg)	Limit (W/kg)	Verdict
Head 1-g SAR (0 mm Gap)	WCDMA Band II +5G WIFI	1.350	1.6	Pass
Hotspot(Body) 1-g SAR (10 mm Gap)	LTE band 25 + BT	1.268	1.6	Pass

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3.4 Test Uncertainty

3.4.1 Measurement uncertainly evaluation for SAR test

Measurement uncertainly evaluation for SAR test (300MHz to 6GHz)

Uncertainty Component	Tol (+- %)	Prob. Dist.	Div.	Ci (1g)	Ci (10g)	1g Ui (+- %)	10 g Ui (+-%)	Vi veff
Measurement System								
Probe calibration	5.8	N	1	1	1	5.80	5.80	∞
Axial Isotropy	3.5	R	√3	√0.5	√0.5	1.43	1.43	∞
Hemispherical Isotropy	5.9	R	√3	√0.5	√0.5	2.41	2.41	∞
Boundary effect	1.0	R	√3	1	1	0.58	0.58	∞
Linearity	4.7	R	√3	1	1	2.71	2.71	∞
System detection limits	1.0	R	√3	1	1	0.58	0.58	∞
Modulation response	3.0	R	√3	1	1	1.73	1.73	∞
Readout Electronics	0.5	N	1	1	1	0.50	0.50	∞
Response Time	0	R	√3	1	1	0.00	0.00	∞
Integration Time	1.4	R	√3	1	1	0.81	0.81	∞
RF ambient Conditions - Noise	3.0	R	√3	1	1	1.73	1.73	∞
RF ambient Conditions - Reflections	3.0	R	√3	1	1	1.73	1.73	∞
Probe positioner Mechanical Tolerance	1.4	R	√3	1	1	0.81	0.81	∞
Probe positioning with respect to Phantom Shell	1.4	R	√3	1	1	0.81	0.81	∞
Extrapolation, interpolation and integration Algorithms for Max. SAR Evaluation	2.3	R	√3	1	1	1.33	1.33	∞
Test sample Related								
Test sample positioning	2.6	N	1	1	1	2.60	2.60	11
Device Holder Uncertainty	3.0	N	1	1	1	3.00	3.00	7
Output power Variation - SAR drift measurement	5.0	R	√3	1	1	2.89	2.89	∞
SAR scaling	2.0	R	√3	1	1	1.15	1.15	∞
Phantom and Tissue Parameters								
Phantom Shell Uncertainty - Shape,Thickness and Permittivity	4	R	√3	1	1	2.31	2.31	∞
Uncertainty in SAR correction for deviation in permittivity and conductivity	2.0	N	1	1	0.84	2.00	1.68	∞
Liquid conductivity measurement	4.0	N	1	0.78	0.71	3.12	2.84	5
Liquid permittivity measurement	5.0	N	1	0.23	0.26	1.15	1.30	5
Liquid Conductivity - Temperature Uncertainty	2.5	R	√3	0.78	0.71	1.13	1.02	∞
Liquid permittivity - Temperature Uncertainty	2.5	R	√3	0.23	0.26	0.33	0.38	∞
Combined Standard Uncertainty		RSS				10.47	10.34	
Expanded Uncertainty (95% Confidence interval)		k				20.95	20.69	

* This uncertainty represents an expanded uncertainty expressed at approximately the 95% confidence level using a coverage factor of k=2.

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3.4.2 Measurement uncertainly evaluation for system check

Uncertainty Component	Tol (+- %)	Prob. Dist.	Div.	Ci (1g)	Ci (10 g)	1g Ui (+- %)	10 g Ui (+-%)	Vi veff
Measurement System								
Probe calibration	5.8	N	1	1	1	5.80	5.80	∞
Axial Isotropy	3.5	R	√3	1	1	2.02	2.02	∞
Hemispherical Isotropy	5.9	R	√3	0	0	0.00	0.00	∞
Boundary effect	1	R	√3	1	1	0.58	0.58	∞
Linearity	4.7	R	√3	1	1	2.71	2.71	∞
System detection limits	1	R	√3	1	1	0.58	0.58	∞
Modulation response	0	N	√3	0	0	0.00	0.00	∞
Readout Electronics	0.5	N	1	1	1	0.50	0.50	∞
Response Time	0	R	√3	0	0	0.00	0.00	∞
Integration Time	1.4	R	√3	0	0	0.00	0.00	∞
RF ambient Conditions - Noise	3	R	√3	1	1	1.73	1.73	∞
RF ambient Conditions - Reflections	3	R	√3	1	1	1.73	1.73	∞
Probe positioner Mechanical Tolerance	1.4	R	√3	1	1	0.81	0.81	∞
Probe positioning with respect to Phantom Shell	1.4	R	√3	1	1	0.81	0.81	∞
Extrapolation, interpolation and integration Algorithms for Max. SAR Evaluation	2.3	R	√3	1	1	1.33	1.33	∞
Dipole								
Deviation of experimental source from numerical source	5	N	1	1	1	5.00	5.00	∞
Input Power and SAR driftmeasurement	0.5	R	√3	1	1	0.29	0.29	∞
Dipole Axis to Liquid Dist.	2.0	R	√3	1	1	1.15	1.15	∞
Phantom and Tissue Parameters								
Phantom Shell Uncertainty - Shape,Thickness and Permittivity	4	R	√3	1	1	2.31	2.31	∞
Uncertainty in SAR correction for deviation in permittivity and conductivity	2.0	N	1	1	0.84	2.00	1.68	∞
Liquid conductivity measurement	4	N	1	0.78	0.71	3.12	2.84	5
Liquid permittivity measurement	5.0	N	1	0.23	0.26	1.15	1.30	5
Liquid Conductivity - Temperature Uncertainty	2.5	R	√3	0.78	0.71	1.13	1.02	∞
Liquid permittivity - Temperature Uncertainty	2.5	R	√3	0.23	0.26	0.33	0.38	∞
Combined Standard Uncertainty		RSS				10.16	10.03	
Expanded Uncertainty (95% Confidence interval)		k				20.32	20.06	

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4. Measurement System

4.1 Specific Absorption Rate (SAR) Definition

SAR is related to the rate at which energy is absorbed per unit mass in an object exposed to a radio field. The SAR distribution in a biological body is complicated and is usually carried out by experimental techniques or numerical modeling. The standard recommends limits for two tiers of groups, occupational/controlled and general population/uncontrolled, based on a person's awareness and ability to exercise control over his or her exposure. In general, occupational/controlled exposure limits are higher than the limits for general population/uncontrolled.

The SAR definition is the time derivative (rate) of the incremental energy (dW) absorbed by (dissipated in) an incremental mass (dm) contained in a volume element (dv) of a given density (ρ). The equation description is as below:

$$\mathbf{SAR} = \frac{d}{dt}\left(\frac{dW}{dm}\right) = \frac{d}{dt}\left(\frac{dW}{\rho dv}\right)$$

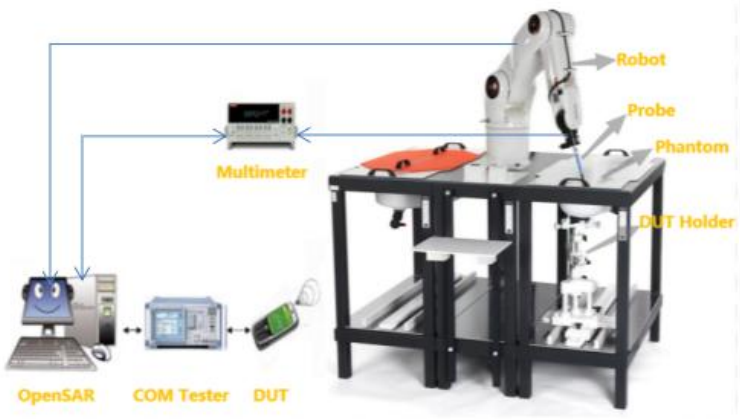
SAR is expressed in units of Watts per kilogram (W/kg) SAR measurement can be related to the electrical field in the tissue by

$$\mathbf{SAR} = \frac{\sigma E^2}{\rho}$$

Where: σ is the conductivity of the tissue,
ρ is the mass density of the tissue and E is the RMS electrical field strength.

4.2 MVG SAR System

4.2.1 SAR system diagram



4.2.2 Robot

A standard high precision 6-axis robot (Denso) with teaches pendant with Scanning System
· It must be able to scan all the volume of the phantom to evaluate the tridimensional distribution of SAR.
· Must be able to set the probe orthogonal of the surface of the phantom (±30°).
· Detects stresses on the probe and stop itself if necessary to keep the integrity of the probe.

4.2.3 E-Field Probe

For the measurements, the Specific Dosimetric SSE2 E-Field Probe with following specifications is used:

- Dynamic range: 0.01-100 W/kg
- Tip diameter: 2mm for SSE2
- Distance between probe tip and sensor centre: 1mm for SSE2
- Distance between sensor centre and the inner phantom surface: 2mm for f>=4GHz.
- Probe linearity: <0.25dB.
- Axial Isotropy: <0.25dB.
- Spherical Isotropy: <0.50dB.
- Calibration range: 150 to 6000 MHz for head & body simulating liquid
- Angle between probe axis (evaluation axis) and surface normal line: less than 20°.

4.2.4 Phantoms

SAM Phantom

For the measurements the Specific Anthropomorphic Mannequin (SAM) defined by the IEEE SCC-34/SC2 group is used. The probe scanning of the E-Field is done in the 2 halves of the normalized head. The normalized shape of the phantom corresponds to the dimensions of 90% of an adult head size. It enables the dosimetric evaluation of left and right-hand phone usage and includes an additional flat phantom part for the simplified body performance check.The phantom set-up includes a cover, which prevents the evaporation of the liquid.

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The thickness of the phantom amounts to 2 mm±0.2 mm. The materials for the phantom do not affect the radiation of the device under test (DUT) : εr' <5
The head is filled with tissue simulating liquid. The hand do not have to be modeled.

SAM Phantom

TWIN SAM phantom			
	Mechanical	Electrical	
Overall thickness	2±0.2 mm(except ear area)	Relative permittivity	3.4
Dimensions	1000 mm(L) x 500 mm(W) x 200 mm(H)	Loss tangent	0.02
Maximum volume	27 L		
Material	Fiberglass based		

ELLIPTICAL Phantom

The phantom is for Body performance check filled with tissue-equivalent liquid to a depth of at least 150 mm, whose shell material is resistant to damage or reaction with tissue-equivalent liquid chemicals.

The shape of the phantom is an ellipse with length 600mm±5mm and width 400mm±5mm.
The phantom shell is made of low-loss and low-permittivity material, having loss tangent tanδ ≤ 0.05 and relative permittivity:
εr' ≤ 5 for f ≤ 3 GHz
3 ≤εr' ≤ 5 for f > 3 GHz
The thickness of the bottom-wall of the flat phantom is 2.0 mm with a tolerance of ± 0.2 mm.

ELLI Phantom

Technical & mechanical characteristics	
Shell thickness	2 mm ± 0.2 mm
Filling volume	25 L
Dimensions	600 mm x 400 mm x 200mm
Permittivity	4.4
Loss tangent	0.017

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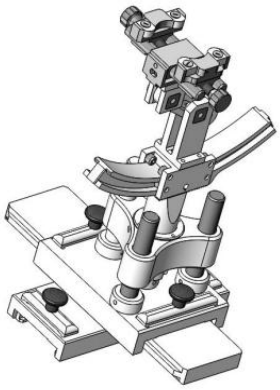
4.2.5 Device Holder



System Material	Permittivity	Loss tangent
Delrin	3.7	0.005

(The positioning system allows obtaining cheek and tilting position with a very good accuracy. In compliance with CENELEC, the tilt angle uncertainty is lower than 1°.)

System Material	Permittivity	Loss tangent
PMMA	2.9	0.028

4.2.6 Simulating Liquid

For SAR measurement of the field distribution inside the phantom, the phantom must be filled with homogeneous tissue simulating liquid to a depth of at least 15 cm. For head SAR testing, the liquid height from the ear reference point (ERP) of the phantom to the liquid top surface is larger than 15 cm. For body SAR testing, the liquid height from the center of the flat phantom to the liquid top surface is larger than 15 cm. The nominal dielectric values of the tissue simulating liquids in the phantom and the tolerance of 5%.

Head Liquid Depth	Body Liquid Depth
	

The following table gives the recipes for tissue simulating liquid and the theoretical Conductivity/Permittivity.

Head (Reference IEEE1528)								
Frequency (MHz)	Water (%)	Sugar (%)	Cellulose (%)	Salt (%)	Preventol (%)	DGBE (%)	Conductivity σ (S/m)	Permittivity ε
750	41.1	57.0	0.2	1.4	0.2	0	0.89	41.9
835	40.3	57.9	0.2	1.4	0.2	0	0.90	41.5
900	40.3	57.9	0.2	1.4	0.2	0	0.97	41.5
1800, 1900, 2000	55.2	0	0	0.3	0	44.5	1.4	40.0
2450	55.0	0	0	0.1	0	44.9	1.80	39.2
2600	54.9	0	0	0.1	0	45.0	1.96	39.0
Frequency (MHz)	Water (%)	Hexyl Carbitol (%)			Triton X-100 (%)		Conductivity σ (S/m)	Permittivity ε
5200	62.52	17.24			17.24		4.66	36.0
5800	62.52	17.24			17.24		5.27	35.3
Body (From instrument manufacturer)								
Frequency (MHz)	Water (%)	Sugar (%)	Cellulose (%)	Salt (%)	Preventol (%)	DGBE (%)	Conductivity σ (S/m)	Permittivity ε
750	51.7	47.2	0	0.9	0.1	0	0.96	55.5
835	50.8	48.2	0	0.9	0.1	0	0.97	55.2
900	50.8	48.2	0	0.9	0.1	0	1.05	55.0
1800, 1900, 2000	70.2	0	0	0.4	0	29.4	1.52	53.3
2450	68.6	0	0	0.1	0	31.3	1.95	52.7
2600	68.2	0	0	0.1	0	31.7	2.16	52.5
Frequency(MHz)	Water	DGBE (%)			Salt (%)		Conductivity σ (S/m)	Permittivity ε
5200	78.60	21.40			/		5.30	49.00
5800	78.50	21.40			0.1		6.00	48.20

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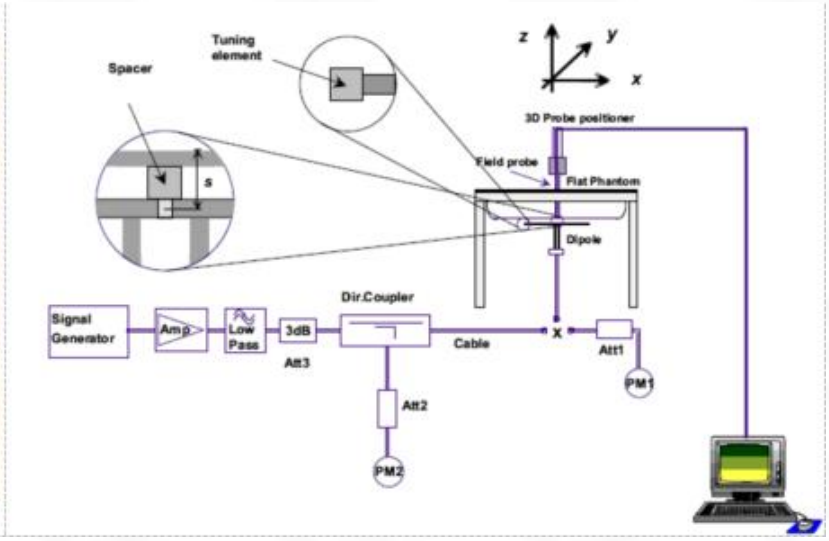
5. System Verification

5.1 Purpose of System Check

The system performance check verifies that the system operates within its specifications. System and operator errors can be detected and corrected. It is recommended that the system performance check be performed prior to any usage of the system in order to guarantee reproducible results. The system performance check uses normal SAR measurements in a simplified setup with a well characterized source. The setup was selected to give a high sensitivity to all parameters that might fail or vary over time. The system check does not intend to replace the calibration of the components, but indicates situations where the system uncertainty is exceeded due to drift or failure.

5.2 System Check Setup



6. TEST POSITION CONFIGURATIONS

According to KDB 648474 D04 Handset, handsets are tested for SAR compliance in head, body-worn accessory and other use configurations described in the following subsections.

6.1 Head Exposure Conditions

Head exposure is limited to next to the ear voice mode operations. Head SAR compliance is tested according to the test positions defined in IEC IEEE 62209-1528:2020 using the SAM phantom illustrated as below.

6.1.1 Definition of the cheek position

The cheek position is established using steps a) to j) as follows.

(a) Configure the DUT for voice operation, if necessary. For example, for a DUT with a flip.a)swivel, or slide cover piece, open the cover if this is consistent with voice operation. If theDUT can also be used with the cover closed, both configurations shall be tested.

(b) Define two imaginary lines on the DUT, the vertical centreline and the horizontal linerelative to the DUT in vertical orientation as shown in Figure 15.

(c) The vertical centreline passes through two points on the front side of the DUT: themidpoint of the width w of the DUT at the level of the acoustic output (Point A inFigure 15), and the midpoint of the width wp at the bottom of the DUT (Point B). Thehorizontal line is perpendicular to the vertical centerline, and passes through the centre ofthe acoustic output (Fiqure 15). The two lines intersect at Point A. Note that for manyDUTs, Point A coincides with the centre of the acoustic output. However, the acousticoutput could be located elsewhere on the horizontal line. Also note that the verticacentreline is not necessarily parallel to the front face of the DUT, especially for clamshellDUTs,DUTs with flip cover pieces, and other irregularly shaped DUTs.

(d) Position the DUT close to the surface of the phantom such that Point A is on the (virtualextension of the line passing through points RE (right-ear ear reference point) and LEleft-ear ear reference point) on the phantom (see Figure 16a) and Figure 16b)). The planedetermined by the vertical centreline and the horizontal line of the DUT shall be parallel tothe sagittal plane of the phantom.

(e) Translate the DUT towards the phantom along the line passing through RE and LE untilethe DUT touches the ear (see Figure 16c)).

(f) Rotate the DUT around the (virtual) LE-RE Line until the DUT vertical centreline is in thef)reference plane(see Figure 16d)).

(g) Rotate the DUT around its vertical centreline until the plane established by the DUTgvertical centreline and horizontal line is parallel to the N-F line (see Annex G), and thentranslate the DUT towards the phantom along the LE-RE line until DUT Point A touchesthe ear at the ERP (ear reference point) (see Figure 16e))

(h) While keeping Point A on the line passing through RE and LE and maintaining the DUT incontact with the pinna, rotate the DUT about the N-F line until any point on the DUT is incontact with a phantom point below the pinna (cheek) (see Figure 16f)). The physicaangles of rotation shall be documented.

(i) While keeping DUT Point A in contact with the ERP rotate the DUT around a lineperpendicular to the plane established by the DUT vertical centreline and horizontal lineand passing through DUT Point A, until the DUT vertical centreline is in the referenceplane(see Figure 16g)).

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(j) Verify that the cheek position is correct as follows:
1) the N-F line is in the plane established by the DUT vertical centreline and horizontalline;
2) DUT Point A touches the pinna at the ERP
3) the DUT vertical centreline is in the reference plane.

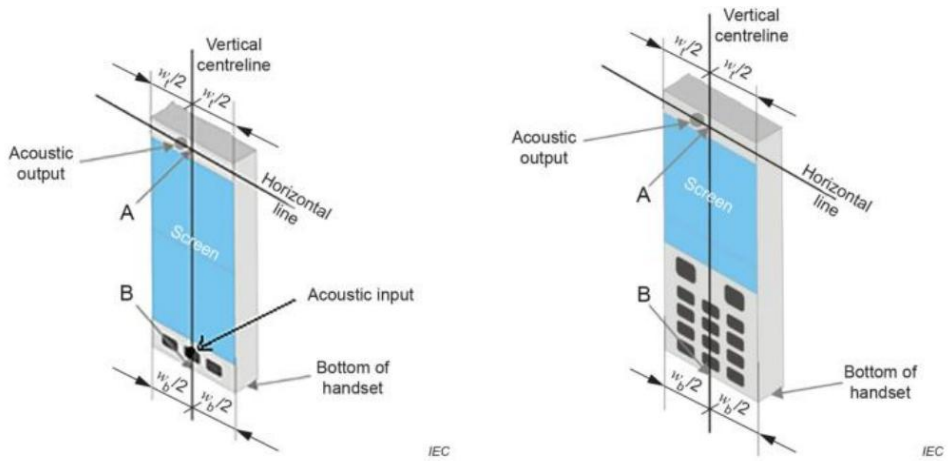
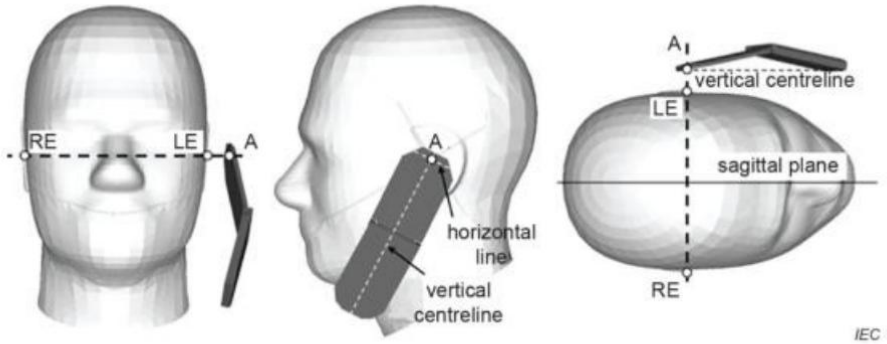


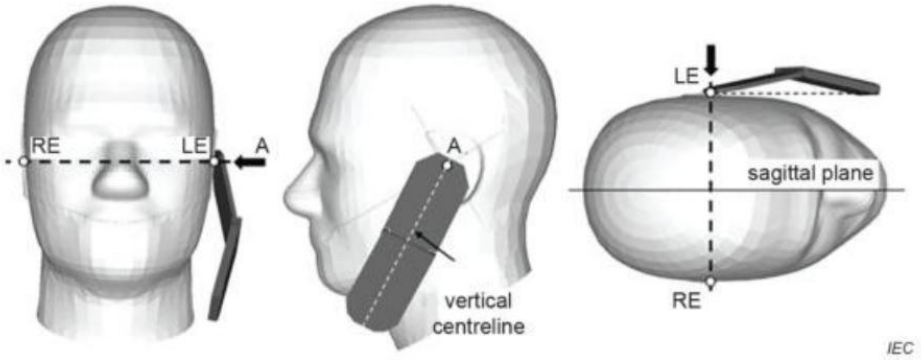
Figure 15 - Vertical and horizontal reference lines and referencepoints A and B on two example device types: a full touch-screensmart phone (left) and a DUT with a keypad (right)

NOTE The reference points for the right-ear ear reference point (RE), left-ear ear reference point (LE), and mouth (M), which establish the reference plane for DUT positioning, are indicated. This device position shall be maintained for the sagittal phantom test set-up shown in Figure G.4.

a) Phone position 1 – cheek position

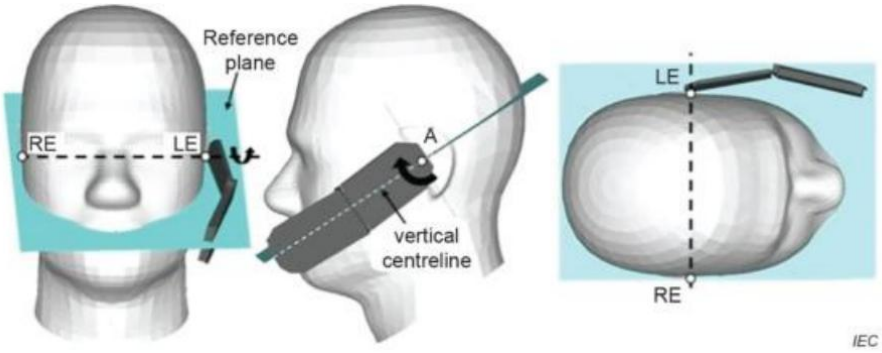


b) One possible DUT position against the head after applying 7.2.4.2.2 c)



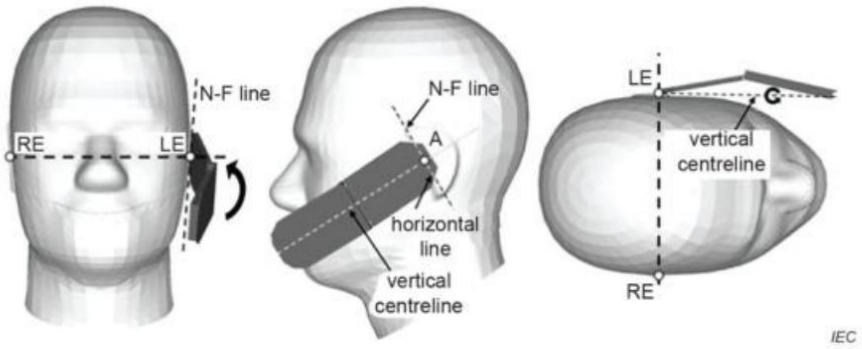
NOTE The black arrows show the direction of translation of the DUT for 7.2.4.2.2 d).

c) DUT position after applying 7.2.4.2.2 d)



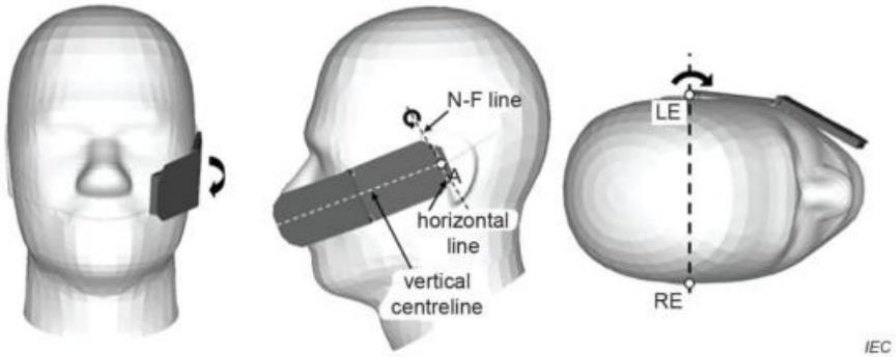
NOTE The curved black arrows show the direction of rotation of the DUT for 7.2.4.2.2 e).

d) DUT position after applying 7.2.4.2.2 e)



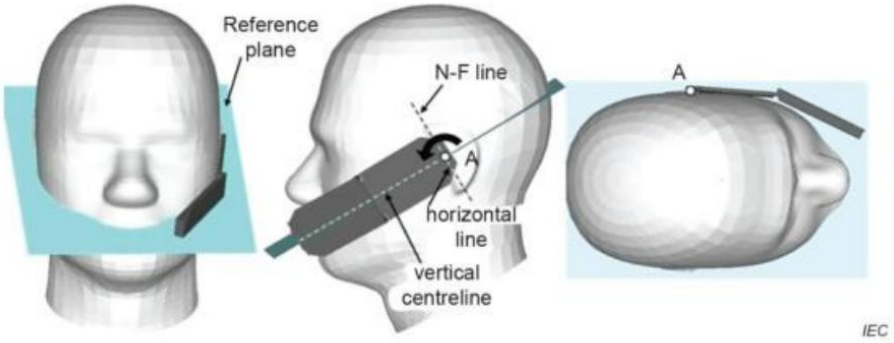
NOTE The curved black arrows show the direction of rotation of the DUT for 7.2.4.2.2 f).

e) DUT position after applying 7.2.4.2.2 f)



NOTE The curved black arrows show the direction of rotation of the DUT for 7.2.4.2.2 g)

f) DUT position after applying 7.2.4.2.2 g)



NOTE The curved black arrows show the direction of rotation of the DUT for 7.2.4.2.2 h).

g) DUT position after applying 7.2.4.2.2 h)

Figure 16 – Cheek position of the DUT on the left side of SAM where the device position shall be maintained for the phantom test set-up

6.1.2 Definition of the tilt position

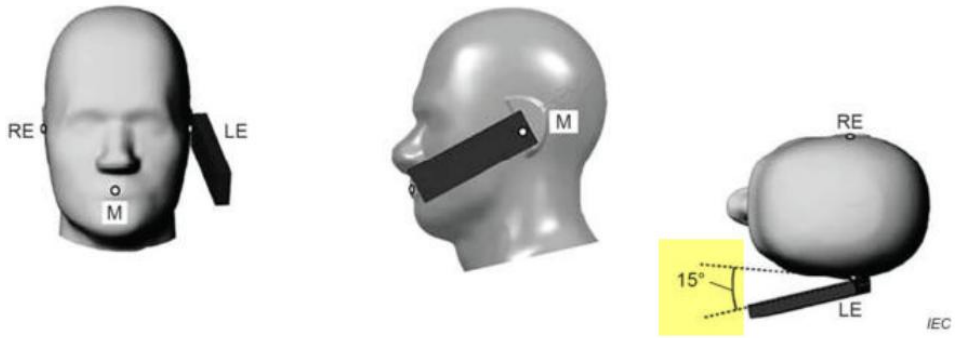
The tilt position is established using steps a) through d) as follows.

(a) Repeat steps a) through j) of 7.2.4.2.2 to place the DUT in the cheek positiona)(see Figure16).

(b) While maintaining the orientation of the DUT, move the DUT away from the pinna alongb)the line passing through RE and LE far enough to allow a rotation of the DUT away fromthe cheek by 15°.

(c) Rotate the DUT around the horizontal line by 15°(see Figure 17).

(d) While maintaining the orientation of the DUT. move the DUT towards the phantom on aline passing through RE and LE until any part of the DUT touches the ear. The tilt positionis obtained when the contact is on the pinna. If the contact is at any location other thanthe pinna, e.g. an extended antenna in contact with the back of the head phantom, theangle of the DUT shall be reduced. in this case, the tilt position is obtained if any part ofthe DUT is in contact with the pinna and a second point on the DUT is in contact with thephantom,e.g.the antenna in contact with the back of the head.



Key

M Mouth reference point

LE Left-ear ear reference point

RE Right-ear ear reference point

This device position shall be maintained for the phantom test set-up.

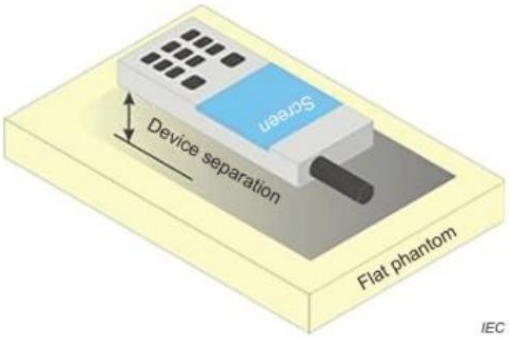
Figure 17 – Tilt position of the DUT on the left side of SAM

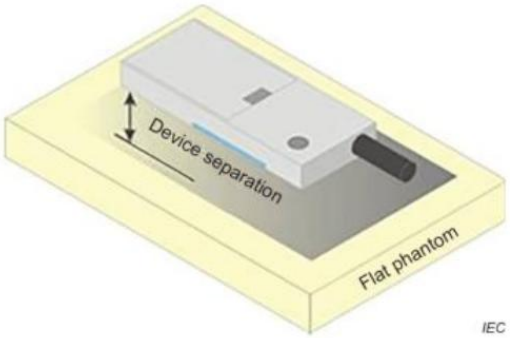
6.2 Body-worn Position Conditions

Body-worn accessory exposure is typically related to voice mode operations when handsets are carried in body-worn accessories. The body-worn accessory procedures in KDB 447498 are used to test for body-worn accessory SAR compliance, without a headset connected to it. This enables the test results for such configuration to be compatible with that required for hotspot mode when the body-worn accessory test separation distance is greater than or equal to that required for hotspot mode. When the reported SAR for a body-worn accessory.

Body-worn accessories that do not contain metallic or conductive components may be tested according to worst-case exposure configurations, typically according to the smallest test separation distance required for the group of body-worn accessories with similar operating and exposure characteristics. All body-worn accessories containing metallic components are tested in conjunction with the host device.

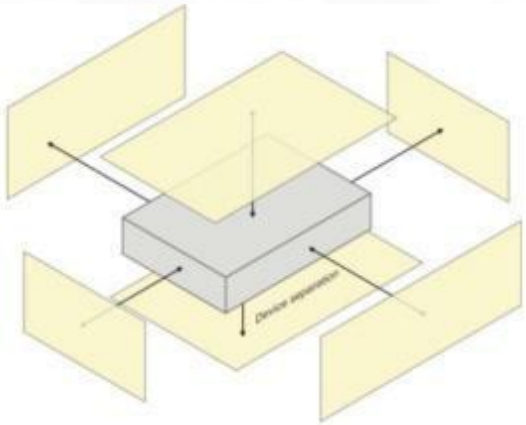
Body-worn accessory SAR compliance is based on a single minimum test separation distance for all wireless and operating modes applicable to each body-worn accessory used by the host, and according to the relevant voice and/or data mode transmissions and operations. If a body-worn accessory supports voice only operations in its normal and expected use conditions, testing of data mode for body-worn compliance is not required. A conservative minimum test separation distance for supporting off-the-shelf body-worn accessories that may be acquired by users of consumer handsets is used to test for body-worn accessory SAR compliance. This distance is determined by the handset manufacturer, according to the requirements of Supplement C 01-01. Devices that are designed to operate on the body of users using lanyards and straps, or without requiring additional body-worn accessories, will be tested using a conservative minimum test separation distance <= 5 mm to support compliance.





6.3 Hotspot Mode Exposure Position Conditions

For handsets that support hotspot mode operations, with wireless router capabilities and various web browsing functions, the relevant hand and body exposure conditions are tested according to the hotspot SAR procedures in KDB 941225. A test separation distance of 10 mm is required between the phantom and all surfaces and edges with a transmitting antenna located within 25 mm from that surface or edge. When the form factor of a handset is smaller than 9 cm x 5 cm, a test separation distance of 5 mm (instead of 10 mm) is required for testing hotspot mode. When the separation distance required for body-worn accessory testing is larger than or equal to that tested for hotspot mode, in the same wireless mode and for the same surface of the phone, the hotspot mode SAR data may be used to support body-worn accessory SAR compliance for that particular configuration (surface).



6.4 Product Specific 10g Exposure Consideration

According with FCC KDB 648474 D04, for smart phones with a display diagonal dimension > 15.0 cm or an overall diagonal dimension > 16.0 cm that provide similar mobile web access and multimedia support found in mini-tablets or UMPC mini-tablets that support voice calls next to the ear, unless it is confirmed otherwise through KDB inquiries, the following phablet procedures should be applied to evaluate SAR compliance for each applicable wireless modes and frequency band. Devices marketed as phablets, regardless of form factors and operating characteristics must be tested as a phablet to determine SAR compliance;

The UMPC mini-tablet procedures must also be applied to test the SAR of all surfaces and edges with an antenna located at ≤ 25 mm from that surface or edge, in direct contact with a flat phantom, for 10-g extremity SAR according to the body-equivalent tissue dielectric parameters in KDB 865664 to address interactive hand use exposure conditions. The UMPC mini-tablet 1-g SAR at 5 mm is not required. When hotspot mode applies, 10-g extremity SAR is required only for the surfaces and edges with hotspot mode 1-g reported SAR > 1.2 W/kg.

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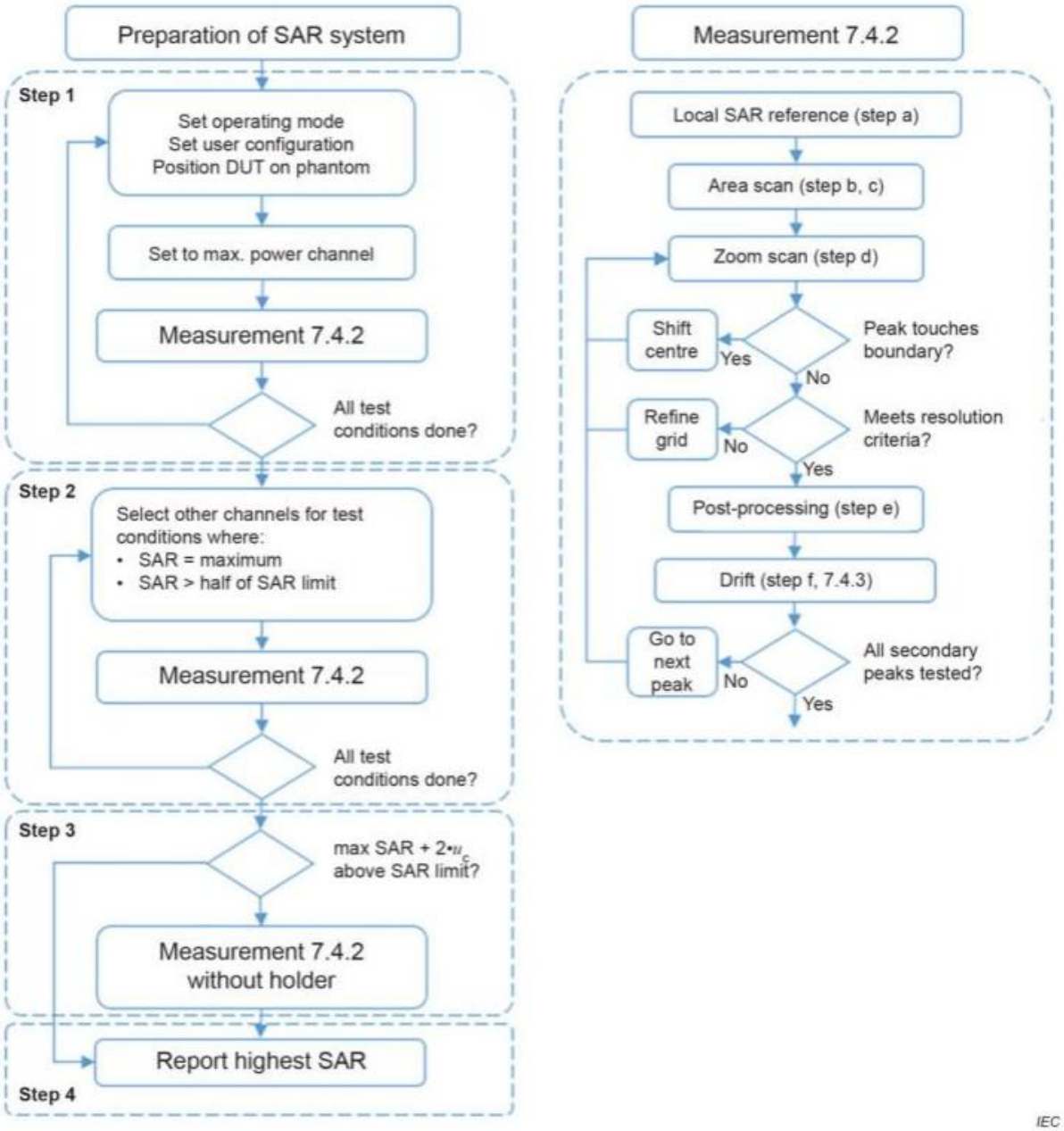
7. Measurement Procedure

7.1 Measurement Process Diagram

Body SAR



7.2 SAR Scan General Requirement

Probe boundary effect error compensation is required for measurements with the probe tip closer than half a probe tip diameter to the phantom surface. Both the probe tip diameter and sensor offset distance must satisfy measurement protocols; to ensure probe boundary effect errors are minimized and the higher fields closest to the phantom surface can be correctly measured and extrapolated to the phantom surface for computing 1 g SAR. Tolerances of the post-processing algorithms must be verified by the test laboratory for the scan resolutions used in the SAR measurements, according to the reference distribution functions specified in IEC/IEEE 62209-1528: 2020.

Table 3 – Area scan parameters

Parameter	DUT transmit frequency being tested	
	$f \leq 3$ GHz	3 GHz < $f \leq 10$ GHz
Maximum distance between the measured points (geometric centre of the sensors) and the inner phantom surface (z_{M1} in Figure 20 in mm)	5 ± 1	$\delta \ln(2)/2 \pm 0,5$ [a]
Maximum spacing between adjacent measured points in mm (see O.8.3.1)[b]	20, or half of the corresponding zoom scan length, whichever is smaller	$60/f$, or half of the corresponding zoom scan length, whichever is smaller
Maximum angle between the probe axis and the phantom surface normal (α in Figure 20)[c]	5° (flat phantom only) 30° (other phantoms)	5° (flat phantom only) 20° (other phantoms)
Tolerance in the probe angle	1°	1°

[a] δ is the penetration depth for a plane-wave incident normally on a planar half-space.

[b] See Clause O.8 on how Δx and Δy may be selected for individual area scan requirements.

[c] The probe angle relative to the phantom surface normal is restricted due to the degradation in the measurement accuracy in fields with steep spatial gradients. The measurement accuracy decreases with increasing probe angle and increasing frequency. This is the reason for the tighter probe angle restriction at frequencies above 3 GHz.

Table 4 – Zoom scan parameters

Parameter	DUT transmit frequency being tested	
	$f \leq 3$ GHz	3 GHz < $f \leq 10$ GHz
Maximum distance between the closest measured points and the phantom surface (z_{M1} in Figure 20 and Table 3, in mm)	5	$\delta \ln(2)/2$ [a]
Maximum angle between the probe axis and the phantom surface normal (α in Figure 20)	5° (flat phantom only) 30° (other phantoms)	5° (flat phantom only) 20° (other phantoms)
Maximum spacing between measured points in the x- and y-directions (Δx and Δy, in mm)	8	$24/f$ [b]
For uniform grids: Maximum spacing between measured points in the direction normal to the phantom shell (Δz_1 in Figure 20, in mm)	5	$10/(f - 1)$
For graded grids: Maximum spacing between the two closest measured points in the direction normal to the phantom shell (Δz_1 in Figure 20, in mm)	4	$12/f$
For graded grids: Maximum incremental increase in the spacing between measured points in the direction normal to the phantom shell ($R_z = \Delta z_2/\Delta z_1$ in Figure 20)	1,5	1,5
Minimum edge length of the zoom scan volume in the x- and y-directions (L_z in O.8.3.2, in mm)	30	22
Minimum edge length of the zoom scan volume in the direction normal to the phantom shell (L_h in O.8.3.2 in mm)	30	22
Tolerance in the probe angle	1°	1°

[a] δ is the penetration depth for a plane-wave incident normally on a planar half-space.

[b] This is the maximum spacing allowed, which might not work for all circumstances.

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7.3 Measurement Procedure

The following steps are used for each test position

a. Establish a call with the maximum output power with a base station simulator. The connection between the mobile and the base station simulator is established via air interface

b. Measurement of the local E-field value at a fixed location. This value serves as a reference value for calculating a possible power drift.

c. Measurement of the SAR distribution with a grid of 8 to 16mm * 8 to16 mm and a constant distance to the inner surface of the phantom. Since the sensors cannot directly measure at the inner phantom surface, the values between the sensors and the inner phantom surface are extrapolated. With these values the area of the maximum SAR is calculated by an interpolation scheme.

d. Around this point, a cube of 30 * 30 * 30 mm or 32 * 32 *32 mm is assessed by measuring 5 or 8 * 5 or 8*4 or 5 mm. With these data, the peak spatial-average SAR value can be calculated.

7.4 Area & Zoom Scan Procedure

First Area Scan is used to locate the approximate location(s) of the local peak SAR value(s). The measurement grid within an Area Scan is defined by the grid extent, grid step size and grid offset. Next, in order to determine the EM field distribution in a three-dimensional spatial extension, Zoom Scan is required. The Zoom Scan is performed around the highest E-field value to determine the averaged SAR-distribution over 10 g. Area scan and zoom scan resolution setting follows KDB 865664 D01v01r04 quoted below.

When the 1 g SAR of the highest peak is within 2 dB of the SAR limit, additional zoom scans are required for other peaks within 2 dB of the highest peak that have not been included in any zoom scan to ensure there is no increase in SAR.

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8. Conducted RF Output Power

8.1 GSM

Mode: GSM850		Maximum Tune-up(dBm)	Burst Average Power (dBm)			Division Factors	Frame-Average Power (dBm)		
			CH128	CH190	CH251		CH128	CH190	CH251
			824.2MHz	836.6MHz	848.8MHz		824.2MHz	836.6MHz	848.8MHz
GSM		**32.50**	31.83	32.12	**32.27**	-9.03	22.80	23.09	**23.24**
GPRS (GMSK)	1Tx slot	32.50	31.82	32.04	32.14	-9.03	22.79	23.01	23.11
	2Tx slots	**30.00**	**29.83**	29.73	29.67	-6.02	**23.81**	23.71	23.65
	3Tx slots	28.00	27.55	27.45	27.46	-4.26	23.29	23.19	23.20
	4Tx slots	25.50	25.42	25.29	25.22	-3.01	22.41	22.28	22.21
EGPRS (8PSK)	1Tx slot	26.50	26.15	25.99	25.94	-9.03	17.12	16.96	16.91
	2Tx slots	25.00	24.71	24.64	24.60	-6.02	18.69	18.62	18.58
	3Tx slots	22.50	22.07	22.09	22.10	-4.26	17.81	17.83	17.84
	4Tx slots	19.50	19.48	19.47	19.46	-3.01	16.47	16.46	16.45
Mode: GSM1900		**Maximum Tune-up(dBm)**	**Burst Average Power (dBm)**			**Division Factors**	**Frame-Average Power (dBm)**		
			CH512	CH661	CH810		CH512	CH661	CH810
			1850.2MHz	1880.0MHz	1909.8MHz		1850.2MHz	1880.0MHz	1909.8MHz
GSM		**29.00**	**28.58**	28.54	28.19	-9.03	**19.55**	19.51	19.16
GPRS (GMSK)	1Tx slot	29.00	28.56	28.45	28.06	-9.03	19.53	19.42	19.03
	2Tx slots	26.50	26.41	25.91	25.09	-6.02	20.39	19.89	19.07
	3Tx slots	**25.00**	**24.84**	24.35	23.57	-4.26	**20.58**	20.09	19.31
	4Tx slots	23.00	22.60	22.06	21.30	-3.01	19.59	19.05	18.29
EGPRS (8PSK)	1Tx slot	26.50	26.28	26.16	25.70	-9.03	17.25	17.13	16.67
	2Tx slots	25.00	24.53	24.59	24.18	-6.02	18.51	18.57	18.16
	3Tx slots	22.50	22.34	22.44	22.00	-4.26	18.08	18.18	17.74
	4Tx slots	20.50	20.16	20.32	20.01	-3.01	17.15	17.31	17.00

Note:
1) Division Factors
To average the power, the division factor is as follows:
1Tx-slot = 1 transmit time slot out of 8 time slots=> conducted power divided by (8/1) => -9.03dB
2Tx-slots = 2 transmit time slots out of 8 time slots=> conducted power divided by (8/2) => -6.02dB
3Tx-slots = 3 transmit time slots out of 8 time slots=> conducted power divided by (8/3) => -4.26dB
4Tx-slots = 4 transmit time slots out of 8 time slots=> conducted power divided by (8/4) => -3.01dB

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8.2 WCDMA

Mode		Maximum Tune-up(dBm)	WCDMA Band II		
			Conducted Power (dBm)		
			CH9262	CH9400	CH9538
			1852.4	1880.0	1907.6
RMC 12.2K		**22.50**	**22.09**	22.02	21.61
HSDPA	Subtest-1	22.50	22.21	22.31	21.72
	Subtest-2	22.50	21.95	22.04	21.47
	Subtest-3	22.00	21.75	21.86	21.30
	Subtest-4	22.00	21.77	21.89	21.34
HSUPA	Subtest-1	20.50	20.09	20.06	19.27
	Subtest-2	20.50	20.18	20.28	19.90
	Subtest-3	21.00	20.63	20.25	19.86
	Subtest-4	21.00	20.65	20.55	20.12
	Subtest-5	22.50	22.24	22.31	21.73
Mode		Maximum Tune-up(dBm)	WCDMA Band IV		
			Conducted Power (dBm)		
			CH1312	CH1413	CH1513
			1712.4	1732.6	1752.6
RMC 12.2K		**22.50**	**22.31**	22.08	22.24
HSDPA	Subtest-1	23.00	22.07	22.71	22.08
	Subtest-2	23.00	22.15	22.76	22.20
	Subtest-3	23.00	22.14	22.69	22.17
	Subtest-4	23.00	22.16	22.70	22.14
HSUPA	Subtest-1	23.00	21.97	22.78	22.17
	Subtest-2	22.50	21.84	22.19	21.74
	Subtest-3	23.00	22.18	22.68	22.20
	Subtest-4	23.00	22.26	22.74	22.29
	Subtest-5	23.00	22.18	22.75	22.12
Mode		Maximum Tune-up(dBm)	WCDMA Band V		
			Conducted Power (dBm)		
			CH4132	CH4182	CH4233
			826.4	836.4	846.6
RMC 12.2K		**24.00**	**23.70**	23.67	23.58
HSDPA	Subtest-1	23.00	22.01	22.53	22.01
	Subtest-2	22.50	21.86	22.31	21.76
	Subtest-3	22.00	21.45	21.90	21.26
	Subtest-4	22.00	21.49	21.91	21.27
HSUPA	Subtest-1	21.00	20.04	20.55	20.12
	Subtest-2	21.00	20.83	20.93	20.49
	Subtest-3	21.00	20.35	20.89	20.44
	Subtest-4	21.00	20.01	20.70	20.27
	Subtest-5	23.00	22.34	22.82	22.26
Per KDB 941225 D01, when the maximum output power and tune-up tolerance specified for production units in a secondary mode is ≤1/2dB higher than the primary mode (RMC12.2kbps) or when the highest reported SAR of the primary mode is scaled by the ratio of specified maximum output power and tune-up tolerance of secondary to primary mode and the adjusted SAR is ≤ 1.2 W/kg, SAR measurement is not required for the secondary mode.					

8.3 LTE

Band 2

LTE-FDD Band 2				Maximum Tune-up(dBm)	Conducted Power(dBm)		
Bandwidth	Modulation	RB allocation	RB offset		18607	18900	19193
					1850.7MHz	1880.0MHz	1909.3MHz
1.4MHz	QPSK	1	0	23.00	22.08	22.43	22.55
			2	23.00	22.07	22.29	22.58
			5	23.00	22.05	22.21	22.55
		3	0	23.00	22.21	22.34	22.59
			1	23.00	22.19	22.32	22.62
			3	23.00	22.25	22.31	22.60
		6	0	22.00	21.31	21.46	21.69
	16QAM	1	0	22.50	21.83	22.41	22.26
			2	22.50	21.77	22.24	22.35
			5	23.00	21.78	22.28	22.77
		3	0	21.50	20.72	21.15	21.26
			1	21.50	20.72	21.37	21.19
			3	21.50	20.97	21.32	21.22
		6	0	21.00	20.31	20.59	20.65
Bandwidth	Modulation	RB allocation	RB offset	Maximum Tune-up(dBm)	18615	18900	19185
					1851.5MHz	1880.0MHz	1908.5MHz
3MHz	QPSK	1	0	23.00	22.15	22.27	22.54
			8	23.00	22.14	22.42	22.59
			14	23.00	22.18	22.26	22.69
		8	0	22.00	21.16	21.34	21.68
			4	22.00	21.29	21.36	21.62
			7	22.00	21.18	21.40	21.69
		15	0	22.00	21.29	21.35	21.53
	16QAM	1	0	22.00	21.06	21.28	21.72
			8	22.00	21.02	21.22	21.61
			14	22.00	21.02	21.09	21.61
		8	0	21.50	20.42	20.57	21.01
			4	21.50	20.42	20.59	21.02
			7	21.00	20.51	20.56	20.85
		15	0	21.00	20.17	20.54	20.74

Bandwidth	Modulation	RB allocation	RB offset	Maximum Tune-up(dBm)	18625	18900	19175
					1852.5MHz	1880.0MHz	1907.5MHz
5MHz	QPSK	1	0	23.00	22.32	22.41	22.57
			12	23.00	22.40	22.45	22.68
			24	23.00	22.38	22.50	22.70
		12	0	22.00	21.35	21.50	21.68
			6	22.00	21.37	21.51	21.71
			13	22.00	21.36	21.28	21.73
		25	0	22.00	21.41	21.38	21.75
	16QAM	1	0	21.50	21.07	20.98	21.08
			12	21.50	21.10	20.63	21.15
			24	22.00	21.50	20.72	21.02
		12	0	21.00	20.44	20.51	20.62
			6	21.00	20.48	20.54	20.63
			13	21.00	20.45	20.43	20.71
		25	0	21.00	20.46	20.56	20.86

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LTE-FDD Band 2				Maximum Tune-up(dBm)	Conducted Power(dBm)		
Bandwidth	Modulation	RB allocation	RB offset		18650	18900	19150
					1855.0MHz	1880.0MHz	1905.0MHz
10MHz	QPSK	1	0	22.50	22.23	22.46	22.35
			24	23.00	22.38	22.39	22.55
			49	23.00	22.43	22.29	22.68
		25	0	22.00	21.46	21.60	21.63
			12	22.00	21.45	21.56	21.47
			25	22.00	21.39	21.42	21.75
		50	0	22.00	21.37	21.37	21.56
	16QAM	1	0	21.50	20.68	21.24	21.35
			24	22.00	21.25	21.15	21.65
			49	22.00	20.83	21.02	21.74
		25	0	21.00	20.56	20.57	20.56
			12	21.00	20.51	20.58	20.50
			25	21.00	20.57	20.48	20.71
		50	0	21.00	20.50	20.53	20.68
Bandwidth	Modulation	RB allocation	RB offset	Maximum Tune-up(dBm)	18675	18900	19125
					1857.5MHz	1880.0MHz	1902.5MHz
15MHz	QPSK	1	0	23.00	22.45	22.61	22.29
			38	23.00	22.5	22.41	22.47
			74	23.00	22.07	22.34	22.66
		38	0	21.50	21.07	21.20	21.44
			18	22.00	21.27	21.06	21.57
			37	22.00	21.30	21.34	21.74
		75	0	22.00	21.40	21.44	21.61
	16QAM	1	0	21.50	21.43	21.20	21.44
			38	22.00	21.40	21.06	21.70
			74	21.50	21.31	20.92	21.47
		38	0	21.50	21.08	21.28	21.46
			18	22.00	21.24	21.50	21.63
			37	22.00	21.30	20.89	21.74
		75	0	21.00	20.57	20.57	20.57
Bandwidth	Modulation	RB allocation	RB offset	Maximum Tune-up(dBm)	18700	18900	19100
					1860.0MHz	1880.0MHz	1900.0MHz
20MHz	QPSK	1	0	23.00	22.58	22.70	22.56
			49	23.00	22.56	22.55	22.68
			99	**23.00**	22.56	22.49	**22.72**
		50	0	22.00	21.45	21.69	21.37
			25	22.00	21.45	21.68	21.48
			50	22.00	21.62	21.44	**21.63**
		100	0	22.00	21.58	21.48	21.59
	16QAM	1	0	22.00	21.81	21.8	21.23
			49	22.00	21.97	21.64	21.17
			99	22.50	22.10	21.57	21.60
		50	0	21.00	20.53	20.72	20.62
			25	21.00	20.54	20.72	20.63
			50	21.00	20.60	20.51	20.78
		100	0	21.00	20.63	20.64	20.60

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Band 4

LTE-FDD Band 4				Maximum Tune-up(dBm)	Conducted Power(dBm)		
Bandwidth	Modulation	RB allocation	RB offset		19957	20175	20393
					1710.7MHz	1732.5MHz	1754.3MHz
1.4MHz	QPSK	1	0	23.50	23.09	23.01	22.59
			2	23.50	23.06	23.00	22.59
			5	23.50	23.10	22.99	22.56
		3	0	23.50	23.13	22.95	22.57
			1	23.50	23.23	22.90	22.59
			3	23.50	23.21	22.88	22.55
		6	0	22.50	22.22	21.90	21.53
	16QAM	1	0	23.00	22.80	22.24	22.49
			2	23.00	22.80	22.28	22.47
			5	23.50	23.09	22.79	22.87
		3	0	22.00	21.73	21.84	21.04
			1	22.00	21.69	21.84	21.04
			3	22.00	21.69	21.92	21.00
		6	0	21.50	21.22	21.09	20.67
Bandwidth	Modulation	RB allocation	RB offset	Maximum Tune-up(dBm)	19965	20175	20385
					1711.5MHz	1732.5MHz	1753.5MHz
3MHz	QPSK	1	0	23.50	23.22	23.01	22.60
			8	23.50	23.21	22.92	22.51
			14	23.50	23.07	22.93	22.5
		8	0	22.50	22.21	21.88	21.61
			4	22.50	22.22	21.86	21.63
			7	22.50	22.10	21.87	21.55
		15	0	22.50	22.21	21.92	21.69
	16QAM	1	0	22.00	21.54	21.77	21.70
			8	22.50	21.53	22.47	21.46
			14	22.00	21.39	21.82	21.46
		8	0	21.50	21.39	20.98	20.77
			4	21.50	21.39	20.99	20.87
			7	21.50	21.33	21.02	20.79
		15	0	21.50	21.10	20.96	20.58
Bandwidth	Modulation	RB allocation	RB offset	Maximum Tune-up(dBm)	19975	20175	20375
					1712.5MHz	1732.5MHz	1752.5MHz
5MHz	QPSK	1	0	23.50	23.27	22.81	22.75
			12	23.50	23.10	22.84	22.76
			24	23.50	23.14	22.81	22.66
		12	0	22.50	22.20	21.96	21.71
			6	22.50	22.22	21.98	21.73
			13	22.50	22.14	22.01	21.57
		25	0	22.50	22.14	21.99	21.65
	16QAM	1	0	22.50	22.43	21.52	21.16
			2	22.00	21.92	21.61	21.11
			24	22.00	21.81	21.54	21.17
		12	0	21.50	21.30	20.87	20.68
			6	21.50	21.31	20.89	20.69
			13	21.50	21.15	21.12	20.66
		25	0	21.50	21.25	21.00	20.78

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LTE-FDD Band 4				Maximum Tune-up(dBm)	Conducted Power(dBm)		
Bandwidth	Modulation	RB allocation	RB offset		20000	20175	20350
					1715.0MHz	1732.5MHz	1750.0MHz
10MHz	QPSK	1	0	23.50	23.19	22.94	22.88
			24	23.50	23.01	22.96	22.72
			49	23.00	22.88	23.00	22.63
		25	0	22.50	22.18	21.95	21.78
			12	22.50	22.17	21.97	21.84
			25	22.00	21.87	21.91	21.63
		50	0	22.50	22.01	21.96	21.72
	16QAM	1	0	22.50	21.52	22.45	21.86
			24	23.00	21.36	22.51	21.78
			49	23.00	21.28	22.59	21.26
		25	0	21.50	21.24	21.06	20.78
			12	21.50	21.26	21.09	20.79
			25	21.50	21.08	20.89	20.69
		50	0	21.50	21.16	21.02	20.71
Bandwidth	Modulation	RB allocation	RB offset	Maximum Tune-up(dBm)	20025	20175	20325
					1717.5MHz	1732.5MHz	1747.5MHz
15MHz	QPSK	1	0	23.00	22.80	22.89	22.86
			38	23.50	22.50	23.01	22.81
			74	23.50	22.38	23.04	22.60
		38	0	22.50	22.25	21.77	21.59
			18	22.00	21.92	21.82	21.47
			37	23.00	21.80	22.52	21.31
		75	0	22.00	22.00	21.95	21.78
	16QAM	1	0	22.50	21.95	22.45	21.93
			38	22.00	21.68	21.87	21.82
			74	22.00	21.55	21.84	21.32
		38	0	22.50	22.30	21.76	21.62
			18	22.00	21.96	21.78	21.52
			37	23.00	21.79	22.58	21.29
		75	0	21.50	21.08	21.03	20.87
Bandwidth	Modulation	RB allocation	RB offset	Maximum Tune-up(dBm)	20050	20175	20300
					1720.0MHz	1732.5MHz	1745.0MHz
20MHz	QPSK	1	0	**23.50**	**23.22**	22.86	23.11
			49	23.00	22.97	22.93	22.84
			99	23.00	22.94	22.96	22.56
		50	0	22.00	21.99	21.90	21.80
			25	22.50	**22.03**	21.92	21.80
			50	22.00	21.88	21.98	21.67
		100	0	22.50	22.03	21.88	21.87
	16QAM	1	0	23.00	22.69	21.51	21.46
			49	23.00	22.55	21.62	20.88
			99	22.50	22.35	21.59	20.67
		50	0	21.50	21.06	21.12	20.94
			25	21.50	21.09	21.13	20.96
			50	21.50	20.93	21.18	20.73
		100	0	21.50	21.14	20.97	20.82

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Band 5

LTE-FDD Band 5				Maximum Tune-up(dBm)	Conducted Power(dBm)		
Bandwidth	Modulation	RB allocation	RB offset		20407	20525	20643
					824.7MHz	836.5MHz	848.3MHz
1.4MHz	QPSK	1	0	24.00	23.79	23.87	23.79
			2	24.00	23.73	23.89	23.76
			5	24.00	23.83	23.84	23.63
		3	0	24.50	23.85	24.03	23.73
			1	24.50	23.85	24.02	23.82
			3	24.00	23.85	23.98	23.85
		6	0	23.00	22.76	22.93	22.75
	16QAM	1	0	24.00	23.04	23.83	22.90
			2	24.00	22.96	23.83	22.89
			5	24.00	22.98	23.56	22.53
		3	0	23.00	22.44	22.48	22.73
			1	23.00	22.44	22.51	22.75
			3	23.00	22.78	22.39	22.71
		6	0	22.50	21.88	22.28	21.66
Bandwidth	Modulation	RB allocation	RB offset	Maximum Tune-up(dBm)	20415	20525	20635
					825.5MHz	836.5MHz	847.5MHz
3MHz	QPSK	1	0	24.50	23.82	24.01	23.74
			8	24.00	23.85	23.97	23.76
			14	24.00	23.88	23.93	23.64
		8	0	23.00	22.63	22.81	22.62
			4	23.00	22.64	22.85	22.70
			7	23.00	22.74	22.99	22.69
		15	0	23.00	22.87	22.89	22.65
	16QAM	1	0	23.50	22.56	23.49	22.38
			8	24.00	22.61	23.55	22.36
			14	23.50	22.64	23.48	22.29
		8	0	22.50	21.99	22.06	21.77
			4	22.50	21.92	22.08	21.82
			7	22.50	22.01	22.10	21.90
		15	0	22.50	21.67	22.07	21.59

LTE-FDD Band 5				Maximum Tune-up(dBm)	Conducted Power(dBm)		
Bandwidth	Modulation	RB allocation	RB offset		20425	20525	20625
					826.5MHz	836.5MHz	846.5MHz
5MHz	QPSK	1	0	24.50	24.24	24.12	24.19
			12	24.50	24.14	24.26	24.36
			24	24.50	24.20	24.35	24.27
		12	0	23.50	23.04	23.12	23.18
			6	23.50	23.05	23.16	23.12
			13	23.50	23.17	23.30	23.07
		25	0	23.50	23.13	23.33	23.10
	16QAM	1	0	23.00	22.78	22.80	22.50
			12	23.50	23.21	23.07	22.45
			24	23.50	22.83	23.13	22.45
		12	0	22.50	22.11	22.19	22.23
			6	22.50	22.06	22.20	22.22
			13	22.50	22.14	22.34	22.11
		25	0	22.50	22.22	22.32	22.26

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Bandwidth	Modulation	RB allocation	RB offset	Maximum Tune-up(dBm)	20450	20525	20600
					829.0MHz	836.5MHz	844.0MHz
10MHz	QPSK	1	0	24.50	24.01	24.19	24.20
			24	**24.50**	24.02	**24.33**	24.13
			49	24.50	24.17	24.25	24.06
		25	0	23.50	23.11	23.12	23.29
			12	23.50	23.03	23.07	23.23
			25	23.50	23.19	**23.17**	23.11
		50	0	23.50	23.04	23.17	23.19
	16QAM	1	0	23.50	22.33	22.99	23.24
			24	23.50	22.89	23.11	23.20
			49	23.50	22.96	22.99	23.10
		25	0	22.50	22.23	22.41	22.20
			12	22.50	22.25	22.29	22.18
			25	22.50	22.23	22.31	22.15
		50	0	22.50	22.18	22.30	22.29

Band 7

LTE-FDD Band 7				Maximum Tune-up(dBm)	Conducted Power(dBm)		
Bandwidth	Modulation	RB allocation	RB offset		20775	21100	21425
					2502.5MHz	2535MHz	2567.5MHz
5MHz	QPSK	1	0	23.50	22.52	22.59	23.12
			12	23.50	22.55	22.51	23.08
			24	23.50	22.58	22.69	23.02
		12	0	22.00	21.26	21.51	21.91
			6	22.00	21.26	21.47	21.90
			13	22.00	21.33	21.56	21.79
		25	0	22.00	21.33	21.38	21.87
	16QAM	1	0	21.50	20.65	20.96	21.25
			12	21.50	20.77	20.71	21.31
			24	21.50	20.84	20.73	21.15
		12	0	21.00	20.30	20.51	20.93
			6	21.00	20.40	20.52	20.99
			13	21.00	20.40	20.45	20.83
		25	0	21.50	20.59	20.59	21.06
Bandwidth	Modulation	RB allocation	RB offset	Maximum Tune-up(dBm)	20800	21100	21400
					2505MHz	2535MHz	2565MHz
10MHz	QPSK	1	0	23.50	22.30	22.65	23.03
			24	23.00	22.52	22.45	22.89
			49	23.00	22.61	22.47	22.83
		25	0	22.50	21.41	21.59	22.04
			12	22.50	21.47	21.45	22.04
			25	22.00	21.59	21.52	21.88
		50	0	22.00	21.39	21.45	21.98
	16QAM	1	0	22.00	20.62	21.74	21.72
			24	22.50	20.81	21.60	22.13
			49	22.50	21.48	21.20	22.07
		25	0	21.00	20.56	20.54	21.00
			12	21.50	20.58	20.56	21.11
			25	21.00	20.65	20.58	20.96
		50	0	21.50	20.54	20.53	21.05

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LTE-FDD Band 7				Maximum Tune-up(dBm)	Conducted Power(dBm)		
Bandwidth	Modulation	RB allocation	RB offset		20825	21100	21375
					2507.5MHz	2535MHz	2562.5MHz
15MHz	QPSK	1	0	23.00	21.95	22.54	22.84
			38	23.00	22.16	22.45	22.97
			74	23.00	22.49	22.42	22.81
		38	0	22.00	21.27	21.43	21.76
			18	22.50	22.01	21.20	22.22
			37	22.50	21.60	21.30	22.16
		75	0	22.50	21.61	21.56	22.04
	16QAM	1	0	22.00	21.27	21.31	21.68
			38	22.00	21.65	21.66	21.75
			74	22.00	21.68	21.26	21.60
		38	0	22.50	21.74	21.44	22.19
			18	22.50	21.56	21.27	22.17
			37	22.50	21.58	21.35	22.01
		75	0	21.50	20.70	20.66	21.07
Bandwidth	Modulation	RB allocation	RB offset	Maximum Tune-up(dBm)	20850	21100	21350
					2510MHz	2535MHz	2560MHz
20MHz	QPSK	1	0	23.50	22.62	23.07	22.97
			49	**23.50**	22.90	22.90	**23.11**
			99	23.00	23.00	22.67	22.97
		50	0	22.00	21.66	21.59	21.92
			25	22.00	21.51	21.58	21.91
			50	22.50	21.79	21.66	**22.01**
		100	0	22.50	21.66	21.88	22.08
	16QAM	1	0	22.50	22.10	21.46	21.62
			49	22.50	22.48	20.97	21.54
			99	23.00	22.53	21.49	21.41
		50	0	21.50	20.56	20.89	21.28
			25	21.50	20.68	20.84	21.27
			50	21.50	20.81	20.80	21.19
		100	0	21.50	21.04	20.63	21.17

Band 19

LTE-FDD Band 19				Maximum Tune-up(dBm)	Conducted Power(dBm)		
Bandwidth	Modulation	RB allocation	RB offset		24025	24075	24125
					832.5MHz	837.5MHz	842.5MHz
5MHz	QPSK	1	0	24.50	24.44	24.31	24.21
			12	24.50	24.36	24.28	24.06
			24	24.50	24.30	24.16	24.03
		12	0	23.50	23.22	23.13	22.98
			6	23.50	23.21	23.10	22.95
			13	23.50	23.12	23.00	22.93
		25	0	23.50	23.17	23.09	22.92
	16QAM	1	0	23.50	23.19	23.04	23.15
			12	23.50	23.17	23.03	22.98
			24	23.50	23.08	22.95	23.04
		12	0	22.50	22.22	22.08	22.02
			6	22.50	22.17	22.09	22.00
			13	22.50	22.09	21.98	21.95
		25	0	22.50	22.18	22.07	21.92

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Bandwidth	Modulation	RB allocation	RB offset	Maximum Tune-up(dBm)	24050	24075	24100
					835.0MHz	837.5MHz	840.0MHz
10MHz	QPSK	1	0	24.50	24.27	24.33	24.16
			24	24.50	24.24	24.20	24.01
			49	24.50	24.19	24.03	23.92
		25	0	23.50	23.24	23.19	23.04
			12	23.50	23.24	23.17	23.03
			25	23.50	23.04	23.06	22.99
		50	0	23.50	23.17	23.10	23.03
	16QAM	1	0	23.50	23.26	23.28	23.04
			24	23.50	23.19	23.20	22.99
			49	23.50	23.11	22.98	22.76
		25	0	22.50	22.20	22.12	22.07
			12	22.50	22.19	22.17	22.06
			25	22.50	22.04	22.04	22.02
		50	0	22.50	22.16	22.08	22.02

Bandwidth	Modulation	RB allocation	RB offset	Maximum Tune-up(dBm)	24075
					837.5MHz
15MHz	QPSK	1	0	**24.50**	**24.24**
			38	24.50	24.21
			74	24.00	23.93
		38	0	23.50	**23.21**
			18	23.50	23.21
			37	23.00	22.93
		75	0	23.50	23.07
	16QAM	1	0	23.50	23.20
			38	23.50	23.24
			74	23.00	22.92
		38	0	23.50	23.21
			18	23.50	23.21
			37	23.00	22.93
		75	0	22.50	22.03

Band 25

LTE-FDD Band 25				Maximum Tune-up(dBm)	Conducted Power(dBm)		
Bandwidth	Modulation	RB allocation	RB offset		26047	26365	26683
					1850.7MHz	1882.5MHz	1914.3MHz
1.4MHz	QPSK	1	0	23.50	23.28	23.06	23.19
			2	23.50	23.21	23.02	23.11
			5	23.50	23.24	23.06	23.10
		3	0	23.50	23.32	23.09	23.24
			1	23.50	23.31	23.09	23.23
			3	23.50	23.28	23.07	23.18
		6	0	22.50	22.22	22.12	22.24
	16QAM	1	0	22.50	22.12	22.00	22.11
			2	22.50	22.15	22.04	22.09
			5	22.50	22.14	21.94	22.03
		3	0	22.50	22.10	21.99	22.06
			1	22.50	22.09	21.90	22.06
			3	22.50	22.07	21.88	22.03
		6	0	21.50	21.01	21.11	21.25

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Bandwidth	Modulation	RB allocation	RB offset	Maximum Tune-up(dBm)	26055	26365	26675
					1851.5MHz	1882.5MHz	1913.5MHz
3MHz	QPSK	1	0	23.50	23.31	23.25	23.4
			7	23.50	23.32	23.24	23.36
			14	23.50	23.29	23.24	23.31
		8	0	22.50	22.19	22.14	22.30
			4	22.50	22.22	22.13	22.31
			7	22.50	22.21	22.10	22.24
		15	0	22.50	22.22	22.12	22.29
	16QAM	1	0	22.50	22.26	22.26	22.39
			7	22.50	22.31	22.24	22.38
			14	22.50	22.25	22.22	22.33
		8	0	21.50	21.25	21.14	21.30
			4	21.50	21.25	21.16	21.32
			7	21.50	21.22	21.12	21.28
		15	0	21.50	21.25	21.12	21.29
Bandwidth	Modulation	RB allocation	RB offset	Maximum Tune-up(dBm)	26065	26365	26665
					1852.5MHz	1882.5MHz	1912.5MHz
5MHz	QPSK	1	0	24.00	23.39	23.39	23.61
			13	24.00	23.37	23.35	23.52
			24	23.50	23.42	23.31	23.45
		12	0	22.50	22.28	22.18	22.33
			6	22.50	22.30	22.20	22.31
			13	22.50	22.23	22.18	22.29
		25	0	22.50	22.29	22.20	22.33
	16QAM	1	0	22.50	22.22	22.18	22.37
			13	22.50	22.21	22.09	22.29
			24	22.50	22.19	22.11	22.22
		12	0	21.50	21.33	21.19	21.29
			6	21.50	21.31	21.14	21.28
			13	21.50	21.17	21.11	21.24
		25	0	21.50	21.28	21.20	21.35

LTE-FDD Band 25				Maximum Tune-up(dBm)	Conducted Power(dBm)		
Bandwidth	Modulation	RB allocation	RB offset		26090	26365	26640
					1855.0MHz	1882.5MHz	1910.0MHz
10MHz	QPSK	1	0	23.50	23.34	23.19	23.46
			25	23.50	23.37	23.23	23.44
			49	23.50	23.30	23.17	23.24
		25	0	22.50	22.26	22.13	22.39
			13	22.50	22.32	22.12	22.40
			25	22.50	22.26	22.13	22.37
		50	0	22.50	22.30	22.18	22.42
	16QAM	1	0	22.50	22.27	22.19	22.42
			25	22.50	22.33	22.20	22.40
			49	22.50	22.29	22.15	22.25
		25	0	21.50	21.25	21.07	21.38
			13	21.50	21.25	21.07	21.38
			25	21.50	21.28	21.15	21.36
		50	0	21.50	21.28	21.11	21.35

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Bandwidth	Modulation	RB allocation	RB offset	Maximum Tune-up(dBm)	26115	26365	26615
					1857.5MHz	1882.5MHz	1907.5MHz
15MHz	QPSK	1	0	23.50	23.24	23.16	23.42
			38	23.50	23.35	23.20	23.46
			74	23.50	23.17	23.12	23.21
		38	0	22.50	22.22	22.17	22.43
			18	22.50	22.31	22.21	22.40
			37	22.50	22.19	22.09	22.21
		75	0	22.50	22.29	22.13	22.35
	16QAM	1	0	22.50	22.20	22.16	22.41
			38	22.50	22.30	22.21	22.42
			74	22.50	22.19	22.15	22.20
		38	0	22.50	22.19	22.18	22.44
			18	22.50	22.30	22.21	22.42
			37	22.50	22.18	22.14	22.21
		75	0	21.50	21.22	21.07	21.32
Bandwidth	Modulation	RB allocation	RB offset	Maximum Tune-up(dBm)	26140	26365	26590
					1860.0MHz	1882.5MHz	1905.0MHz
20MHz	QPSK	1	0	23.50	23.23	23.14	23.32
			49	**24.00**	23.41	23.29	**23.50**
			99	23.50	23.11	23.24	23.23
		50	0	22.50	22.26	22.16	22.49
			25	22.50	22.32	22.17	**22.49**
			50	22.50	22.28	22.20	22.36
		100	0	22.50	22.25	22.16	22.45
	16QAM	1	0	22.50	22.06	21.98	22.15
			49	22.50	22.22	22.07	22.30
			99	22.50	21.95	22.03	22.03
		50	0	21.50	21.24	21.14	21.46
			25	21.50	21.24	21.18	21.44
			50	21.50	21.23	21.13	21.32
		100	0	21.50	21.20	21.16	21.43

Band 26 Part90

LTE-FDD Band 26 Part90				Maximum Tune-up(dBm)	Conducted Power(dBm)		
Bandwidth	Modulation	RB allocation	RB offset		26697	26740	26783
					814.7MHz	819.0MHz	823.3MHz
1.4MHz	QPSK	1	0	24.00	23.67	23.72	23.85
			2	24.00	23.67	23.74	23.85
			5	24.00	23.67	23.74	23.87
		3	0	24.00	23.74	23.77	23.91
			1	24.00	23.72	23.77	23.88
			3	24.00	23.74	23.81	23.89
		6	0	23.00	22.70	22.88	22.95
	16QAM	1	0	23.00	22.54	22.50	22.69
			2	23.00	22.63	22.55	22.69
			5	23.00	22.60	22.54	22.66
		3	0	23.00	22.52	22.65	22.80
			1	23.00	22.53	22.68	22.82
			3	23.00	22.51	22.68	22.78
		6	0	22.00	21.51	21.80	21.89

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Bandwidth	Modulation	RB allocation	RB offset	Maximum Tune-up(dBm)	26705	26740	26775
					815.5MHz	819.0MHz	822.5MHz
3MHz	QPSK	1	0	24.00	23.68	23.72	23.95
			8	24.00	23.73	23.74	23.99
			14	24.50	23.75	23.76	24.08
		8	0	23.00	22.71	22.81	22.86
			4	23.00	22.71	22.80	22.88
			7	23.00	22.70	22.82	22.88
		15	0	23.00	22.69	22.80	22.90
	16QAM	1	0	23.00	22.58	22.50	22.93
			8	23.00	22.57	22.52	22.99
			14	23.00	22.58	22.61	23.00
		8	0	22.00	21.66	21.81	21.91
			4	22.00	21.66	21.80	21.93
			7	22.00	21.68	21.83	21.94
		15	0	22.00	21.61	21.72	21.93

LTE-FDD Band 26 Part90				Maximum Tune-up(dBm)	Conducted Power(dBm)		
Bandwidth	Modulation	RB allocation	RB offset		26715	26740	26765
					816.5MHz	819.0MHz	821.5MHz
5MHz	QPSK	1	0	24.50	23.79	23.89	24.05
			13	24.00	23.87	23.96	23.95
			24	24.50	23.98	24.16	24.13
		12	0	23.00	22.72	22.83	22.88
			6	23.00	22.73	22.83	22.85
			13	23.00	22.74	22.83	22.88
		25	0	23.00	22.76	22.85	22.90
	16QAM	1	0	23.00	22.76	22.73	22.80
			13	23.00	22.86	22.77	22.84
			24	23.00	22.94	22.90	22.89
		12	0	22.00	21.78	21.77	21.86
			6	22.00	21.76	21.78	21.87
			13	22.00	21.75	21.82	21.88
		25	0	22.00	21.75	21.87	21.91

Bandwidth	Modulation	RB allocation	RB offset	Maximum Tune-up(dBm)	26740
					819.0MHz
10MHz	QPSK	1	0	24.00	23.71
			24	24.00	23.88
			49	**24.00**	**23.93**
		25	0	23.00	22.81
			12	23.00	22.81
			25	23.00	**22.89**
		50	0	23.00	22.90
	16QAM	1	0	23.00	22.58
			24	23.00	22.73
			49	23.00	22.79
		25	0	22.00	21.81
			12	22.00	21.79
			25	22.00	21.89
		50	0	22.00	21.84

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Band 26 Part22

LTE-FDD Band 26 Part22				Maximum Tune-up(dBm)	Conducted Power(dBm)		
Bandwidth	Modulation	RB allocation	RB offset		26797	26915	27033
					824.7MHz	836.5MHz	848.3MHz
1.4MHz	QPSK	1	0	24.00	23.98	23.85	23.83
			2	24.00	23.94	23.83	23.80
			5	24.50	24.05	23.85	23.82
		3	0	24.50	24.02	23.89	23.85
			1	24.50	24.04	23.87	23.87
			3	24.00	23.00	23.91	23.87
		6	0	24.00	23.98	22.95	22.84
	16QAM	1	0	23.00	22.86	22.66	22.70
			2	23.00	22.90	22.63	22.79
			5	23.00	22.90	22.60	22.76
		3	0	23.00	22.83	22.82	22.68
			1	23.00	22.85	22.93	22.69
			3	23.00	22.86	22.85	22.67
		6	0	22.00	21.79	21.89	21.66
Bandwidth	Modulation	RB allocation	RB offset	Maximum Tune-up(dBm)	26805	26915	27025
					825.5MHz	836.5MHz	847.5MHz
3MHz	QPSK	1	0	24.50	23.90	24.01	23.81
			7	24.50	23.94	24.07	23.86
			14	24.50	24.07	23.99	23.80
		8	0	23.00	22.95	22.87	22.79
			4	23.00	22.95	22.88	22.81
			7	23.00	22.99	22.82	22.83
		15	0	23.00	22.96	22.83	22.81
	16QAM	1	0	23.50	22.67	23.01	22.70
			7	23.00	22.78	22.95	22.74
			14	23.00	22.69	22.95	22.68
		8	0	22.00	21.95	21.93	21.75
			4	22.00	21.98	21.92	21.74
			7	22.00	22.00	21.88	21.79
		15	0	22.00	21.90	21.87	21.72

LTE-FDD Band 26 Part22				Maximum Tune-up(dBm)	Conducted Power(dBm)		
Bandwidth	Modulation	RB allocation	RB offset		26815	26915	27015
					826.5MHz	836.5MHz	846.5MHz
5MHz	QPSK	1	0	24.50	24.20	24.18	23.87
			13	24.50	24.21	24.10	23.78
			24	24.50	24.21	24.05	23.95
		12	0	23.00	22.99	22.97	22.82
			6	23.00	22.98	22.97	22.79
			13	23.50	23.03	22.82	22.75
		25	0	23.50	23.04	22.91	22.81
	16QAM	1	0	23.00	22.94	22.96	22.82
			13	23.00	22.94	22.95	22.84
			24	23.00	22.96	22.81	22.91
		12	0	22.00	21.97	21.94	21.8
			6	22.00	21.99	21.95	21.84
			13	22.50	22.01	21.83	21.75
		25	0	22.50	22.05	21.91	21.78

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Bandwidth	Modulation	RB allocation	RB offset	Maximum Tune-up(dBm)	26840	26915	26990
					829.0MHz	836.5MHz	844.0MHz
10MHz	QPSK	1	0	24.50	23.97	24.10	23.88
			24	24.50	24.10	24.07	23.73
			49	24.00	23.93	23.86	23.81
		25	0	23.50	23.04	23.03	22.78
			12	23.50	23.01	23.04	22.76
			25	23.50	23.02	22.86	22.75
		50	0	23.50	23.03	22.96	22.78
	16QAM	1	0	23.50	22.85	23.08	22.73
			24	23.00	22.96	22.99	22.63
			49	23.00	22.8	22.84	22.64
		25	0	22.50	22.06	21.99	21.78
			12	22.50	22.05	21.99	21.80
			25	22.50	22.03	21.84	21.74
		50	0	22.50	22.03	21.94	21.79
Bandwidth	Modulation	RB allocation	RB offset	Maximum Tune-up(dBm)	26865	26915	26965
					831.5MHz	836.5MHz	841.5MHz
15MHz	QPSK	1	0	**24.50**	23.89	**24.08**	23.79
			38	24.50	24.04	24.01	23.70
			74	24.00	23.71	23.68	23.61
		38	0	23.50	22.71	**23.09**	22.95
			18	23.00	22.80	22.99	22.86
			37	23.00	22.51	22.69	22.81
		75	0	23.00	22.91	22.90	22.79
	16QAM	1	0	23.50	22.69	23.10	22.96
			38	23.00	22.81	22.99	22.90
			74	23.00	22.49	22.69	22.83
		38	0	23.50	22.70	23.10	22.98
			18	23.00	22.82	23.00	22.88
			37	23.00	22.48	22.69	22.79
		75	0	22.00	21.89	21.88	21.77

Band 38

LTE-TDD Band 38				Maximum Tune-up(dBm)	Conducted Power(dBm)		
Bandwidth	Modulation	RB allocation	RB offset		37775	38000	38225
					2572.5MHz	2595.0MHz	2617.5MHz
5MHz	QPSK	1	0	23.50	23.17	22.77	23.24
			12	23.50	23.30	22.89	23.39
			24	23.50	23.12	22.76	23.19
		12	0	22.50	22.31	21.87	22.39
			6	22.50	22.30	21.98	22.38
			13	22.50	22.23	21.90	22.33
		25	0	22.50	22.32	21.92	22.39
	16QAM	1	0	22.50	22.35	22.16	22.39
			12	23.00	22.48	22.25	22.52
			24	22.50	22.24	22.14	22.33
		12	0	21.50	21.34	20.87	21.45
			6	21.50	21.38	20.87	21.43
			13	21.50	21.32	20.93	21.41
		25	0	21.50	21.28	20.94	21.40

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Bandwidth	Modulation	RB allocation	RB offset	Maximum Tune-up(dBm)	37800	38000	38200
					2575.00MHz	2595.00MHz	2615.00MHz
10MHz	QPSK	1	0	23.50	23.28	22.87	23.23
			24	24.00	23.46	23.08	23.61
			49	23.50	23.07	22.84	23.26
		25	0	22.50	22.31	21.89	22.31
			12	22.50	22.34	21.93	22.37
			25	22.50	22.22	21.90	22.34
		50	0	22.50	22.25	21.91	22.35
	16QAM	1	0	22.50	22.48	22.09	21.86
			24	23.00	22.65	22.28	22.23
			49	22.50	22.29	22.07	21.86
		25	0	21.50	21.40	20.98	21.36
			12	21.50	21.38	21.01	21.35
			25	21.50	21.32	20.96	21.33
		50	0	21.50	21.31	20.98	21.43

LTE-TDD Band 38				Maximum Tune-up(dBm)	Conducted Power(dBm)		
Bandwidth	Modulation	RB allocation	RB offset		37825	38000	38175
					2577.5MHz	2595.0MHz	2612.5MHz
15MHz	QPSK	1	0	23.50	23.16	22.83	23.13
			38	23.50	23.15	22.81	23.37
			74	23.50	22.76	22.82	23.23
		38	0	22.50	22.15	21.85	22.26
			18	22.50	22.13	21.88	22.26
			37	22.50	22.12	21.85	22.23
		75	0	22.50	22.13	21.83	22.22
	16QAM	1	0	22.50	22.36	22.03	21.79
			38	22.50	22.36	22.00	22.09
			74	22.00	22.00	22.00	21.96
		38	0	22.50	22.15	21.84	22.22
			18	22.50	22.14	21.85	22.20
			37	22.50	22.14	21.87	22.27
		75	0	21.50	21.15	20.89	21.25
Bandwidth	Modulation	RB allocation	RB offset	Maximum Tune-up(dBm)	37850	38000	38150
					2580.0MHz	2595.0MHz	2610.0MHz
20MHz	QPSK	1	0	23.50	23.01	22.72	22.62
			49	**23.50**	**23.24**	22.92	23.23
			99	23.00	22.45	22.70	22.90
		50	0	22.50	**22.14**	21.81	22.11
			25	22.50	22.11	21.83	22.15
			50	22.50	21.89	21.77	22.17
		100	0	22.50	22.02	21.81	22.16
	16QAM	1	0	22.50	22.04	21.87	21.19
			49	22.50	22.25	21.98	21.77
			99	22.00	21.54	21.77	21.50
		50	0	21.50	21.18	20.88	21.21
			25	21.50	21.18	20.87	21.22
			50	21.50	20.99	20.86	21.27
		100	0	21.50	21.05	20.86	21.21

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Band 41

LTE-TDD Band 41				Maximum Tune-up(dBm)	Conducted Power(dBm)		
Bandwidth	Modulation	RB allocation	RB offset		40065	40590	41215
					2537.50MHz	2590.00MHz	2652.50MHz
5MHz	QPSK	1	0	23.50	23.06	21.84	21.40
			12	23.00	22.90	21.70	21.42
			24	23.00	22.63	21.64	21.25
		12	0	22.50	22.19	20.91	20.59
			6	22.50	22.17	20.92	20.52
			13	22.00	21.88	20.84	20.62
		25	0	22.00	21.98	20.86	20.57
	16QAM	1	0	22.50	22.27	21.15	20.34
			12	22.50	22.02	21.00	20.66
			24	22.00	21.77	20.64	20.61
		12	0	21.50	21.11	19.77	19.62
			6	21.50	21.20	19.77	19.63
			13	21.50	21.01	19.81	19.64
		25	0	21.00	21.00	19.79	19.35
Bandwidth	Modulation	RB allocation	RB offset	Maximum Tune-up(dBm)	40090	40590	41190
					2540.00MHz	2590.00MHz	2650.00MHz
10MHz	QPSK	1	0	23.50	23.25	22.02	21.59
			24	23.00	22.78	22.02	21.67
			49	22.50	22.43	21.44	21.54
		25	0	22.50	22.06	20.90	20.60
			12	22.50	22.04	20.80	20.62
			25	22.00	21.57	20.77	20.48
		50	0	22.00	21.59	20.82	20.56
	16QAM	1	0	22.50	22.27	20.59	20.66
			24	22.00	21.86	20.69	20.85
			49	22.00	21.56	20.36	20.76
		25	0	21.50	21.14	19.81	19.67
			12	21.50	21.12	19.81	19.45
			25	21.00	20.59	19.82	19.50
		50	0	21.00	20.90	19.74	19.48

LTE-TDD Band 41				Maximum Tune-up(dBm)	Conducted Power(dBm)		
Bandwidth	Modulation	RB allocation	RB offset		40115	40590	41165
					2542.5MHz	2590.00MHz	2647.5MHz
15MHz	QPSK	1	0	23.50	23.30	22.30	21.53
			38	22.50	22.41	21.88	21.32
			74	22.50	22.07	21.79	21.47
		38	0	22.00	21.62	20.93	20.49
			18	22.00	21.59	20.82	20.49
			37	21.50	21.44	20.93	20.49
		75	0	21.50	21.43	20.94	20.49
	16QAM	1	0	22.50	22.39	21.31	20.79
			38	22.00	21.72	20.94	20.62
			74	21.50	21.23	20.83	20.81
		38	0	22.00	21.60	20.93	20.50
			18	22.00	21.60	20.94	20.49
			37	21.50	21.43	20.93	20.49
		75	0	21.00	20.75	19.76	19.44

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Bandwidth	Modulation	RB allocation	RB offset	Maximum Tune-up(dBm)	40140	40590	41140
					2545.00MHz	2590.00MHz	2645.00MHz
20MHz	QPSK	1	0	**23.50**	**23.23**	22.34	22.02
			50	22.50	22.39	22.05	21.47
			99	22.00	21.97	21.45	21.60
		50	0	22.00	**21.90**	21.06	20.66
			25	22.00	21.87	21.06	20.66
			50	21.50	21.24	20.76	20.53
		100	0	21.50	21.46	20.92	20.68
	16QAM	1	0	22.50	22.44	20.70	20.49
			50	21.50	21.33	20.56	20.40
			99	21.50	21.04	20.50	20.37
		50	0	21.50	21.10	20.01	19.59
			25	21.50	21.09	20.01	19.59
			50	21.00	20.51	19.73	19.44
		100	0	21.00	20.57	19.85	19.63

Band 66

LTE-FDD Band 66				Maximum Tune-up(dBm)	Conducted Power(dBm)		
Bandwidth	Modulation	RB allocation	RB offset		131979	132322	132665
					1710.7MHz	1745.0MHz	1779.3MHz
1.4MHz	QPSK	1	0	24.00	23.51	23.21	23.39
			2	23.50	23.48	23.16	23.36
			5	24.00	23.50	23.15	23.35
		3	0	24.00	23.59	23.25	23.47
			1	24.00	23.62	23.25	23.47
			3	24.00	23.58	23.16	23.43
		6	0	23.00	22.55	22.26	22.50
	16QAM	1	0	22.50	22.42	22.14	22.35
			2	22.50	22.43	22.13	22.37
			5	22.50	22.41	22.08	22.30
		3	0	22.50	22.38	22.09	22.33
			1	22.50	22.37	22.08	22.30
			3	22.50	22.37	21.99	22.27
		6	0	21.50	21.38	21.23	21.49
Bandwidth	Modulation	RB allocation	RB offset	Maximum Tune-up(dBm)	131987	132322	132657
					1711.5MHz	1745.0MHz	1778.5MHz
3MHz	QPSK	1	0	24.00	23.63	23.35	23.56
			8	24.00	23.59	23.32	23.59
			14	24.00	23.61	23.28	23.56
		8	0	23.00	22.50	22.28	22.45
			4	23.00	22.51	22.24	22.47
			7	22.50	22.48	22.20	22.46
		15	0	23.00	22.51	22.19	22.48
	16QAM	1	0	23.00	22.65	22.35	22.52
			8	23.00	22.57	22.33	22.54
			14	23.00	22.61	22.29	22.52
		8	0	22.00	21.55	21.30	21.48
			4	22.00	21.54	21.28	21.50
			7	22.00	21.50	21.23	21.53
		15	0	22.00	21.51	21.22	21.50

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Bandwidth	Modulation	RB allocation	RB offset	Maximum Tune-up(dBm)	131997	132322	132647
					1712.5MHz	1745.0MHz	1777.5MHz
5MHz	QPSK	1	0	24.00	23.75	23.53	23.64
			12	24.00	23.75	23.47	23.67
			24	24.00	23.70	23.38	23.70
		12	0	23.00	22.52	22.31	22.50
			6	23.00	22.50	22.32	22.51
			13	22.50	22.46	22.19	22.47
		25	0	23.00	22.52	22.24	22.49
	16QAM	1	0	23.00	22.52	22.30	22.39
			12	23.00	22.52	22.22	22.42
			24	22.50	22.48	22.14	22.44
		12	0	22.00	21.48	21.28	21.52
			6	22.00	21.48	21.26	21.53
			13	21.50	21.47	21.16	21.45
		25	0	22.00	21.51	21.24	21.50
Bandwidth	Modulation	RB allocation	RB offset	Maximum Tune-up(dBm)	132022	132322	132622
					1715.0MHz	1745.0MHz	1775.0MHz
10MHz	QPSK	1	0	23.50	23.42	23.47	23.43
			24	24.00	23.42	23.39	23.56
			49	24.00	23.38	23.20	23.59
		25	0	22.50	22.43	22.33	22.49
			12	23.00	22.43	22.33	22.51
			25	22.50	22.41	22.28	22.44
		50	0	22.50	22.44	22.3	22.49
	16QAM	1	0	22.50	22.26	22.43	22.39
			24	23.00	22.20	22.34	22.55
			49	23.00	22.17	22.19	22.53
		25	0	21.50	21.47	21.31	21.47
			12	21.50	21.45	21.33	21.47
			25	21.50	21.42	21.23	21.44
		50	0	22.00	21.45	21.27	21.50

LTE-FDD Band 66				Maximum Tune-up(dBm)	Conducted Power(dBm)		
Bandwidth	Modulation	RB allocation	RB offset		132047	132322	132597
					1717.5MHz	1745.0MHz	1772.5MHz
15MHz	QPSK	1	0	23.50	23.42	23.49	23.27
			38	24.00	23.44	23.36	23.52
			74	24.00	23.27	23.08	23.50
		38	0	22.50	22.25	22.44	22.21
			18	22.50	22.28	22.36	22.49
			37	22.50	22.08	22.08	22.49
		75	0	22.50	22.41	22.26	22.41
	16QAM	1	0	22.50	22.20	22.42	22.21
			38	22.50	22.27	22.36	22.49
			74	22.50	22.08	22.07	22.49
		38	0	22.50	22.24	22.44	22.20
			18	22.50	22.24	22.37	22.48
			37	22.50	22.06	22.08	22.49
		75	0	21.50	21.37	21.16	21.36

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Bandwidth	Modulation	RB allocation	RB offset	Maximum Tune-up(dBm)	132072	132322	132572
					1720.0MHz	1745.0MHz	1770.0MHz
20MHz	QPSK	1	0	**23.50**	23.39	**23.46**	22.92
			49	23.50	23.45	23.41	23.28
			99	23.50	23.35	23.07	23.28
		50	0	22.50	22.48	**22.35**	22.25
			25	22.50	22.46	22.33	22.23
			50	22.50	22.36	22.17	22.23
		100	0	22.50	22.39	22.23	22.25
	16QAM	1	0	22.50	22.28	22.28	22.21
			49	23.00	22.32	22.23	22.53
			99	23.00	22.22	21.83	22.58
		50	0	21.50	21.47	21.32	21.25
			25	21.50	21.44	21.33	21.24
			50	21.50	21.39	21.15	21.29
		100	0	21.50	21.36	21.21	21.23

8.4 Wi-Fi

2.4G

Band (GHz)	Mode	Channel	Freq. (MHz)	Average Power (dBm)	Maximum Tune-up(dBm)	SAR Test Require.
2.4g Wifi (2.4~2.4835)	802.11b	1	2412	14.02	14.50	No
		6	2437	**16.94**	**17.00**	Yes
		11	2462	16.75	17.00	No
	802.11g	1	2412	9.55	10.00	No
		6	2437	13.45	13.50	No
		11	2462	13.20	13.50	No
	802.11n(HT20)	1	2412	10.38	10.50	No
		6	2437	13.54	14.00	No
		11	2462	13.19	13.50	No
	802.11n(HT40)	3	2422	12.43	12.50	No
		6	2437	12.66	13.00	No
		9	2452	9.67	10.00	No
Note: SAR is not required for the following 2.4 GHz OFDM conditions as the highest reported SAR for DSSS is adjusted by the ratio of OFDM to DSSS specified maximum output power and the adjusted SAR is ≤ 1.2W/kg.						

5G

Band (GHz)	Mode	Channel	Freq. (MHz)	Average Power (dBm)	Maximum Tune-up(dBm)	SAR Test Require.
U-NII-1 (5.150~5.250)	802.11a	36	5180	11.50	12.00	No
		40	5200	11.54	12.00	No
		48	5240	10.96	11.00	No
	802.11n(HT20)	36	5180	12.09	12.50	No
		40	5200	11.93	12.00	No
		48	5240	11.88	12.00	No
	802.11ac(VHT20)	36	5180	12.32	12.50	No
		40	5200	11.46	11.50	No
		48	5240	11.10	11.50	No
	802.11n(HT40)	38	5190	12.58	13.00	No
		46	5230	12.38	12.50	No
	802.11ac(VHT40)	38	5190	12.03	12.50	No
		46	5230	11.44	11.50	No
	802.11ac(VHT80)	42	5210	**13.00**	**13.00**	Yes

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Band (GHz)	Mode	Channel	Freq. (MHz)	Average Power (dBm)	Maximum Tune-up(dBm)	SAR Test Require.
U-NII-2a (5.250~5.350)	802.11a	52	5260	10.51	11.00	No
		60	5300	10.31	10.50	No
		64	5320	9.91	10.00	No
	802.11n(HT20)	52	5260	11.03	11.50	No
		60	5300	11.08	11.50	No
		64	5320	10.40	10.50	No
	802.11ac(VHT20)	52	5260	10.54	11.00	No
		60	5300	10.14	10.50	No
		64	5320	9.52	10.00	No
	802.11n(HT40)	54	5270	11.43	11.50	No
		62	5310	10.86	11.00	No
	802.11ac(VHT40)	54	5270	11.29	11.50	No
		62	5310	10.94	11.00	No
	802.11ac(VHT80)	58	5290	**11.59**	**12.00**	Yes
Band (GHz)	Mode	Channel	Freq. (MHz)	Average Power (dBm)	Maximum Tune-up(dBm)	SAR Test Require.
U-NII-2c (5.470~5.725)	802.11a	100	5500	7.46	7.50	No
		116	5580	7.73	8.00	No
		140	5700	9.28	9.50	No
	802.11n(HT20)	100	5500	8.04	8.50	No
		116	5580	7.96	8.00	No
		140	5700	**9.59**	**10.00**	Yes
	802.11ac(VHT20)	100	5500	7.24	7.50	No
		116	5580	7.06	7.50	No
		140	5700	8.76	9.00	No
	802.11n(HT40)	102	5510	8.17	8.50	No
		110	5550	8.21	8.50	No
		134	5670	8.90	9.00	No
	802.11ac(VHT40)	102	5510	8.18	8.50	No
		110	5550	8.58	9.00	No
		134	5670	8.67	9.00	No
	802.11ac(VHT80)	106	5530	8.45	8.50	No
		138	5690	7.97	8.00	No
Band (GHz)	Mode	Channel	Freq. (MHz)	Average Power (dBm)	Maximum Tune-up(dBm)	SAR Test Require.
U-NII-3 (5.725~5.850)	802.11a	149	5745	9.35	9.50	No
		157	5785	9.92	10.00	No
		165	5825	10.40	10.50	No
	802.11n(HT20)	149	5745	9.87	10.00	No
		157	5785	10.30	10.50	No
		165	5825	10.67	11.00	No
	802.11ac(VHT20)	149	5745	8.79	9.00	No
		157	5785	8.94	9.00	No
		165	5825	9.37	9.50	No
	802.11n(HT40)	151	5755	9.31	9.50	No
		159	5795	9.74	10.00	No
	802.11ac(VHT40)	151	5755	10.46	10.50	No
		159	5795	**11.13**	**11.50**	Yes
	802.11ac(VHT80)	155	5775	9.95	10.00	No

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8.5 Bluetooth

	Mode	Maximum Tune-up(dBm)	Average Conducted Output Power (dBm)		
EDR			0	39	78
			2402MHz	2441MHz	2480MHz
	GFSK	**10.00**	**9.82**	8.43	6.47
	π/4QPSK	9.00	8.70	7.55	5.49
	8DPSK	9.00	8.63	7.29	5.36
BLE	Mode	Maximum Tune-up(dBm)	Average Conducted Output Power (dBm)		
			0	20	39
			2402MHz	2440MHz	2480MHz
	1Mbps	-2.50	-2.96	-3.04	-4.18
	2Mbps	-2.50	-2.89	-3.13	-4.37

Channel	Frequency (GHz)	Max. Tune-up Power (dBm)	Max. Power (mW)	Test distance (mm)	Exclusion thresholds for 1-g SAR(mW)	RF exposure evaluation required
0	2.402	10.00	10.00	0	2.79	Yes
0	2.402	10.00	10.00	10	10.39	No

Note

1. Per KDB 447498 D04 Interim General RF Exposure Guidance v01, the 1-g SAR test exclusion thresholds for 300 MHz to 6 GHz at *test separation distances* ≤ 40 cm are determined by:

$$P_{\text{th}}\,(\text{mW}) = \begin{cases} ERP_{20\,\text{cm}}(d/20\,\text{cm})^{x} & d \le 20\,\text{cm} \\ ERP_{20\,\text{cm}} & 20\,\text{cm} < d \le 40\,\text{cm} \end{cases} \quad \text{(B.2)}$$

where

$$x = -\log_{10}\left(\frac{60}{ERP_{20\,\text{cm}}\sqrt{f}}\right)$$

and f is in GHz, d is the separation distance (cm), and $ERP_{20\text{cm}}$ is per Formula (B.1).

$$P_{\text{th}}\,(\text{mW}) = ERP_{20\,\text{cm}}\,(\text{mW}) = \begin{cases} 2040f & 0.3\,\text{GHz} \le f < 1.5\,\text{GHz} \\ 3060 & 1.5\,\text{GHz} \le f \le 6\,\text{GHz} \end{cases} \quad \text{(B.1)}$$

*When the minimum test separation distance is < 5 mm, a distance of 5 mm is applied to determine estimated SAR.

2. Per KDB 248227 D01 v02r02, choose the highest output power channel to test SAR and determine further SAR exclusion.
3. The output power of all data rate were prescan, just the worst case (the lowest data rate) of all mode were shown in report.

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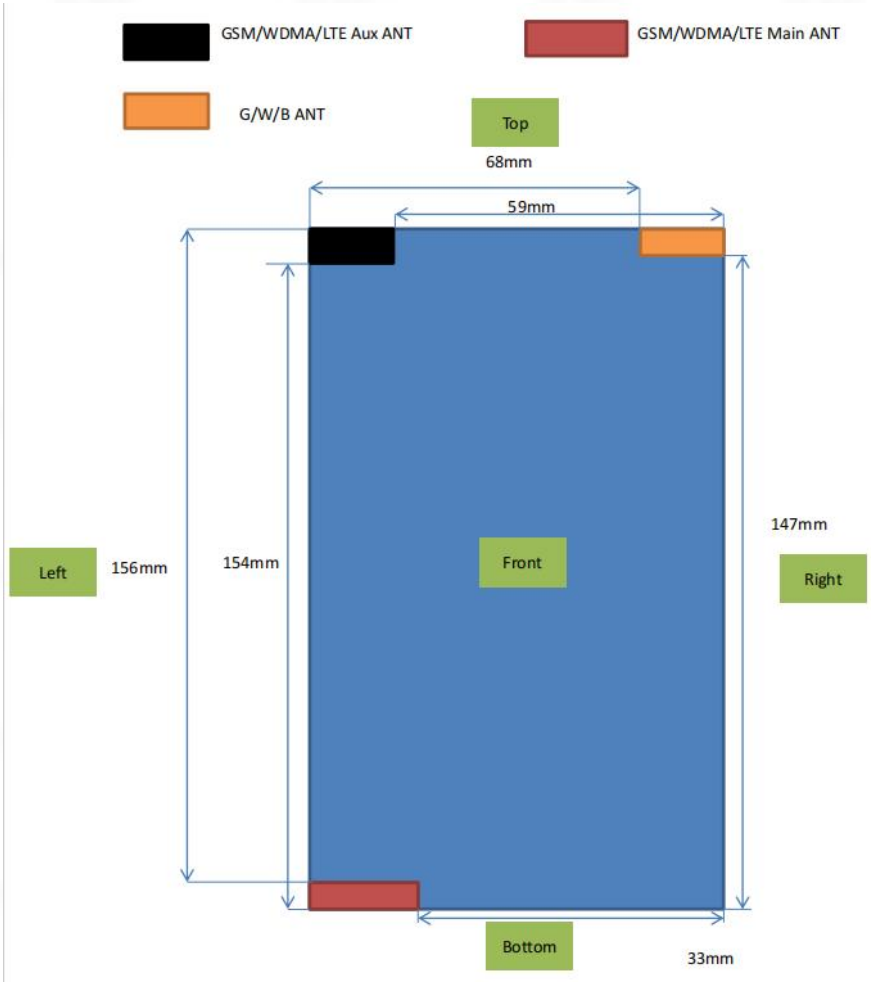
9. Test Exclusion Consideration

Antenna information:



WWAN Main Antenna	GSM/WCDMA/LTE TX/RX
WLAN/BT Antenna	WLAN/BT TX/RX

Note:
1. KDB 447498 D04v01, particular DUT edges were not required to be evaluated for SAR if the antenna-to-edge distance is greater than 2.5cm.
2. Per KDB648474 D04,10-g extremity SAR is not required when Body-Worn mode 1-g reported SAR<1.2W/Kg.

Distance of The Antenna to the EUT surface and edge (mm)						
Antenna	Front Side (mm)	Back Side (mm)	Left Edge (mm)	Right Edge (mm)	Top Edge (mm)	Bottom Edge (mm)
WWAN	<25	<25	<25	33	156	<25
BT/Wifi	<25	<25	68	<25	<25	147
Positions for SAR tests: Hotspot mode						
Antenna	Front Side (mm)	Back Side (mm)	Left Edge (mm)	Right Edge (mm)	Top Edge (mm)	Bottom Edge (mm)
WWAN	Yes	Yes	Yes	No	No	Yes
BT/Wifi	Yes	Yes	No	Yes	Yes	No

9.1 SAR Test Exclusion Consideration Table

Per KDB 447498 requires when the standalone SAR test exclusion of section 4.3.1 is applied to an antenna that transmits simultaneously with other antennas, the standalone SAR must be estimated according to the following format to determine simultaneous transmission SAR test exclusion:

(max.power of channel, including tune-up tolerance, mW) / (min. test separation distance, mm)] · [√f(GHz) / x] W/kg for test separation distances ≤ 50 mm;
where x = 7.5 for 1-g SAR, and x= 18.75 for 10-g SAR.
0.4 W/Kg for 1-g SAR and 1.0 W/kg for 10-g SAR, when the test separation distances is > 50 mm

Mode	Channel	Frequency (GHz)	Max tune-up power (dBm)	Max. Power (mW)	Exposure Position	Body-worn
					Test Dist.(mm)	10
BT	0	2.402	10.00	10.00	Estimated SAR(W/kg)	0.207

10. Test Result

Head(0mm gap)												
Mode	Position	Ch.	Freq. (MHz)	Power Drift (%)	1g Meas. SAR (W/kg)	Duty cycle (%)	Duty cycle Factor	Meas. Power (dBm)	Max. tune-up power (dBm)	Scaling Factor	1g Scaled SAR (W/kg)	Meas. No.
GSM 850 (voice)	Left Cheek	251	848.8	1.720	0.104	100.00	1.000	32.27	32.50	1.054	0.110	/
	Left Tilt	251	848.8	0.860	0.051	100.00	1.000	32.27	32.50	1.054	0.054	/
	Right Cheek	128	824.2	2.960	0.109	100.00	1.000	32.27	32.50	1.054	**0.115**	1#
	Right Tilt	251	848.8	-3.150	0.056	100.00	1.000	32.27	32.50	1.054	0.059	/
Body(10mm Gap)												
Mode	Position	Ch.	Freq. (MHz)	Power Drift (%)	1g Meas. SAR (W/kg)	Duty cycle (%)	Duty cycle Factor	Meas. Power (dBm)	Max. tune-up power (dBm)	Scaling Factor	1g Scaled SAR (W/kg)	Meas. No.
GSM 850 (voice)	Front	251	848.8	-2.010	0.156	100.00	1.000	32.27	32.50	1.054	0.164	/
	Back	251	848.8	-1.660	0.293	100.00	1.000	32.27	32.50	1.054	0.309	/
	Left	251	848.8	-3.720	0.127	100.00	1.000	32.27	32.50	1.054	0.134	/
	Bottom	251	848.8	0.290	0.243	100.00	1.000	32.27	32.50	1.054	0.256	/
Body(hotspot open, 10mm Gap)												
Mode	Position	Ch.	Freq. (MHz)	Power Drift (%)	1g Meas. SAR (W/kg)	Duty cycle (%)	Duty cycle Factor	Meas. Power (dBm)	Max. tune-up power (dBm)	Scaling Factor	1g Scaled SAR (W/kg)	Meas. No.
GPRS 850+2slots	Front	128	824.2	-3.890	0.248	100.00	1.000	29.83	30.00	1.040	0.258	/
	Back	128	824.2	-2.570	0.444	100.00	1.000	29.83	30.00	1.040	**0.462**	2#
	Left	128	824.2	0.410	0.216	100.00	1.000	29.83	30.00	1.040	0.225	/
	Bottom	128	824.2	-1.540	0.412	100.00	1.000	29.83	30.00	1.040	0.428	/

Head(0mm gap)												
Mode	Position	Ch.	Freq. (MHz)	Power Drift (%)	1g Meas. SAR (W/kg)	Duty cycle (%)	Duty cycle Factor	Meas. Power (dBm)	Max. tune-up power (dBm)	Scaling Factor	1g Scaled SAR (W/kg)	Meas. No.
GSM 1900 (voice)	Left Cheek	512	1850.2	-0.590	0.050	100.00	1.000	28.58	29.00	1.102	0.055	/
	Left Tilt	512	1850.2	-0.830	0.025	100.00	1.000	28.58	29.00	1.102	0.028	/
	Right Cheek	512	1850.2	2.250	0.055	100.00	1.000	28.58	29.00	1.102	**0.061**	3#
	Right Tilt	512	1850.2	0.150	0.031	100.00	1.000	28.58	29.00	1.102	0.034	/
Body(hotspot open, 10mm Gap)												
Mode	Position	Ch.	Freq. (MHz)	Power Drift (%)	1g Meas. SAR (W/kg)	Duty cycle (%)	Duty cycle Factor	Meas. Power (dBm)	Max. tune-up power (dBm)	Scaling Factor	1g Scaled SAR (W/kg)	Meas. No.
GSM 1900 (voice)	Front	512	1850.2	1.220	0.102	100.00	1.000	28.58	29.00	1.102	0.112	/
	Back	512	1850.2	-2.330	0.127	100.00	1.000	28.58	29.00	1.102	0.140	/
	Left	512	1850.2	1.040	0.088	100.00	1.000	28.58	29.00	1.102	0.097	/
	Bottom	512	1850.2	0.980	0.161	100.00	1.000	28.58	29.00	1.102	0.177	/
Body(hotspot open, 10mm Gap)												

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Mode	Position	Ch.	Freq. (MHz)	Power Drift (%)	1g Meas. SAR (W/kg)	Duty cycle (%)	Duty cycle Factor	Meas. Power (dBm)	Max. tune-up power (dBm)	Scaling Factor	1g Scaled SAR (W/kg)	Meas. No.
GPRS 1900+3slots	Front	512	1850.2	0.850	0.264	100.00	1.000	24.84	25.00	1.038	0.274	/
	Back	512	1850.2	-1.770	0.341	100.00	1.000	24.84	25.00	1.038	0.354	/
	Left	512	1850.2	0.460	0.231	100.00	1.000	24.84	25.00	1.038	0.240	/
	Bottom	512	1850.2	-3.090	0.390	100.00	1.000	24.84	25.00	1.038	**0.405**	4#

Head(0mm gap)												
Mode	Position	Ch.	Freq. (MHz)	Power Drift (%)	1g Meas. SAR (W/kg)	Duty cycle (%)	Duty cycle Factor	Meas. Power (dBm)	Max. tune-up power (dBm)	Scaling Factor	1g Scaled SAR (W/kg)	Meas. No.
WCDMA Band 2 (RMC*)	Left Cheek	9262	1852.4	-0.440	0.644	100.00	1.000	22.09	22.50	1.099	0.708	/
	Left Tilt	9262	1852.4	0.240	0.332	100.00	1.000	22.09	22.50	1.099	0.365	/
	Right Cheek	9262	1852.4	-3.950	0.652	100.00	1.000	22.09	22.50	1.099	**0.717**	5#
	Right Tilt	9262	1852.4	-3.880	0.338	100.00	1.000	22.09	22.50	1.099	0.371	/
Body(hotspot open, 10mm Gap)												
Mode	Position	Ch.	Freq. (MHz)	Power Drift (%)	1g Meas. SAR (W/kg)	Duty cycle (%)	Duty cycle Factor	Meas. Power (dBm)	Max. tune-up power (dBm)	Scaling Factor	1g Scaled SAR (W/kg)	Meas. No.
WCDMA Band 2 (RMC*)	Front	9262	1852.4	-3.120	0.297	100.00	1.000	22.09	22.50	1.099	0.326	/
	Back	9262	1852.4	3.520	0.753	100.00	1.000	22.09	22.50	1.099	0.828	/
	Left	9262	1852.4	-3.550	0.201	100.00	1.000	22.09	22.50	1.099	0.221	/
	Bottom	9262	1852.4	-4.120	0.934	100.00	1.000	22.09	22.50	1.099	**1.026**	6#
	Bottom-repeat	9262	1852.4	1.600	0.923	100.00	1.000	22.09	22.50	1.099	1.014	/
	Bottom	9400	1880.0	2.080	0.913	100.00	1.000	22.02	22.50	1.117	1.020	/
	Bottom	9538	1907.6	-0.390	0.897	100.00	1.000	21.61	22.00	1.094	0.981	/

Head(0mm gap)												
Mode	Position	Ch.	Freq. (MHz)	Power Drift (%)	1g Meas. SAR (W/kg)	Duty cycle (%)	Duty cycle Factor	Meas. Power (dBm)	Max. tune-up power (dBm)	Scaling Factor	1g Scaled SAR (W/kg)	Meas. No.
WCDMA Band 4 (RMC*)	Left Cheek	1312	1712.4	4.130	0.490	100.00	1.000	22.31	22.50	1.045	0.512	/
	Left Tilt	1312	1712.4	-1.040	0.233	100.00	1.000	22.31	22.50	1.045	0.243	/
	Right Cheek	1312	1712.4	-0.650	0.498	100.00	1.000	22.31	22.50	1.045	**0.520**	7#
	Right Tilt	1312	1712.4	-4.080	0.241	100.00	1.000	22.31	22.50	1.045	0.252	/
Body(hotspot open, 10mm Gap)												
Mode	Position	Ch.	Freq. (MHz)	Power Drift (%)	1g Meas. SAR (W/kg)	Duty cycle (%)	Duty cycle Factor	Meas. Power (dBm)	Max. tune-up power (dBm)	Scaling Factor	1g Scaled SAR (W/kg)	Meas. No.
WCDMA Band 4 (RMC*)	Front	1312	1712.4	1.650	0.523	100.00	1.000	22.31	22.50	1.045	0.547	/
	Back	1312	1712.4	3.760	0.897	100.00	1.000	22.31	22.50	1.045	0.937	/
	Left	1312	1712.4	-2.140	0.496	100.00	1.000	22.31	22.50	1.045	0.518	/
	Bottom	1312	1712.4	-1.270	0.939	100.00	1.000	22.31	22.50	1.045	**0.981**	8#
	Bottom-repeat	1312	1712.4	0.490	0.931	100.00	1.000	22.31	22.50	1.045	0.973	/
	Bottom	1413	1732.6	4.010	0.889	100.00	1.000	22.08	22.50	1.102	0.980	/
	Bottom	1513	1752.6	2.310	0.917	100.00	1.000	22.24	22.50	1.062	0.974	/

Head(0mm gap)												
Mode	Position	Ch.	Freq. (MHz)	Power Drift (%)	1g Meas SAR (W/kg)	Duty cycle (%)	Duty cycle Factor	Meas. Power (dBm)	Max. tune-up power (dBm)	Scaling Factor	1g Scaled SAR (W/kg)	Meas. No.
WCDMA Band 5 (RMC*)	Left Cheek	4132	826.4	3.220	0.157	100.00	1.000	23.70	24.00	1.072	0.168	/
	Left Tilt	4132	826.4	0.440	0.092	100.00	1.000	23.70	24.00	1.072	0.099	/
	Right Cheek	4132	826.4	-2.140	0.162	100.00	1.000	23.70	24.00	1.072	**0.174**	9#
	Right Tilt	4132	826.4	-2.810	0.099	100.00	1.000	23.70	24.00	1.072	0.106	/
Body(hotspot open, 10mm Gap)												
Mode	Position	Ch.	Freq. (MHz)	Power Drift (%)	1g Meas SAR (W/kg)	Duty cycle (%)	Duty cycle Factor	Meas. Power (dBm)	Max. tune-up power (dBm)	Scaling Factor	1g Scaled SAR (W/kg)	Meas. No.
WCDMA Band 5 (RMC*)	Front	4132	826.4	-2.310	0.178	100.00	1.000	23.70	24.00	1.072	0.191	/
	Back	4132	826.4	-1.060	0.306	100.00	1.000	23.70	24.00	1.072	**0.328**	10#
	Left	4132	826.4	-3.970	0.123	100.00	1.000	23.70	24.00	1.072	0.132	/
	Bottom	4132	826.4	-2.090	0.205	100.00	1.000	23.70	24.00	1.072	0.220	/

Head(0mm gap)													
Mode	Channel Type	Position	Ch.	Freq. (MHz)	Power Drift (%)	1g Meas SAR (W/kg)	Duty cycle (%)	Duty cycle Factor	Meas. Power (dBm)	Max. tune-up power (dBm)	Scaling Factor	1g Scaled SAR (W/kg)	Meas. No.
Band 2	1RB	Left Cheek	19100	1900.0	-1.400	0.317	100.00	1.000	22.72	23.00	1.067	0.338	/

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(BW: 20MHz)		Left Tilt	19100	1900.0	4.020	0.154	100.00	1.000	22.72	23.00	1.067	0.164	/
		Right Cheek	19100	1900.0	2.210	0.323	100.00	1.000	22.72	23.00	1.067	**0.345**	11#
		Right Tilt	19100	1900.0	-1.240	0.161	100.00	1.000	22.72	23.00	1.067	0.172	/
	50%RB	Left Cheek	19100	1900.0	0.410	0.288	100.00	1.000	21.63	22.00	1.089	0.314	/
		Left Tilt	19100	1900.0	-4.800	0.141	100.00	1.000	21.63	22.00	1.089	0.154	/
		Right Cheek	19100	1900.0	1.390	0.294	100.00	1.000	21.63	22.00	1.089	0.320	/
		Right Tilt	19100	1900.0	0.460	0.146	100.00	1.000	21.63	22.00	1.089	0.159	/

Body(hotspot open, 10mm Gap)

Mode	Channel Type	Position	Ch.	Freq. (MHz)	Power Drift (%)	1g Meas SAR (W/kg)	Duty cycle (%)	Duty cycle Factor	Meas. Power (dBm)	Max. tune-up power (dBm)	Scaling Factor	1g Scaled SAR (W/kg)	Meas. No.
Band 2 (BW: 20MHz)	1RB	Front	19100	1900.0	-2.580	0.613	100.00	1.000	22.72	23.00	1.067	0.654	/
		Back	19100	1900.0	3.650	0.931	100.00	1.000	22.72	23.00	1.067	0.993	/
		Left	19100	1900.0	1.040	0.582	100.00	1.000	22.72	23.00	1.067	0.621	/
		Bottom	18700	1860.0	2.080	0.923	100.00	1.000	22.56	23.00	1.107	1.022	/
		Bottom	18900	1880.0	0.890	0.911	100.00	1.000	22.49	22.50	1.002	0.913	/
		Bottom	19100	1900.0	2.530	0.960	100.00	1.000	22.72	23.00	1.067	**1.024**	12#
		Bottom-repeat	19100	1900.0	3.020	0.953	100.00	1.000	22.72	23.00	1.067	1.017	/
	50%RB	Front	19100	1900.0	-1.790	0.564	100.00	1.000	21.63	22.00	1.089	0.614	/
		Back	19100	1900.0	-4.700	0.890	100.00	1.000	21.63	22.00	1.089	0.969	/
		Left	19100	1900.0	-1.750	0.532	100.00	1.000	21.63	22.00	1.089	0.579	/
		Bottom	19100	1900.0	0.790	0.925	100.00	1.000	21.63	22.00	1.089	1.007	/

Head(0mm gap)

Mode	Channel Type	Position	Ch.	Freq. (MHz)	Power Drift (%)	1g Meas SAR (W/kg)	Duty cycle (%)	Duty cycle Factor	Meas. Power (dBm)	Max. tune-up power (dBm)	Scaling Factor	1g Scaled SAR (W/kg)	Meas. No.
Band 4 (BW: 20MHz)	1RB	Left Cheek	20050	1720.0	0.920	0.094	100.00	1.000	23.22	23.50	1.067	0.100	/
		Left Tilt	20050	1720.0	4.340	0.043	100.00	1.000	23.22	23.50	1.067	0.046	/
		Right Cheek	20050	1720.0	4.860	0.100	100.00	1.000	23.22	23.50	1.067	**0.107**	13#
		Right Tilt	20050	1720.0	-3.060	0.049	100.00	1.000	23.22	23.50	1.067	0.052	/
	50%RB	Left Cheek	20050	1720.0	-4.240	0.085	100.00	1.000	22.03	22.50	1.114	0.095	/
		Left Tilt	20050	1720.0	1.700	0.036	100.00	1.000	22.03	22.50	1.114	0.040	/
		Right Cheek	20050	1720.0	0.730	0.090	100.00	1.000	22.03	22.50	1.114	0.100	/
		Right Tilt	20050	1720.0	0.640	0.040	100.00	1.000	22.03	22.50	1.114	0.045	/

Body(hotspot open, 10mm Gap)

Mode	Channel Type	Position	Ch.	Freq. (MHz)	Power Drift (%)	1g Meas SAR (W/kg)	Duty cycle (%)	Duty cycle Factor	Meas. Power (dBm)	Max. tune-up power (dBm)	Scaling Factor	1g Scaled SAR (W/kg)	Meas. No.
Band 4 (BW: 20MHz)	1RB	Front	20175	1732.5	-0.960	0.428	100.00	1.000	23.22	23.50	1.067	0.457	/
		Back	20175	1732.5	-2.540	0.715	100.00	1.000	23.22	23.50	1.067	0.763	/
		Left	20175	1732.5	-4.550	0.403	100.00	1.000	23.22	23.50	1.067	0.430	/
		Bottom	20175	1732.5	-3.680	0.744	100.00	1.000	23.22	23.50	1.067	**0.794**	14#
	50%RB	Front	20175	1732.5	-3.340	0.382	100.00	1.000	22.03	22.50	1.114	0.426	/
		Back	20175	1732.5	-4.650	0.687	100.00	1.000	22.03	22.50	1.114	0.765	/
		Left	20175	1732.5	-2.020	0.343	100.00	1.000	22.03	22.50	1.114	0.382	/
		Bottom	20175	1732.5	-4.060	0.708	100.00	1.000	22.03	22.50	1.114	0.789	/

Head(0mm gap)

Mode	Channel Type	Position	Ch.	Freq. (MHz)	Power Drift (%)	1g Meas SAR (W/kg)	Duty cycle (%)	Duty cycle Factor	Meas. Power (dBm)	Max. tune-up power (dBm)	Scaling Factor	1g Scaled SAR (W/kg)	Meas. No.
Band 5 (BW: 10MHz)	1RB	Left Cheek	20525	836.5	-1.510	0.142	100.00	1.000	24.33	24.50	1.040	0.148	/
		Left Tilt	20525	836.5	4.020	0.072	100.00	1.000	24.33	24.50	1.040	0.075	/
		Right Cheek	20525	836.5	-4.680	0.147	100.00	1.000	24.33	24.50	1.040	**0.153**	15#
		Right Tilt	20525	836.5	-2.810	0.077	100.00	1.000	24.33	24.50	1.040	0.080	/
	50%RB	Left Cheek	20525	836.5	0.860	0.115	100.00	1.000	23.17	23.50	1.079	0.124	/
		Left Tilt	20525	836.5	-4.770	0.060	100.00	1.000	23.17	23.50	1.079	0.065	/
		Right Cheek	20525	836.5	-0.460	0.122	100.00	1.000	23.17	23.50	1.079	0.132	/
		Right Tilt	20525	836.5	0.490	0.065	100.00	1.000	23.17	23.50	1.079	0.070	/

Body(hotspot open, 10mm Gap)

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Mode	Channel Type	Position	Ch.	Freq. (MHz)	Power Drift (%)	1g Meas SAR (W/kg)	Duty cycle (%)	Duty cycle Factor	Meas. Power (dBm)	Max. tune-up power (dBm)	Scaling Factor	1g Scaled SAR (W/kg)	Meas. No.
Band 5 (BW: 10MHz)	1RB	Front	20525	836.5	-3.910	0.235	100.00	1.000	24.33	24.50	1.040	0.244	/
		Back	20525	836.5	-2.410	0.300	100.00	1.000	24.33	24.50	1.040	**0.312**	16#
		Left	20525	836.5	-1.540	0.202	100.00	1.000	24.33	24.50	1.040	0.210	/
		Bottom	20525	836.5	-3.390	0.261	100.00	1.000	24.33	24.50	1.040	0.271	/
	50%RB	Front	20525	836.5	0.020	0.197	100.00	1.000	23.17	23.50	1.079	0.213	/
		Back	20525	836.5	-1.570	0.273	100.00	1.000	23.17	23.50	1.079	0.295	/
		Left	20525	836.5	-0.870	0.176	100.00	1.000	23.17	23.50	1.079	0.190	/
		Bottom	20525	836.5	0.010	0.229	100.00	1.000	23.17	23.50	1.079	0.247	/

Head(0mm gap)													
Mode	Channel Type	Position	Ch.	Freq. (MHz)	Power Drift (%)	1g Meas SAR (W/kg)	Duty cycle (%)	Duty cycle Factor	Meas. Power (dBm)	Max. tune-up power (dBm)	Scaling Factor	1g Scaled SAR (W/kg)	Meas. No.
Band 7 (BW: 20MHz)	1RB	Left Cheek	21350	2560.0	1.650	0.211	100.00	1.000	23.11	23.50	1.094	0.231	/
		Left Tilt	21350	2560.0	1.470	0.106	100.00	1.000	23.11	23.50	1.094	0.116	/
		Right Cheek	21350	2560.0	2.570	0.217	100.00	1.000	23.11	23.50	1.094	**0.237**	17#
		Right Tilt	21350	2560.0	-3.910	0.111	100.00	1.000	23.11	23.50	1.094	0.121	/
	50%RB	Left Cheek	21350	2560.0	-1.370	0.183	100.00	1.000	22.01	22.50	1.119	0.205	/
		Left Tilt	21350	2560.0	0.800	0.082	100.00	1.000	22.01	22.50	1.119	0.092	/
		Right Cheek	21350	2560.0	-2.530	0.189	100.00	1.000	22.01	22.50	1.119	0.211	/
		Right Tilt	21350	2560.0	0.640	0.088	100.00	1.000	22.01	22.50	1.119	0.098	/
Body(hotspot open, 10mm Gap)													
Mode	Channel Type	Position	Ch.	Freq. (MHz)	Power Drift (%)	1g Meas SAR (W/kg)	Duty cycle (%)	Duty cycle Factor	Meas. Power (dBm)	Max. tune-up power (dBm)	Scaling Factor	1g Scaled SAR (W/kg)	Meas. No.
Band 7 (BW: 20MHz)	1RB	Front	21350	2560.0	0.270	0.553	100.00	1.000	23.11	23.50	1.094	0.605	/
		Back	21350	2560.0	-2.580	0.856	100.00	1.000	23.11	23.50	1.094	0.936	/
		Left	21350	2560.0	-3.150	0.517	100.00	1.000	23.11	23.50	1.094	0.566	/
		Bottom	20850	2510.0	1.890	0.882	100.00	1.000	22.90	23.00	1.023	0.902	/
		Bottom	21100	2535.0	4.360	0.878	100.00	1.000	22.90	23.00	1.023	0.898	/
		Bottom	21350	2560.0	-2.990	0.900	100.00	1.000	23.11	23.50	1.094	**0.985**	18#
		Bottom-repeat	21350	2560.0	1.600	0.892	100.00	1.000	23.11	23.50	1.094	0.976	/
	50%RB	Front	21350	2560.0	2.110	0.498	100.00	1.000	22.01	22.50	1.119	0.557	/
		Back	21350	2560.0	-3.910	0.816	100.00	1.000	22.01	22.50	1.119	0.913	/
		Left	21350	2560.0	-2.910	0.446	100.00	1.000	22.01	22.50	1.119	0.499	/
		Bottom	21350	2560.0	0.160	0.867	100.00	1.000	22.01	22.50	1.119	0.970	/

Head(0mm gap)													
Mode	Channel Type	Position	Ch.	Freq. (MHz)	Power Drift (%)	1g Meas SAR (W/kg)	Duty cycle (%)	Duty cycle Factor	Meas. Power (dBm)	Max. tune-up power (dBm)	Scaling Factor	1g Scaled SAR (W/kg)	Meas. No.
Band 19 (BW: 15MHz)	1RB	Left Cheek	24075	837.5	0.890	0.145	100.00	1.000	24.24	24.50	1.062	0.154	/
		Left Tilt	24075	837.5	3.210	0.081	100.00	1.000	24.24	24.50	1.062	0.086	/
		Right Cheek	24075	837.5	-4.460	0.151	100.00	1.000	24.24	24.50	1.062	**0.160**	19#
		Right Tilt	24075	837.5	-3.070	0.087	100.00	1.000	24.24	24.50	1.062	0.092	/
	50%RB	Left Cheek	24075	837.5	-1.810	0.124	100.00	1.000	23.21	23.50	1.069	0.133	/
		Left Tilt	24075	837.5	-2.700	0.067	100.00	1.000	23.21	23.50	1.069	0.072	/
		Right Cheek	24075	837.5	-3.290	0.133	100.00	1.000	23.21	23.50	1.069	0.142	/
		Right Tilt	24075	837.5	2.890	0.071	100.00	1.000	23.21	23.50	1.069	0.076	/
Body(hotspot open, 10mm Gap)													
Mode	Channel Type	Position	Ch.	Freq. (MHz)	Power Drift (%)	1g Meas SAR (W/kg)	Duty cycle (%)	Duty cycle Factor	Meas. Power (dBm)	Max. tune-up power (dBm)	Scaling Factor	1g Scaled SAR (W/kg)	Meas. No.
Band 19 (BW: 15MHz)	1RB	Front	24075	837.5	3.720	0.165	100.00	1.000	24.24	24.50	1.062	0.175	/
		Back	24075	837.5	-2.800	0.230	100.00	1.000	24.24	24.50	1.062	**0.244**	20#
		Left	24075	837.5	-2.870	0.126	100.00	1.000	24.24	24.50	1.062	0.134	/
		Bottom	24075	837.5	-3.650	0.203	100.00	1.000	24.24	24.50	1.062	0.216	/
	50%RB	Front	24075	837.5	-4.890	0.137	100.00	1.000	23.21	23.50	1.069	0.146	/
		Back	24075	837.5	-5.130	0.200	100.00	1.000	23.21	23.50	1.069	0.214	/
		Left	24075	837.5	-3.670	0.094	100.00	1.000	23.21	23.50	1.069	0.100	/
		Bottom	24075	837.5	-0.800	0.174	100.00	1.000	23.21	23.50	1.069	0.186	/

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Head(0mm gap)													
Mode	Channel Type	Position	Ch.	Freq. (MHz)	Power Drift (%)	1g Meas SAR (W/kg)	Duty cycle (%)	Duty cycle Factor	Meas. Power (dBm)	Max. tune-up power (dBm)	Scaling Factor	1g Scaled SAR (W/kg)	Meas. No.
Band 25 (BW: 20MHz)	1RB	Left Cheek	26590	1905.0	1.070	0.157	100.00	1.000	23.50	24.00	1.122	0.176	/
		Left Tilt	26590	1905.0	3.350	0.080	100.00	1.000	23.50	24.00	1.122	0.090	/
		Right Cheek	26590	1905.0	-0.550	0.163	100.00	1.000	23.50	24.00	1.122	**0.183**	21#
		Right Tilt	26590	1905.0	-0.450	0.086	100.00	1.000	23.50	24.00	1.122	0.096	/
	50%RB	Left Cheek	26590	1905.0	-4.410	0.141	100.00	1.000	22.49	22.50	1.002	0.141	/
		Left Tilt	26590	1905.0	-3.740	0.068	100.00	1.000	22.49	22.50	1.002	0.068	/
		Right Cheek	26590	1905.0	-4.810	0.146	100.00	1.000	22.49	22.50	1.002	0.146	/
		Right Tilt	26590	1905.0	-2.240	0.074	100.00	1.000	22.49	22.50	1.002	0.074	/
Body(hotspot open, 10mm Gap)													
Mode	Channel Type	Position	Ch.	Freq. (MHz)	Power Drift (%)	1g Meas SAR (W/kg)	Duty cycle (%)	Duty cycle Factor	Meas. Power (dBm)	Max. tune-up power (dBm)	Scaling Factor	1g Scaled SAR (W/kg)	Meas. No.
Band 25 (BW: 20MHz)	1RB	Front	26590	1905.0	0.190	0.768	100.00	1.000	23.50	24.00	1.122	0.862	/
		Back	26590	1905.0	0.500	0.946	100.00	1.000	23.50	24.00	1.122	1.061	/
		Left	26590	1905.0	-4.310	0.732	100.00	1.000	23.50	24.00	1.122	0.821	/
		Bottom	26140	1860.0	1.690	0.968	100.00	1.000	23.41	23.50	1.021	0.988	/
		Bottom	26365	1882.5	3.060	0.958	100.00	1.000	23.29	23.50	1.050	1.006	/
		Bottom	26590	1905.0	-2.760	0.984	100.00	1.000	23.50	24.00	1.122	**1.104**	22#
		Bottom-repeat	26590	1905.0	4.120	0.977	100.00	1.000	23.50	24.00	1.122	1.096	/
	50%RB	Front	26590	1905.0	-2.250	0.735	100.00	1.000	22.49	22.50	1.002	0.736	/
		Back	26590	1905.0	-4.850	0.917	100.00	1.000	22.49	22.50	1.002	0.919	/
		Left	26590	1905.0	-1.190	0.701	100.00	1.000	22.49	22.50	1.002	0.702	/
		Bottom	26590	1905.0	-2.720	0.965	100.00	1.000	22.49	22.50	1.002	0.967	/

Head(0mm gap)													
Mode	Channel Type	Position	Ch.	Freq. (MHz)	Power Drift (%)	1g Meas SAR (W/kg)	Duty cycle (%)	Duty cycle Factor	Meas. Power (dBm)	Max. tune-up power (dBm)	Scaling Factor	1g Scaled SAR (W/kg)	Meas. No.
Band 26 part 90 (BW:10MHz)	1RB	Left Cheek	26740	819.0	3.310	0.136	100.00	1.000	23.93	24.00	1.016	0.138	/
		Left Tilt	26740	819.0	3.070	0.068	100.00	1.000	23.93	24.00	1.016	0.069	/
		Right Cheek	26740	819.0	-1.390	0.143	100.00	1.000	23.93	24.00	1.016	**0.145**	23#
		Right Tilt	26740	819.0	-0.610	0.074	100.00	1.000	23.93	24.00	1.016	0.075	/
	50%RB	Left Cheek	26740	819.0	-1.770	0.122	100.00	1.000	22.89	23.00	1.026	0.125	/
		Left Tilt	26740	819.0	-2.960	0.061	100.00	1.000	22.89	23.00	1.026	0.063	/
		Right Cheek	26740	819.0	1.190	0.126	100.00	1.000	22.89	23.00	1.026	0.129	/
		Right Tilt	26740	819.0	-3.200	0.067	100.00	1.000	22.89	23.00	1.026	0.069	/
Body(hotspot open, 10mm Gap)													
Mode	Channel Type	Position	Ch.	Freq. (MHz)	Power Drift (%)	1g Meas SAR (W/kg)	Duty cycle (%)	Duty cycle Factor	Meas. Power (dBm)	Max. tune-up power (dBm)	Scaling Factor	1g Scaled SAR (W/kg)	Meas. No.
Band 26 part 90 (BW:10MHz)	1RB	Front	26740	819.0	-3.670	0.167	100.00	1.000	23.93	24.00	1.016	0.170	/
		Back	26740	819.0	3.670	0.258	100.00	1.000	23.93	24.00	1.016	**0.262**	24#
		Left	26740	819.0	-2.030	0.130	100.00	1.000	23.93	24.00	1.016	0.132	/
		Bottom	26740	819.0	-1.190	0.224	100.00	1.000	23.93	24.00	1.016	0.228	/
	50%RB	Front	26740	819.0	-2.610	0.138	100.00	1.000	22.89	23.00	1.026	0.142	/
		Back	26740	819.0	-2.070	0.219	100.00	1.000	22.89	23.00	1.026	0.225	/
		Left	26740	819.0	0.810	0.101	100.00	1.000	22.89	23.00	1.026	0.104	/
		Bottom	26740	819.0	-3.680	0.196	100.00	1.000	22.89	23.00	1.026	0.201	/
Head(0mm gap)													
Mode	Channel Type	Position	Ch.	Freq. (MHz)	Power Drift (%)	1g Meas SAR (W/kg)	Duty cycle (%)	Duty cycle Factor	Meas. Power (dBm)	Max. tune-up power (dBm)	Scaling Factor	1g Scaled SAR (W/kg)	Meas. No.
Band 26 part 22 (BW:15MHz)	1RB	Left Cheek	26915	836.5	-3.730	0.143	100.00	1.000	24.08	24.50	1.102	0.158	/
		Left Tilt	26915	836.5	0.750	0.066	100.00	1.000	24.08	24.50	1.102	0.073	/
		Right Cheek	26915	836.5	2.650	0.150	100.00	1.000	24.08	24.50	1.102	**0.165**	25#
		Right Tilt	26915	836.5	-1.600	0.073	100.00	1.000	24.08	24.50	1.102	0.080	/
	50%RB	Left Cheek	26915	836.5	-3.160	0.116	100.00	1.000	23.09	23.50	1.099	0.127	/
		Left Tilt	26915	836.5	-3.090	0.058	100.00	1.000	23.09	23.50	1.099	0.064	/
		Right Cheek	26915	836.5	0.640	0.122	100.00	1.000	23.09	23.50	1.099	0.134	/
		Right Tilt	26915	836.5	-4.110	0.064	100.00	1.000	23.09	23.50	1.099	0.070	/

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Body(hotspot open, 10mm Gap)													
Mode	Channel Type	Position	Ch.	Freq. (MHz)	Power Drift (%)	1g Meas SAR (W/kg)	Duty cycle (%)	Duty cycle Factor	Meas. Power (dBm)	Max. tune-up power (dBm)	Scaling Factor	1g Scaled SAR (W/kg)	Meas. No.
Band 26 part 22 (BW:15MHz)	1RB	Front	26915	836.5	-4.170	0.145	100.00	1.000	24.08	24.50	1.102	0.160	/
		Back	26915	836.5	-3.490	0.276	100.00	1.000	24.08	24.50	1.102	**0.304**	26#
		Left	26915	836.5	-2.190	0.116	100.00	1.000	24.08	24.50	1.102	0.128	/
		Bottom	26915	836.5	-2.010	0.240	100.00	1.000	24.08	24.50	1.102	0.264	/
	50%RB	Front	26915	836.5	-3.710	0.118	100.00	1.000	23.09	23.50	1.099	0.130	/
		Back	26915	836.5	-4.110	0.244	100.00	1.000	23.09	23.50	1.099	0.268	/
		Left	26915	836.5	0.470	0.078	100.00	1.000	23.09	23.50	1.099	0.086	/
		Bottom	26915	836.5	-4.540	0.212	100.00	1.000	23.09	23.50	1.099	0.233	/

Head(0mm gap)													
Mode	Channel Type	Position	Ch.	Freq. (MHz)	Power Drift (%)	1g Meas SAR (W/kg)	Duty cycle (%)	Duty cycle Factor	Meas. Power (dBm)	Max. tune-up power (dBm)	Scaling Factor	1g Scaled SAR (W/kg)	Meas. No.
Band 38 (BW: 20MHz)	1RB	Left Cheek	37850	2580.0	0.550	0.110	100.00	1.000	23.24	23.50	1.062	0.117	/
		Left Tilt	37850	2580.0	4.810	0.061	100.00	1.000	23.24	23.50	1.062	0.065	/
		Right Cheek	37850	2580.0	-3.880	0.114	100.00	1.000	23.24	23.50	1.062	**0.121**	27#
		Right Tilt	37850	2580.0	-1.770	0.066	100.00	1.000	23.24	23.50	1.062	0.070	/
	50%RB	Left Cheek	37850	2580.0	-3.450	0.092	100.00	1.000	22.14	22.50	1.086	0.100	/
		Left Tilt	37850	2580.0	-4.180	0.051	100.00	1.000	22.14	22.50	1.086	0.055	/
		Right Cheek	37850	2580.0	0.430	0.097	100.00	1.000	22.14	22.50	1.086	0.105	/
		Right Tilt	37850	2580.0	-4.160	0.057	100.00	1.000	22.14	22.50	1.086	0.062	/
Body(hotspot open, 10mm Gap)													
Mode	Channel Type	Position	Ch.	Freq. (MHz)	Power Drift (%)	1g Meas SAR (W/kg)	Duty cycle (%)	Duty cycle Factor	Meas. Power (dBm)	Max. tune-up power (dBm)	Scaling Factor	1g Scaled SAR (W/kg)	Meas. No.
Band 38 (BW: 20MHz)	1RB	Front	37850	2580.0	1.670	0.265	100.00	1.000	23.24	23.50	1.062	0.281	/
		Back	37850	2580.0	3.250	0.374	100.00	1.000	23.24	23.50	1.062	0.397	/
		Left	37850	2580.0	2.590	0.231	100.00	1.000	23.24	23.50	1.062	0.245	/
		Bottom	37850	2580.0	-2.900	0.416	100.00	1.000	23.24	23.50	1.062	**0.442**	28#
	50%RB	Front	37850	2580.0	-4.090	0.228	100.00	1.000	22.14	22.50	1.086	0.248	/
		Back	37850	2580.0	-3.290	0.332	100.00	1.000	22.14	22.50	1.086	0.361	/
		Left	37850	2580.0	0.050	0.192	100.00	1.000	22.14	22.50	1.086	0.209	/
		Bottom	37850	2580.0	-2.640	0.375	100.00	1.000	22.14	22.50	1.086	0.407	/

Head(0mm gap)													
Mode	Channel Type	Position	Ch.	Freq. (MHz)	Power Drift (%)	1g Meas SAR (W/kg)	Duty cycle (%)	Duty cycle Factor	Meas. Power (dBm)	Max. tune-up power (dBm)	Scaling Factor	1g Scaled SAR (W/kg)	Meas. No.
Band 41 (BW: 20MHz)	1RB	Left Cheek	40140	2545.0	1.300	0.123	100.00	1.000	23.23	23.50	1.064	0.131	/
		Left Tilt	40140	2545.0	-1.530	0.058	100.00	1.000	23.23	23.50	1.064	0.062	/
		Right Cheek	40140	2545.0	-1.150	0.130	100.00	1.000	23.23	23.50	1.064	**0.138**	29#
		Right Tilt	40140	2545.0	-0.840	0.064	100.00	1.000	23.23	23.50	1.064	0.068	/
	50%RB	Left Cheek	40140	2545.0	-4.840	0.102	100.00	1.000	21.90	22.00	1.023	0.104	/
		Left Tilt	40140	2545.0	-2.310	0.053	100.00	1.000	21.90	22.00	1.023	0.054	/
		Right Cheek	40140	2545.0	-0.120	0.110	100.00	1.000	21.90	22.00	1.023	0.113	/
		Right Tilt	40140	2545.0	-3.070	0.058	100.00	1.000	21.90	22.00	1.023	0.059	/
Body(hotspot open, 10mm Gap)													
Mode	Channel Type	Position	Ch.	Freq. (MHz)	Power Drift (%)	1g Meas SAR (W/kg)	Duty cycle (%)	Duty cycle Factor	Meas. Power (dBm)	Max. tune-up power (dBm)	Scaling Factor	1g Scaled SAR (W/kg)	Meas. No.
Band 41 (BW: 20MHz)	1RB	Front	40140	2545.0	0.930	0.314	100.00	1.000	23.23	23.50	1.064	0.334	/
		Back	40140	2545.0	-2.170	0.405	100.00	1.000	23.23	23.50	1.064	0.431	/
		Left	40140	2545.0	1.430	0.272	100.00	1.000	23.23	23.50	1.064	0.289	/
		Bottom	40140	2545.0	-2.670	0.438	100.00	1.000	23.23	23.50	1.064	**0.466**	30#
	50%RB	Front	40140	2545.0	2.390	0.293	100.00	1.000	21.90	22.00	1.023	0.300	/
		Back	40140	2545.0	-3.330	0.369	100.00	1.000	21.90	22.00	1.023	0.377	/
		Left	40140	2545.0	-0.290	0.242	100.00	1.000	21.90	22.00	1.023	0.248	/
		Bottom	40140	2545.0	-3.500	0.403	100.00	1.000	21.90	22.00	1.023	0.412	/

Head(0mm gap)

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Mode	Channel Type	Position	Ch.	Freq. (MHz)	Power Drift (%)	1g Meas SAR (W/kg)	Duty cycle (%)	Duty cycle Factor	Meas. Power (dBm)	Max. tune-up power (dBm)	Scaling Factor	1g Scaled SAR (W/kg)	Meas. No.
Band 66 (BW: 20MHz)	1RB	Left Cheek	132322	1745.0	2.790	0.112	100.00	1.000	23.46	23.50	1.009	0.113	/
		Left Tilt	132322	1745.0	1.470	0.051	100.00	1.000	23.46	23.50	1.009	0.051	/
		Right Cheek	132322	1745.0	-3.540	0.116	100.00	1.000	23.46	23.50	1.009	**0.117**	31#
		Right Tilt	132322	1745.0	-2.930	0.056	100.00	1.000	23.46	23.50	1.009	0.057	/
	50%RB	Left Cheek	132322	1745.0	1.130	0.082	100.00	1.000	22.35	22.50	1.035	0.085	/
		Left Tilt	132322	1745.0	-4.400	0.037	100.00	1.000	22.35	22.50	1.035	0.038	/
		Right Cheek	132322	1745.0	-0.330	0.087	100.00	1.000	22.35	22.50	1.035	0.090	/
		Right Tilt	132322	1745.0	-2.120	0.042	100.00	1.000	22.35	22.50	1.035	0.043	/
Body(hotspot open, 10mm Gap)													
Mode	Channel Type	Position	Ch.	Freq. (MHz)	Power Drift (%)	1g Meas SAR (W/kg)	Duty cycle (%)	Duty cycle Factor	Meas. Power (dBm)	Max. tune-up power (dBm)	Scaling Factor	1g Scaled SAR (W/kg)	Meas. No.
Band 66 (BW: 20MHz)	1RB	Front	132322	1745.0	-1.250	0.413	100.00	1.000	23.46	23.50	1.009	0.417	/
		Back	132322	1745.0	-2.230	0.664	100.00	1.000	23.46	23.50	1.009	0.670	/
		Left	132322	1745.0	-3.460	0.372	100.00	1.000	23.46	23.50	1.009	0.375	/
		Bottom	132322	1745.0	-3.730	0.709	100.00	1.000	23.46	23.50	1.009	**0.715**	32#
	50%RB	Front	132322	1745.0	0.250	0.370	100.00	1.000	22.35	22.50	1.035	0.383	/
		Back	132322	1745.0	-2.410	0.633	100.00	1.000	22.35	22.50	1.035	0.655	/
		Left	132322	1745.0	3.080	0.337	100.00	1.000	22.35	22.50	1.035	0.349	/
		Bottom	132322	1745.0	-1.370	0.672	100.00	1.000	22.35	22.50	1.035	0.696	/

Head(0mm gap)											
Mode	Position	Ch.	Freq. (MHz)	Power Drift (%)	1g Meas SAR (W/kg)	Duty cycle (%)	Duty cycle Factor	Meas. Power (dBm)	Max. tune-up power (dBm)	Scaling Factor	1g Scaled SAR (W/kg)	Meas. No.
2.4g (2.4~2.4835) 802.11b	Left Cheek	6	2437	0.950	0.568	100.00	1.000	16.94	17.00	1.014	0.576	/
	Left Tilt	6	2437	2.100	0.316	100.00	1.000	16.94	17.00	1.014	0.320	/
	Right Cheek	6	2437	3.020	0.574	100.00	1.000	16.94	17.00	1.014	**0.582**	33#
	Right Tilt	6	2437	-0.340	0.322	100.00	1.000	16.94	17.00	1.014	0.327	/
Body(hotspot open, 10mm Gap)												
Mode	Position	Ch.	Freq. (MHz)	Power Drift (%)	1g Meas SAR (W/kg)	Duty cycle (%)	Duty cycle Factor	Meas. Power (dBm)	Max. tune-up power (dBm)	Scaling Factor	1g Scaled SAR (W/kg)	Meas. No.
2.4g (2.4~2.4835) 802.11b	Front	6	2437	2.950	0.130	100.00	1.000	16.94	17.00	1.014	0.132	/
	Back	6	2437	3.010	0.188	100.00	1.000	16.94	17.00	1.014	**0.191**	34#
	Right	6	2437	-0.820	0.112	100.00	1.000	16.94	17.00	1.014	0.114	/
	Top	6	2437	-1.470	0.159	100.00	1.000	16.94	17.00	1.014	0.161	/

Head(0mm gap)											
Mode	Position	Ch.	Freq. (MHz)	Power Drift (%)	1g Meas SAR (W/kg)	Duty cycle (%)	Duty cycle Factor	Meas. Power (dBm)	Max. tune-up power (dBm)	Scaling Factor	1g Scaled SAR (W/kg)	Meas. No.
U-NII-1 (5.150~5.250) 802.11ac(VHT80)	Left Cheek	42	5210	1.410	0.253	100.00	1.000	13.00	13.00	1.000	0.253	/
	Left Tilt	42	5210	-1.820	0.120	100.00	1.000	13.00	13.00	1.000	0.120	/
	Right Cheek	42	5210	-1.810	0.259	100.00	1.000	13.00	13.00	1.000	**0.259**	35#
	Right Tilt	42	5210	-1.880	0.125	100.00	1.000	13.00	13.00	1.000	0.125	/
Body(hotspot open, 10mm Gap)												
Mode	Position	Ch.	Freq. (MHz)	Power Drift (%)	1g Meas SAR (W/kg)	Duty cycle (%)	Duty cycle Factor	Meas. Power (dBm)	Max. tune-up power (dBm)	Scaling Factor	1g Scaled SAR (W/kg)	Meas. No.
U-NII-1 (5.150~5.250) 802.11ac(VHT80)	Front	42	5210	0.750	0.157	100.00	1.000	13.00	13.00	1.000	0.157	/
	Back	42	5210	2.560	0.212	100.00	1.000	13.00	13.00	1.000	**0.212**	36#
	Right	42	5210	-2.390	0.129	100.00	1.000	13.00	13.00	1.000	0.129	/
	Top	42	5210	0.450	0.183	100.00	1.000	13.00	13.00	1.000	0.183	/

Head(0mm gap)											
Mode	Position	Ch.	Freq. (MHz)	Power Drift (%)	1g Meas SAR (W/kg)	Duty cycle (%)	Duty cycle Factor	Meas. Power (dBm)	Max. tune-up power (dBm)	Scaling Factor	1g Scaled SAR (W/kg)	Meas. No.
U-NII-2a (5.250~5.350) 802.11ac(VHT80)	Left Cheek	58	5290	0.880	0.368	100.00	1.000	11.59	12.00	1.099	0.404	/
	Left Tilt	58	5290	-0.790	0.164	100.00	1.000	11.59	12.00	1.099	0.180	/
	Right Cheek	58	5290	-1.010	0.374	100.00	1.000	11.59	12.00	1.099	**0.411**	37#
	Right Tilt	58	5290	-0.600	0.171	100.00	1.000	11.59	12.00	1.099	0.188	/
Body(hotspot open, 10mm Gap)												
Mode	Position	Ch.	Freq. (MHz)	Power Drift (%)	1g Meas SAR (W/kg)	Duty cycle (%)	Duty cycle Factor	Meas. Power (dBm)	Max. tune-up power (dBm)	Scaling Factor	1g Scaled SAR (W/kg)	Meas. No.

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U-NII-2a (5.250~5.350) 802.11ac(VHT80)	Front	58	5290	4.480	0.112	100.00	1.000	11.59	12.00	1.099	0.123	/
	Back	58	5290	-2.320	0.150	100.00	1.000	11.59	12.00	1.099	**0.165**	38#
	Right	58	5290	-3.440	0.093	100.00	1.000	11.59	12.00	1.099	0.102	/
	Top	58	5290	0.160	0.131	100.00	1.000	11.59	12.00	1.099	0.144	/

Head(0mm gap)												
Mode	Position	Ch.	Freq. (MHz)	Power Drift (%)	1g Meas SAR (W/kg)	Duty cycle (%)	Duty cycle Factor	Meas. Power (dBm)	Max. tune-up power (dBm)	Scaling Factor	1g Scaled SAR (W/kg)	Meas. No.
U-NII-2c (5.470~5.725) 802.11n(HT20)	Left Cheek	140	5700	1.040	0.242	100.00	1.000	9.59	10.00	1.099	0.266	/
	Left Tilt	140	5700	2.500	0.115	100.00	1.000	9.59	10.00	1.099	0.126	/
	Right Cheek	140	5700	3.370	0.247	100.00	1.000	9.59	10.00	1.099	**0.271**	39#
	Right Tilt	140	5700	-1.390	0.121	100.00	1.000	9.59	10.00	1.099	0.133	/
Body(hotspot open, 10mm Gap)												
Mode	Position	Ch.	Freq. (MHz)	Power Drift (%)	1g Meas SAR (W/kg)	Duty cycle (%)	Duty cycle Factor	Meas. Power (dBm)	Max. tune-up power (dBm)	Scaling Factor	1g Scaled SAR (W/kg)	Meas. No.
U-NII-2c (5.470~5.725) 802.11n(HT20)	Front	140	5700	0.670	0.110	100.00	1.000	9.59	10.00	1.099	0.121	/
	Back	140	5700	-3.670	0.167	100.00	1.000	9.59	10.00	1.099	**0.184**	40#
	Right	140	5700	-4.430	0.090	100.00	1.000	9.59	10.00	1.099	0.099	/
	Top	140	5700	-0.800	0.135	100.00	1.000	9.59	10.00	1.099	0.148	/

Head(0mm gap)												
Mode	Position	Ch.	Freq. (MHz)	Power Drift (%)	1g Meas SAR (W/kg)	Duty cycle (%)	Duty cycle Factor	Meas. Power (dBm)	Max. tune-up power (dBm)	Scaling Factor	1g Scaled SAR (W/kg)	Meas. No.
U-NII-3 (5.725~5.850) 802.11ac(VHT40)	Left Cheek	159	5795	-1.760	0.574	100.00	1.000	11.13	11.50	1.089	0.625	/
	Left Tilt	159	5795	-0.490	0.262	100.00	1.000	11.13	11.50	1.089	0.285	/
	Right Cheek	159	5795	-1.980	0.581	100.00	1.000	11.13	11.50	1.089	**0.633**	41#
	Right Tilt	159	5795	0.630	0.268	100.00	1.000	11.13	11.50	1.089	0.292	/
Body(hotspot open, 10mm Gap)												
Mode	Position	Ch.	Freq. (MHz)	Power Drift (%)	1g Meas SAR (W/kg)	Duty cycle (%)	Duty cycle Factor	Meas. Power (dBm)	Max. tune-up power (dBm)	Scaling Factor	1g Scaled SAR (W/kg)	Meas. No.
U-NII-3 (5.725~5.850) 802.11ac(VHT40)	Front	159	5795	-0.160	0.122	100.00	1.000	11.13	11.50	1.089	0.133	/
	Back	159	5795	2.400	0.179	100.00	1.000	11.13	11.50	1.089	**0.195**	42#
	Right	159	5795	-2.150	0.103	100.00	1.000	11.13	11.50	1.089	0.112	/
	Top	159	5795	0.570	0.140	100.00	1.000	11.13	11.50	1.089	0.152	/

Head(0mm gap)												
Mode	Position	Ch.	Freq. (MHz)	Power Drift (%)	1g Meas SAR (W/kg)	Duty cycle (%)	Duty cycle Factor	Meas. Power (dBm)	Max. tune-up power (dBm)	Scaling Factor	1g Scaled SAR (W/kg)	Meas. No.
Bluetooth	Left Cheek	0	2402	1.990	0.067	100.00	1.000	9.82	10.00	1.042	0.070	/
	Left Tilt	0	2402	-0.460	0.030	100.00	1.000	9.82	10.00	1.042	0.031	/
	Right Cheek	0	2402	-1.440	0.072	100.00	1.000	9.82	10.00	1.042	**0.075**	43#
	Right Tilt	0	2402	0.400	0.035	100.00	1.000	9.82	10.00	1.042	0.036	/

Note:
1. The maximum SAR Value of each test band is marked bold.
2. SAR plot is provided only for the highest measured SAR in each exposure configuration, wireless mode and frequency band combination.
3. Per KDB 447498 D04 v01, for each exposure position, if the highest output power channel Reported SAR ≤ 0.8W/kg, other channels SAR testing is not necessary.
4. Per KDB 447498 D04 v01, head/body-worn use is evaluated with the device positioned at 0mm/10 mm from a head/flat phantom respectively filled with head tissue-equivalent medium.
5. Per KDB Publication 941225 D06 where SAR test considerations for handsets (L x W ≥ 9 cm x 5 cm) are based on a composite test separation distance of 10 mm from the front, back and edges of the device with antennas 2.5 cm or closer to the edge of the device, determined from general mixed use conditions for this type of devices. Since the hotspot SAR results may overlap with the body-worn accessory SAR requirements, the more conservative configurations can be considered, thus excluding some body-worn accessory SAR tests.
6. Per KDB 447498 D04 v01, the report SAR is measured SAR value adjusted for maximum tune-up tolerance. Scaling Factor=10^[(tune-up limit power(dBm) - Ave.power power (dBm))/10], where tune-up limit is the maximum rated power among all production units.
   Reported SAR(W/kg)=Measured SAR (W/kg)*Scaling Factor.

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11. SAR Measurement Variability

According to KDB 865664 D01, SAR measurement variability was assessed for each frequency band, which is determined by the SAR probe calibration point and tissue-equivalent medium used for the device measurements. When both head and body tissue-equivalent media are required for SAR measurements in a frequency band, the variability measurement procedures should be applied to the tissue medium with the highest measured SAR, using the highest measured SAR configuration for that tissue-equivalent medium. Alternatively, if the highest measured SAR for both head and body tissue-equivalent media are ≤ 1.45 W/kg and the ratio of these highest SAR values, i.e., largest divided by smallest value, is ≤ 1.10, the highest SAR configuration for either head or body tissue-equivalent medium may be used to perform the repeated measurement. These additional measurements are repeated after the completion of all measurements requiring the same head or body tissue-equivalent medium in a frequency band. The test device should be returned to ambient conditions (normal room temperature) with the battery fully charged before it is re-mounted on the device holder for the repeated measurement(s) to minimize any unexpected variations in the repeated results.

SAR repeated measurement procedure:

1. When the highest measured SAR is < 0.80 W/kg, repeated measurement is not required.
2. When the highest measured SAR is >= 0.80 W/kg, repeat that measurement once.
3. If the ratio of largest to smallest SAR for the original and first repeated measurements is > 1.20, or when the original or repeated measurement is >= 1.45 W/kg, perform a second repeated measurement.
4. If the ratio of largest to smallest SAR for the original, first and second repeated measurements is > 1.20, and the original, first or second repeated measurement is >= 1.5 W/kg, perform a third repeated measurement.

Note: For 1g SAR, the highest measured 1g SAR is 0.984 < 0.80 W/kg, repeated measurement is as below.

Mode	Position	Ch.	Freq. (MHz)	1g Meas SAR (W/kg)	the ratio of largest to smallest SAR for the original and first repeated measurements
WCDMA Band II	Bottom	9262	1852.4	0.934	1.012
	Bottom-repeat	9262	1852.4	0.923	
WCDMA Band IV	Bottom	1312	1712.4	0.939	1.009
	Bottom-repeat	1312	1712.4	0.931	
LTE band 2	Bottom	19100	1900.0	0.960	1.007
	Bottom-repeat	19100	1900.0	0.953	
LTE band 7	Bottom	21350	2560.0	0.900	1.009
	Bottom-repeat	21350	2560.0	0.892	
LTE band 25	Bottom	26590	1905.0	0.984	1.007
	Bottom-repeat	26590	1905.0	0.977	

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12. Simultaneous Transmission

Simultaneous transmission SAR test exclusion is determined for each operating configuration and exposure condition according to the reported standalone SAR of each applicable simultaneous transmitting antenna. When the sum of SAR 1g of all simultaneously transmitting antennas in an operating mode and exposure condition combination is within the SAR limit (SAR 1g 1.6 W/kg), the simultaneous transmission SAR is not required. When the sum of SAR 1g is greater than the SAR limit (SAR 1g 1.6 W/kg), SAR test exclusion is determined by the SAR to Peak Location Ratio (SPLSR).

12.1 Simultaneous Transmission Mode Considerations

Simultaneous transmission SAR test exclusion is determined for each operating configuration and exposure condition according to the reported standalone SAR of each applicable simultaneous transmitting antenna. The device has 2 Tx antennas, WWAN main antenna, Wifi/BT antenna supports 2.4G/5G Wi-Fi and BT. The 2 antennas can always transmit simultaneously. The work mode combination is showed as below table.

Application Simultaneous Transmission information:

NO.	Configuration	Head	Body-worn
1	WWAN+WIFI(2.4g)	Yes	Yes
2	WWAN+WIFI(5g)	Yes	Yes
3	WWAN+BT	Yes	Yes

12.2 Sum SAR of Simultaneous Transmission

Head

Band	Test Position	Channel Type	Scaled				Σ SAR (W/kg) WWAN + WIFI 2.4G	Σ SAR (W/kg) WWAN + WIFI 5G	Σ SAR (W/kg) WWAN + BT	SPLSR	Remark
			WWAN	WIFI 2.4G	WIFI 5G	Bluetooth					
WCDMA Band 2	Left Cheek	1RB	0.708	0.576	0.625	0.070	1.284	1.333	0.778	N/A	N/A
	Left Tilt		0.365	0.320	0.285	0.031	0.685	0.650	0.396	N/A	N/A
	Right Cheek		**0.717**	**0.582**	**0.633**	**0.075**	1.299	**1.350**	0.792	N/A	N/A
	Right Tilt		0.371	0.327	0.292	0.036	0.698	0.663	0.407	N/A	N/A

Hotspot(body-worn)

Band	Test Position	Channel Type	Scaled				Σ SAR (W/kg) WWAN + WIFI 2.4G	Σ SAR (W/kg) WWAN + WIFI 5G	Σ SAR (W/kg) WWAN + BT	SPLSR	Remark
			WWAN	WIFI 2.4G	WIFI 5G	Bluetooth					
LTE band 25	Front	1RB	0.862	0.132	0.133	**0.207**	0.994	0.995	1.069	N/A	N/A
	Back		**1.061**	**0.191**	**0.195**	0.207	1.252	1.256	**1.268**	N/A	N/A
	Left		0.821	/	/	/	0.821	0.821	0.821	N/A	N/A
	Right		/	0.114	0.112	0.207	0.114	0.112	0.207	N/A	N/A
	Top		/	0.161	0.152	0.207	0.161	0.152	0.207	N/A	N/A
	Bottom		1.104	/	/	/	1.104	1.104	1.104	N/A	N/A
	Front	50%RB	0.736	0.132	0.133	0.207	0.868	0.869	0.943	N/A	N/A
	Back		0.919	0.191	0.195	0.207	1.110	1.114	1.126	N/A	N/A
	Left		0.702	/	/	/	0.702	0.702	0.702	N/A	N/A
	Right		/	0.114	0.112	0.207	0.114	0.112	0.207	N/A	N/A
	Top		/	0.161	0.152	0.207	0.161	0.152	0.207	N/A	N/A
	Bottom		0.967	/	/	/	0.967	0.967	0.967	N/A	N/A

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13. Test Equipment List

Description	Manufacturer	Model	Serial No./Version	Cal. Date	Cal. Due
E-Field Probe	MVG	SSE2	04/22 EPGO365	2024/02/06	2025/02/05
6 1/2 Digital Multimeter	Keithley	DMM6500	4527164	2023/11/16	2024/11/15
Wideband Radio Communication Tester	ROHDE & SCHWARZ	CMW500	161997	2023/11/16	2024/11/15
MXG Vector Signal Generator	Agilent	N5182A	MY46240163	2023/11/16	2024/11/15
E-Series Avg. Power Sensor	KEYSIGHT	E9300A	MY55050017	2024/03/20	2025/03/19
EPM Series Power Meter	KEYSIGHT	E4418B	MY41293435	2024/03/20	2025/03/19
10dB Attenuator	MIDWEST MICROWAVE	263-10dB	/	2024/03/20	2025/03/19
Coupler	MERRIMAC	CWM-10R-10.8G	LOT-83391	2024/03/20	2025/03/19
835MHz Validation Dipole	MVG	SID835	07/22 DIP 0G835-656	2023/02/06	2025/02/05
1800MHz Validation Dipole	MVG	SID1800	07/22 DIP 1G800-657	2023/02/06	2025/02/05
1900MHz Validation Dipole	MVG	SID1900	07/22 DIP 1G900-658	2023/02/06	2025/02/05
2450MHz Validation Dipole	MVG	SID2450	07/22 DIP 2G450-662	2023/02/06	2025/02/05
2600MHz Validation Dipole	MVG	SID2600	07/22 DIP 2G600-663	2023/02/06	2025/02/05
5200MHz-5800MHz Validation Dipole	MVG	SID5000	07/22 DIP5G000-670	2023/02/06	2025/02/05
LIMESAR Dielectric Probe	MVG	SCLMP	06/22 OCPG88	/	/
ENA Series Network Analyzer	Agilent	E5071B	MY42301221	2023/11/16	2024/11/15
Thermometer	Riters	DT-232	21A11	2024/03/20	2025/03/19
Antenna network emulator	MVG	ANTA 74	07/22 ANTA 74	/	/
SAM Phantom	MVG	SAM	07/22 SAM149	/	/
Mobile Phone Positioning System	MVG	MSH 118	07/22 MSH 118	/	/
Mechanical Calibration Kit	PNA	/	/	/	/
Open SAR test software	MVG	/	V5.3.5	/	/

Note: For dipole antennas, BTF has adopted 3 years as calibration intervals, and on annual basis, every measurement dipole has been evaluated and is in compliance with the following criteria:

1. There is no physical damage on the dipole;
2. System validation with specific dipole is within 10% of calibrated value;
3. Return-loss in within 20% of calibrated measurement.
4. Impedance (real or imaginary parts) in within 5 Ohms of calibrated measurement.

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ANNEX A Simulating Liquid Verification Result

The dielectric parameters of the liquids were verified prior to the SAR evaluation using an SCLMP Dielectric Probe Kit.

Dielectric performance of tissue simulating liquid									
Frequency (MHz)	εr		σ(s/m)		Delta (εr)	Delta (σ)	Limit	Temp (℃)	Date
	Target	Measured	Target	Measured					
835	41.50	41.41	0.90	0.87	0.22%	3.33%	±5%	20.0	18/6/2024
1800	40.00	39.91	1.40	1.37	0.23%	2.14%	±5%	20.0	20/6/2024
1900	40.00	39.88	1.40	1.41	0.30%	-0.71%	±5%	20.0	21/6/2024
2450	39.20	39.08	1.80	1.81	0.31%	-0.56%	±5%	20.0	24/6/2024
2600	39.00	38.88	1.96	1.97	0.31%	-0.51%	±5%	20.0	25/6/2024
5200	36.00	35.88	4.66	4.70	0.33%	-0.86%	±5%	20.0	26/6/2024
5400	35.80	35.68	4.86	4.90	-0.34%	0.82%	±5%	20.0	26/6/2024
5600	35.50	35.38	5.07	5.11	-0.34%	0.79%	±5%	20.0	27/6/2024
5800	35.30	35.18	5.27	5.31	0.34%	-0.76%	±5%	20.0	27/6/2024
NOTE: The dielectric parameters of the tissue-equivalent liquid should be measured under similar ambient conditions and within 2 ℃ of the conditions expected during the SAR evaluation to satisfy protocol requirements.									

ANNEX B System Check Result

Comparing to the original SAR value provided by MVG, the validation data should be within its specification of 10 %(for 10 g).

Frequency (MHz)	Input Power (mW)	10g SAR (W/Kg)	1g SAR (W/Kg)	10g SAR 1W input power normalized (W/Kg)	1g SAR 1W input power normalized (W/Kg)	10g SAR Standard target (1W) (W/Kg)	1g SAR Standard target (1W) (W/Kg)	1g SAR Deviation	10g SAR Deviation
835	16	0.106	0.163	6.63	10.19	6.22	9.56	6.51%	6.56%
1800	16	0.312	0.588	19.50	36.75	20.10	38.40	-2.99%	-4.30%
1900	16	0.322	0.630	20.13	39.38	20.50	39.70	-1.83%	-0.82%
2450	16	0.352	0.793	22.00	49.56	23.86	54.4	-7.80%	-8.89%
2600	16	0.421	0.866	26.31	54.13	24.60	55.30	6.96%	-2.12%
5200	13	0.288	1.019	22.15	78.38	21.29	73.88	4.06%	6.10%
5400	13	0.299	1.051	23.00	80.85	23.23	81.47	-0.99%	-0.77%
5600	13	0.304	1.084	23.38	83.38	22.64	78.71	3.29%	5.94%
5800	13	0.277	0.981	21.31	75.46	21.5	74.21	-0.89%	1.69%

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ANNEX C SAR Dipole Calibrations

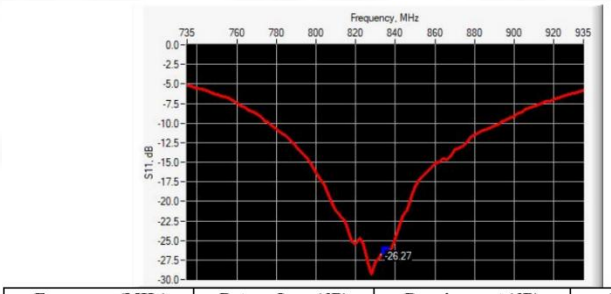
Justification for Extended SAR Dipole Calibrations

Referring to KDB 865664D01V01r04, if dipoles are verified in return loss (<-20dB, within 20% of prior calibration)and in impedance (within 5 ohm of prior calibration). the annual calibration is not necessary and the calibrationinterval can be extended.While calibration intervals not exceed 3 years.

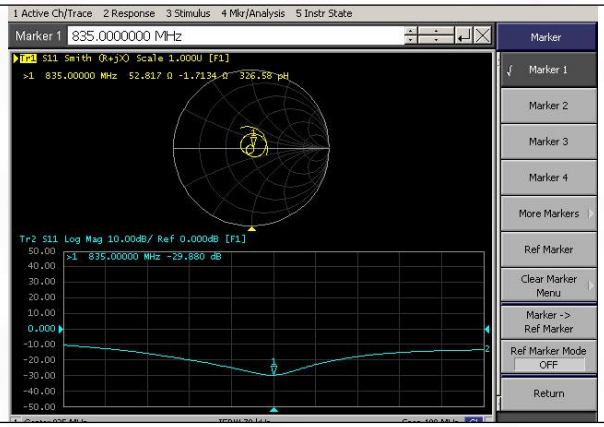
Frequency (MHz)	Return loss(dB)		Impedance(Ω)				error range（%）		Results	Date of Measurement
	measurement	target	measurement		target		Return loss(±20%)	Impedance(±5 Ω)	(P/F)	
			real part	imaginary part	real part	imaginary part				
CW835	-29.88	-26.27	52.8	-1.7	52.5	-4.2	13.74%	2.8	P	2/5/2024
CW1800	-24.55	-26.54	52.4	-0.2	52.8	+3.8	-7.50%	4.4	P	2/5/2024
CW1900	-25.67	-23.01	51.9	-5.3	51.0	-7.0	11.56%	2.6	P	2/5/2024
CW2450	-24.37	-21.23	48.3	5.7	49.4	+8.6	14.79%	4.0	P	2/5/2024
CW2600	-20.56	-23.05	57.3	5.7	54.3	+5.5	-10.80%	3.2	P	2/5/2024
CW5200	-21.14	-20.29	58.4	-4.5	58.76	-4.43	4.19%	0.43	P	2/5/2024
CW5400	-27.63	-29.09	57.5	1.2	53.46	+0.61	-5.02%	4.63	P	2/5/2024
CW5600	-33.45	-31.06	51.7	0.7	52.76	-0.45	7.69%	2.21	P	2/5/2024
CW5800	-28.88	-28.48	50.8	0.1	50.12	-3.76	1.40%	4.34	P	2/5/2024

Dipole calibration report data	Self-examination data

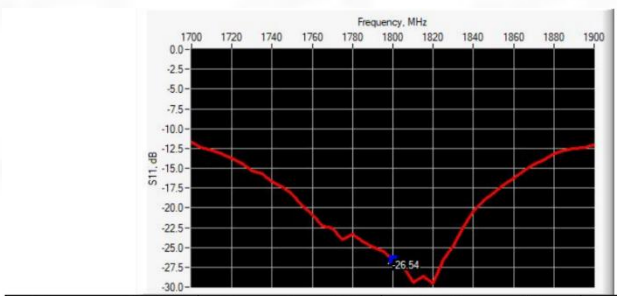
835MHz Dipole



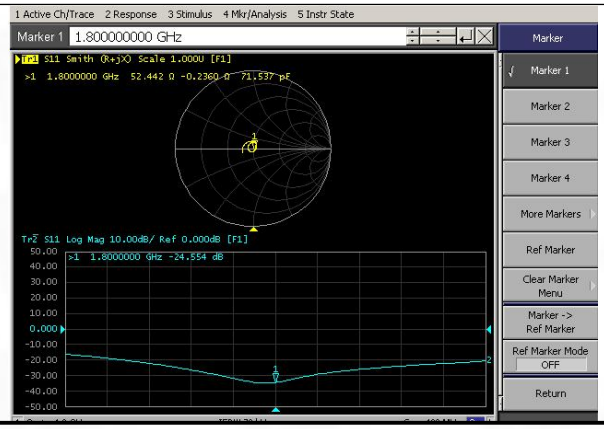
Frequency (MHz)	Return Loss (dB)	Requirement (dB)	Impedance
835	-26.27	-20	52.5 Ω - 4.2 jΩ



1800MHz Dipole



Frequency (MHz)	Return Loss (dB)	Requirement (dB)	Impedance
1800	-26.54	-20	52.8 Ω + 3.8 jΩ



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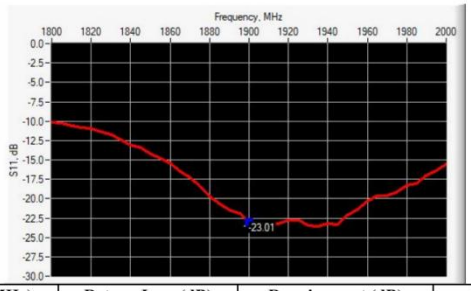
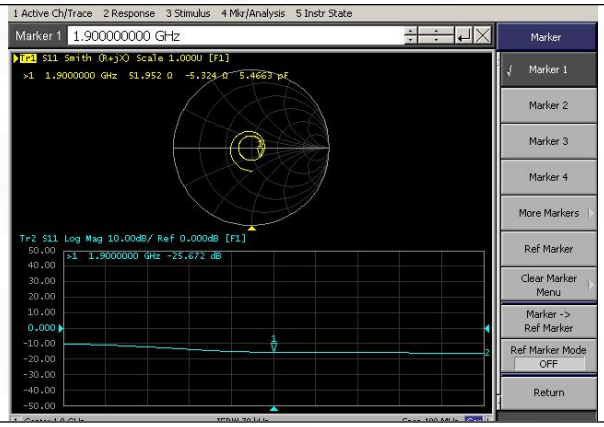
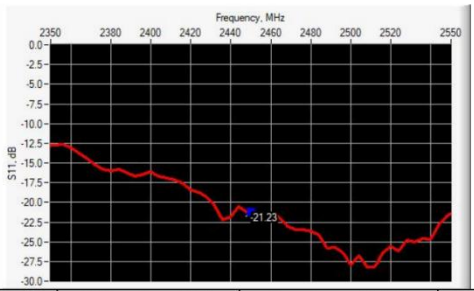
1900MHz Dipole

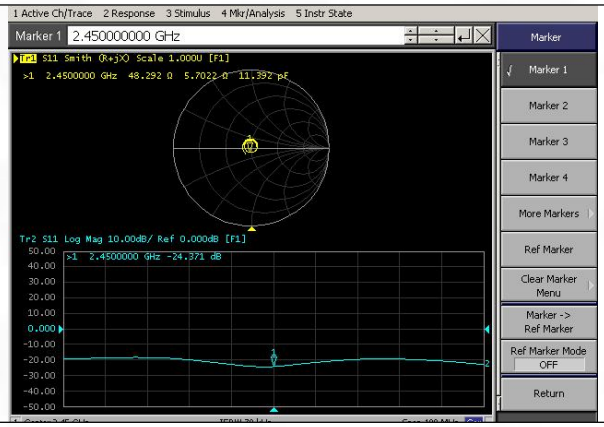




Frequency (MHz)	Return Loss (dB)	Requirement (dB)	Impedance
1900	-23.01	-20	51.0 Ω - 7.0 jΩ

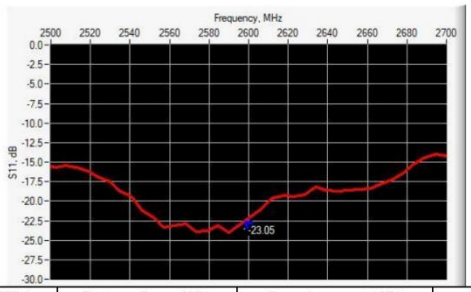
2450MHz Dipole

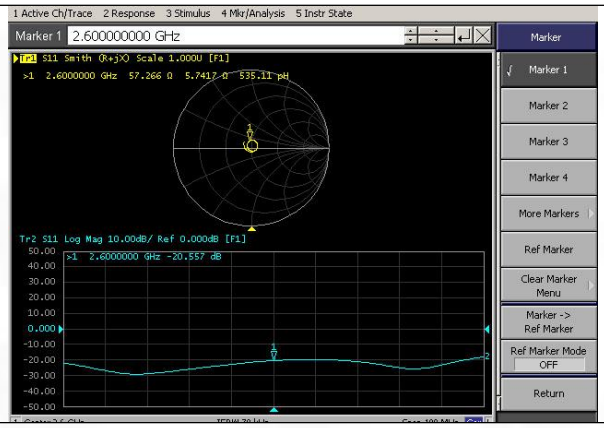




Frequency (MHz)	Return Loss (dB)	Requirement (dB)	Impedance
2450	-21.23	-20	49.4 Ω + 8.6 jΩ

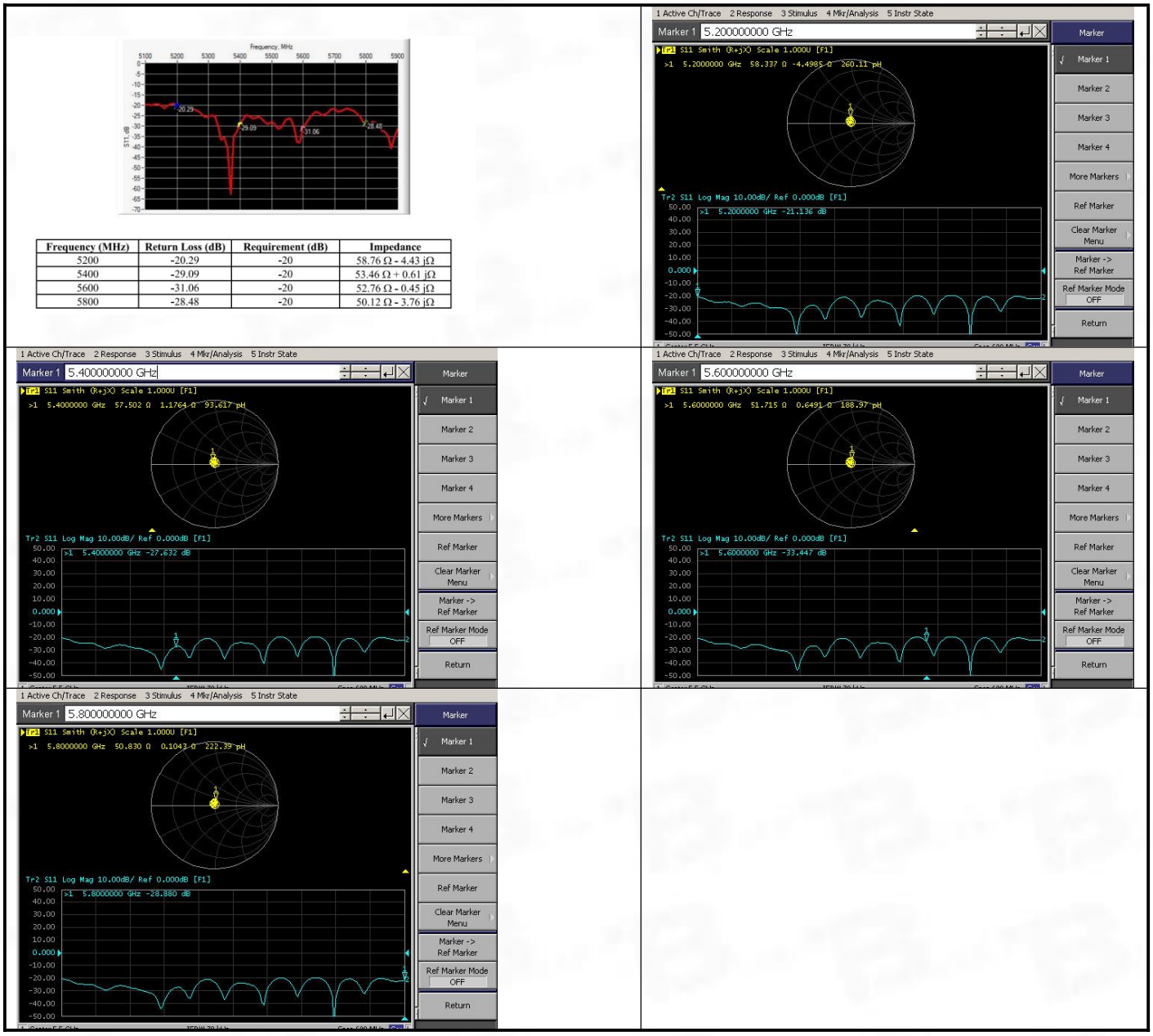
2600MHz Dipole





Frequency (MHz)	Return Loss (dB)	Requirement (dB)	Impedance
2600	-23.05	-20	54.3 Ω + 5.5 jΩ

5000MHz Dipole



Frequency (MHz)	Return Loss (dB)	Requirement (dB)	Impedance
5200	-20.29	-20	58.76 Ω - 4.43 jΩ
5400	-29.09	-20	53.46 Ω + 0.61 jΩ
5600	-31.06	-20	52.76 Ω - 0.45 jΩ
5800	-28.48	-20	50.12 Ω - 3.76 jΩ

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System Performance Check Data (835 MHz)

System check at 835 MHz

Date of measurement: 18/6/2024

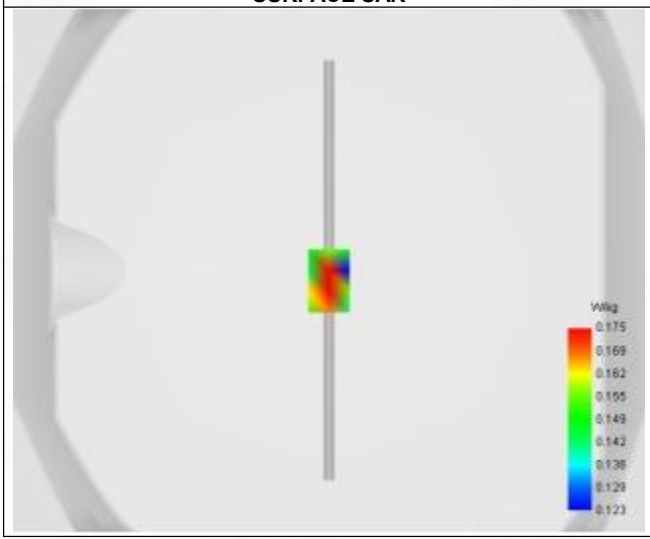
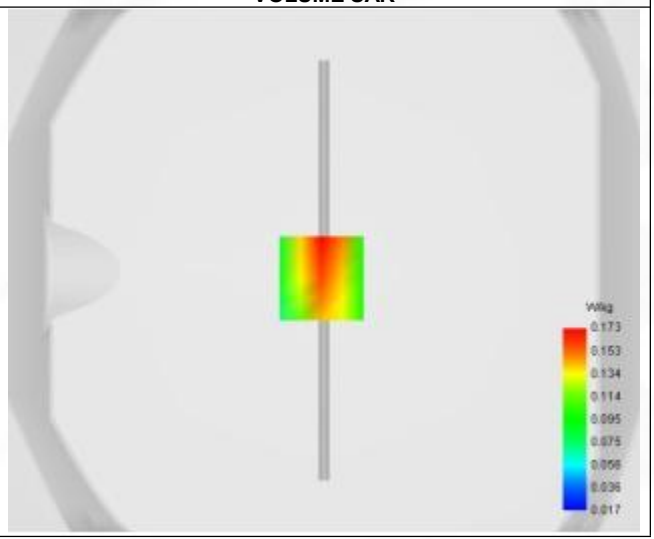
A. Experimental conditions.

Probe	SN 04/22 EPGO365
ConvF	1.68
Area Scan	dx=8mm dy=8mm, Adaptative 1 max
Zoom Scan	5x5x7,dx=8mm dy=8mm dz=5mm,Complete
Phantom	Validation plane
Device Position	Dipole
Band	CW835
Channels	Middle
Signal	CW

B. Permitivity

Frequency (MHz)	835.000
Relative permitivity (real part)	41.410
Relative permitivity (imaginary part)	19.490
Conductivity (S/m)	0.870

C. SAR Surface and Volume

SURFACE SAR	VOLUME SAR
	

Maximum location: X=-1.00, Y=-3.00 ; SAR Peak: 0.26 W/kg

D. SAR 1g & 10g

SAR 10g (W/Kg)	0.106
SAR 1g (W/Kg)	0.163
Variation (%)	-3.390
Horizontal validation criteria: minimum distance (mm)	8.487
Vertical validation criteria: SAR ratio M2/M1 (%)	66.47%

E. Z Axis Scan

Z (mm)	0.00	4.00	9.00	14.00	19.00
SAR (W/Kg)	0.059	0.173	0.115	0.061	0.072

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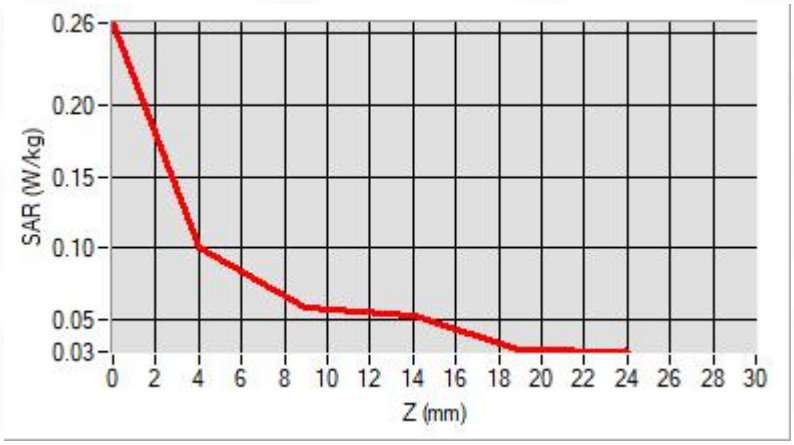
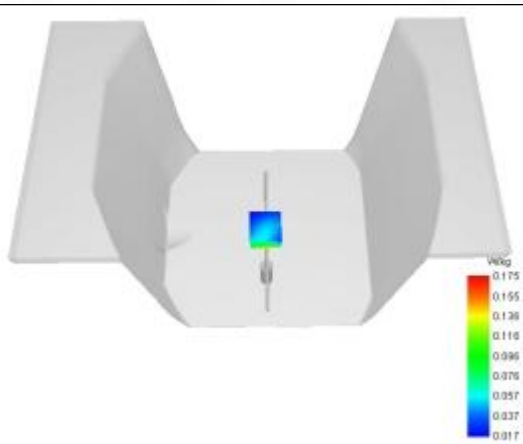
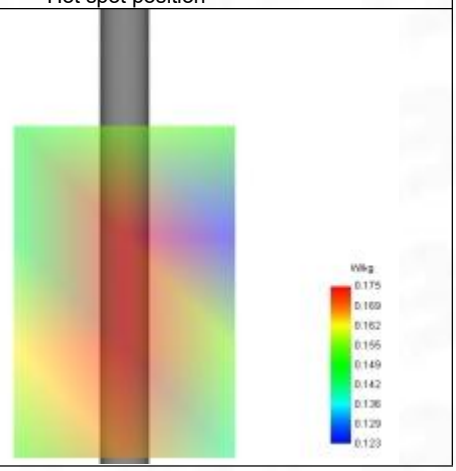


F. 3D Image

3D screen shot	Hot spot position
	

System Performance Check Data (1800 MHz)

System check at 1800 MHz

Date of measurement: 20/6/2024

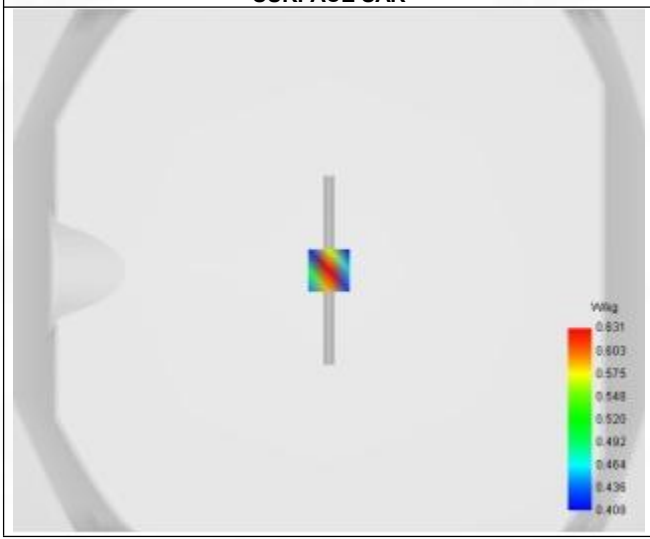
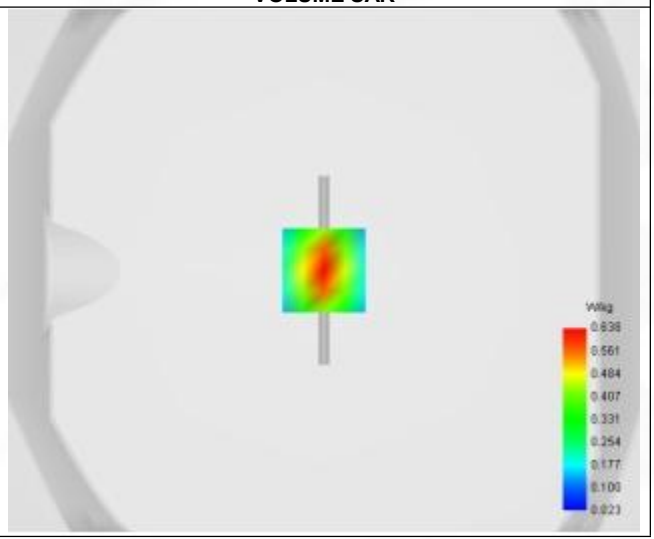
A. Experimental conditions.

Probe	SN 04/22 EPGO365
ConvF	1.96
Area Scan	dx=8mm dy=8mm, Adaptative 1 max
Zoom Scan	5x5x7,dx=8mm dy=8mm dz=5mm,Complete
Phantom	Validation plane
Device Position	Dipole
Band	CW1800
Channels	Middle
Signal	CW

B. Permitivity

Frequency (MHz)	1800.000
Relative permitivity (real part)	39.910
Relative permitivity (imaginary part)	14.090
Conductivity (S/m)	1.370

C. SAR Surface and Volume

SURFACE SAR	VOLUME SAR
	

Maximum location: X=0.00, Y=0.00 ; SAR Peak: 1.00 W/kg

D. SAR 1g & 10g

SAR 10g (W/Kg)	0.312
SAR 1g (W/Kg)	0.588
Variation (%)	-0.250
Horizontal validation criteria: minimum distance (mm)	8.698
Vertical validation criteria: SAR ratio M2/M1 (%)	55.80%

E. Z Axis Scan

Z (mm)	0.00	4.00	9.00	14.00	19.00
SAR (W/Kg)	1.003	0.638	0.356	0.204	0.127

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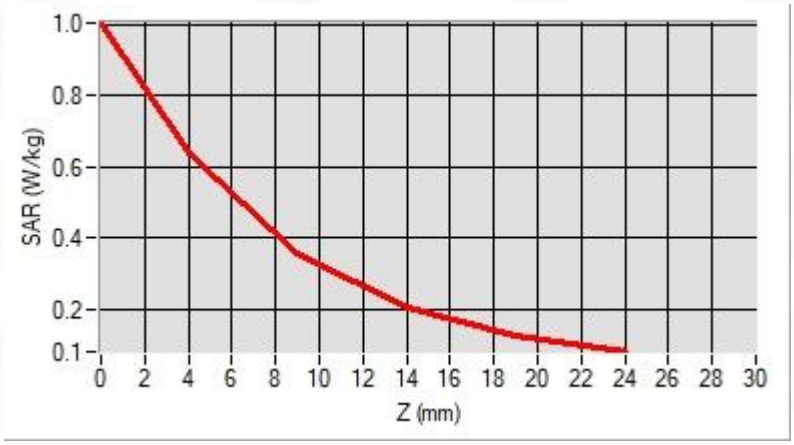
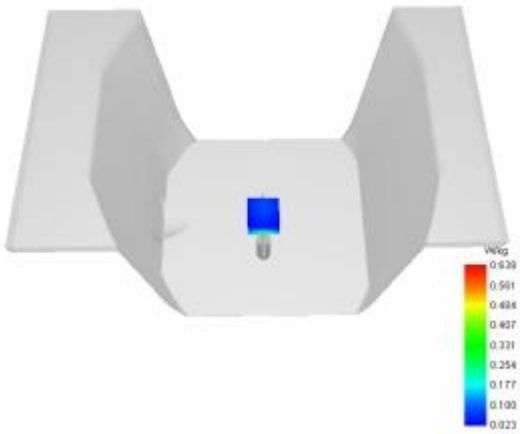
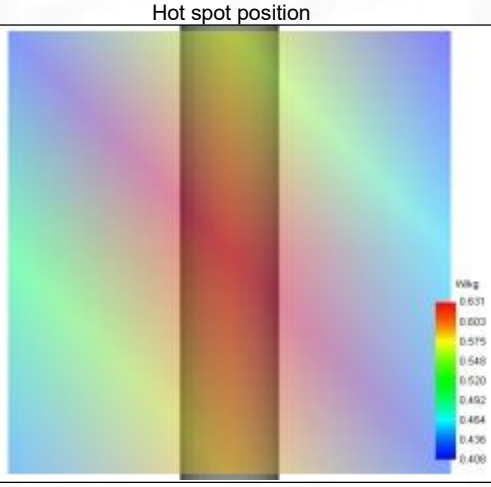


F. 3D Image

3D screen shot	Hot spot position
	

System Performance Check Data (1900 MHz)

System check at 1900 MHz

Date of measurement: 21/6/2024

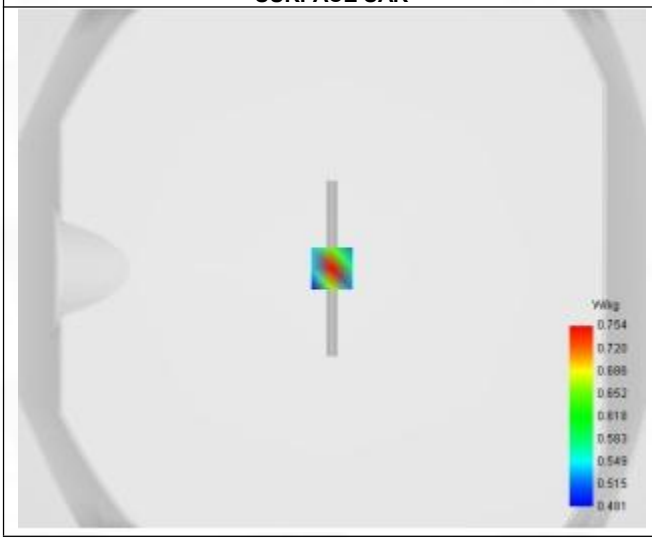
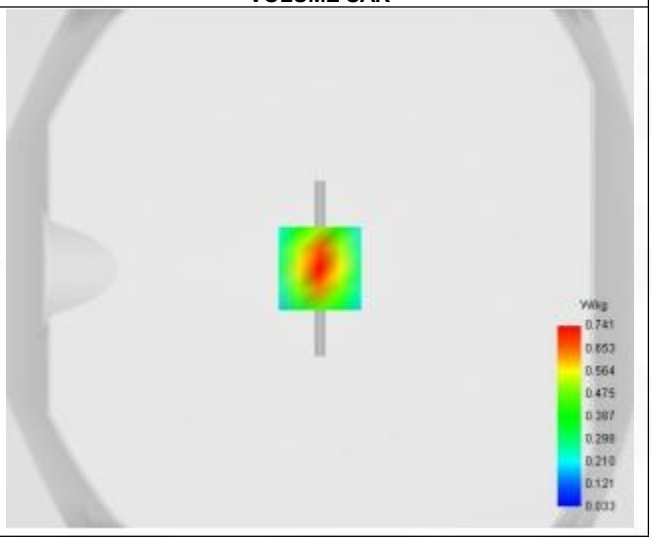
A. Experimental conditions.

Probe	SN 04/22 EPGO365
ConvF	2.24
Area Scan	dx=8mm dy=8mm, Adaptative 1 max
Zoom Scan	5x5x7,dx=8mm dy=8mm dz=5mm,Complete
Phantom	Validation plane
Device Position	Dipole
Band	CW1900
Channels	Middle
Signal	CW

B. Permitivity

Frequency (MHz)	1900.000
Relative permitivity (real part)	39.880
Relative permitivity (imaginary part)	13.380
Conductivity (S/m)	1.410

C. SAR Surface and Volume

SURFACE SAR	VOLUME SAR
	

Maximum location: X=0.00, Y=0.00 ; SAR Peak: 1.18 W/kg

D. SAR 1g & 10g

SAR 10g (W/Kg)	0.322
SAR 1g (W/Kg)	0.630
Variation (%)	-2.080
Horizontal validation criteria: minimum distance (mm)	8.699
Vertical validation criteria: SAR ratio M2/M1 (%)	52.96%

E. Z Axis Scan

Z (mm)	0.00	4.00	9.00	14.00	19.00
SAR (W/Kg)	1.201	0.759	0.402	0.239	0.156

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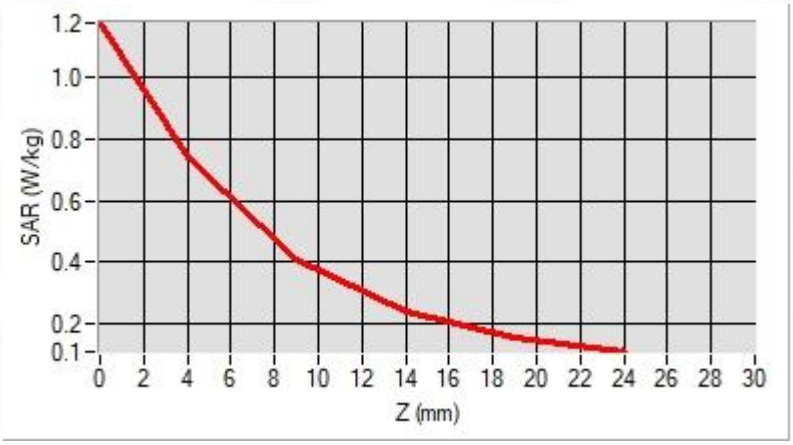
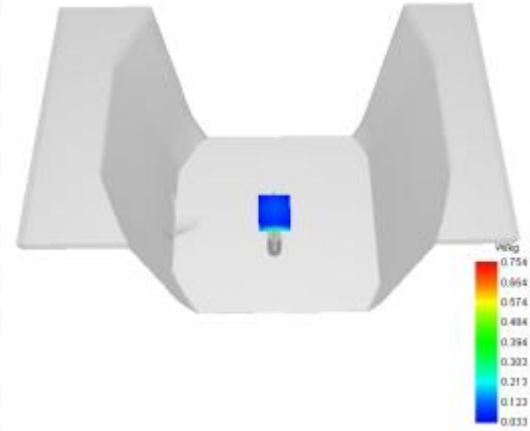
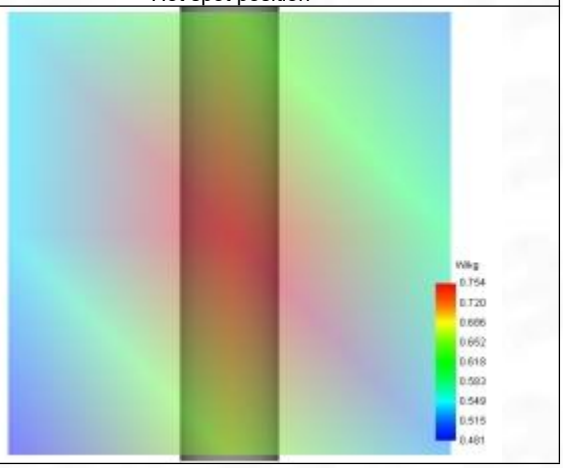


F. 3D Image

3D screen shot	Hot spot position
	

System Performance Check Data (2450 MHz)

System check at 2450 MHz

Date of measurement: 24/6/2024

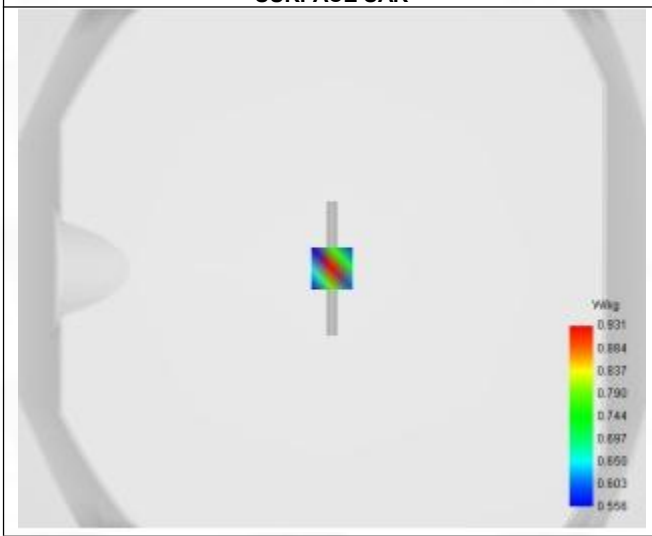
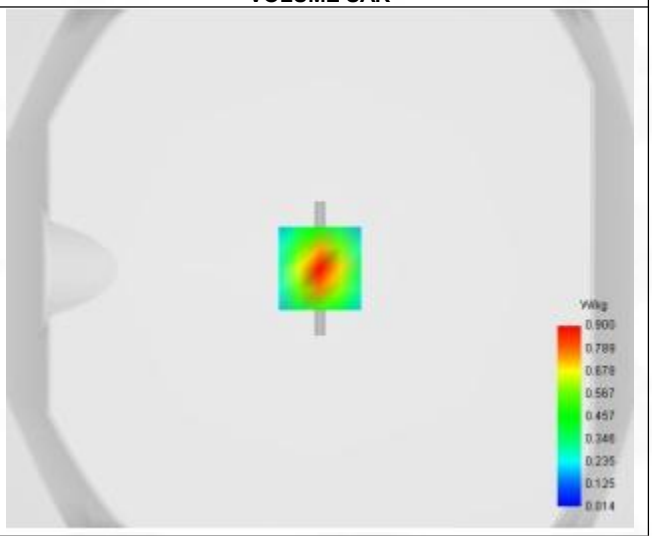
A. Experimental conditions.

Probe	SN 04/22 EPGO365
ConvF	2.36
Area Scan	dx=8mm dy=8mm, Adaptative 1 max
Zoom Scan	5x5x7,dx=5mm dy=5mm dz=5mm,Complete
Phantom	Validation plane
Device Position	Dipole
Band	CW2450
Channels	Middle
Signal	CW

B. Permitivity

Frequency (MHz)	2450.000
Relative permitivity (real part)	39.080
Relative permitivity (imaginary part)	13.340
Conductivity (S/m)	1.810

C. SAR Surface and Volume

SURFACE SAR	VOLUME SAR
	

Maximum location: X=0.00, Y=0.00 ; SAR Peak: 1.47 W/kg

D. SAR 1g & 10g

SAR 10g (W/Kg)	0.352
SAR 1g (W/Kg)	0.793
Variation (%)	-2.570
Horizontal validation criteria: minimum distance (mm)	9.787
Vertical validation criteria: SAR ratio M2/M1 (%)	53.00%

E. Z Axis Scan

Z (mm)	0.00	4.00	9.00	14.00	19.00
SAR (W/Kg)	1.466	0.900	0.477	0.261	0.158

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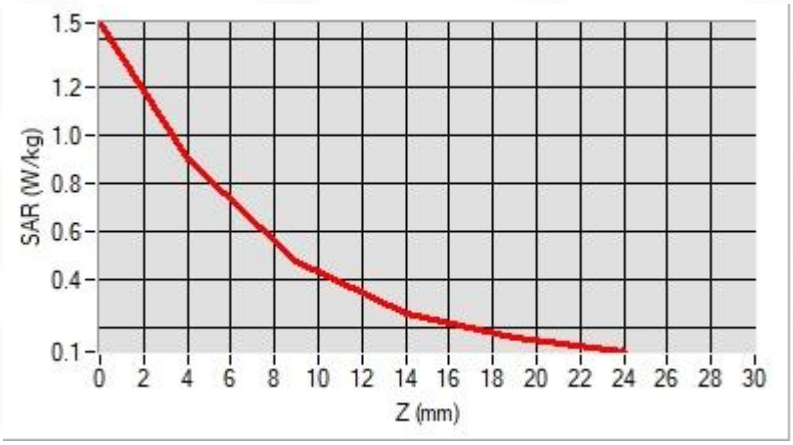
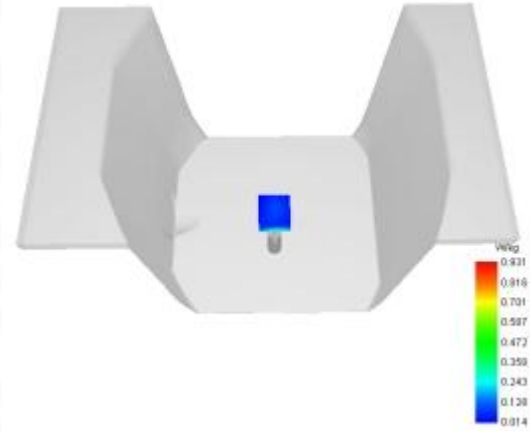
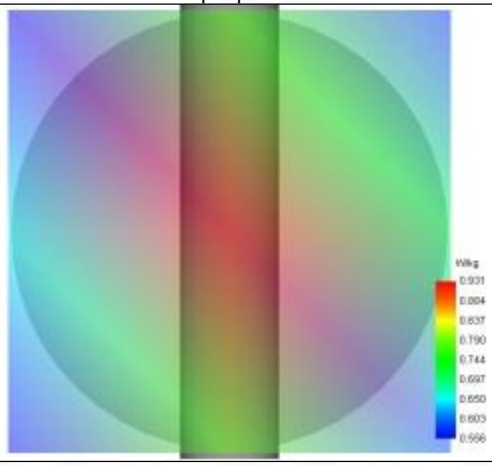


F. 3D Image

3D screen shot	Hot spot position
	

System Performance Check Data (2600 MHz)

System check at 2600 MHz

Date of measurement: 25/6/2024

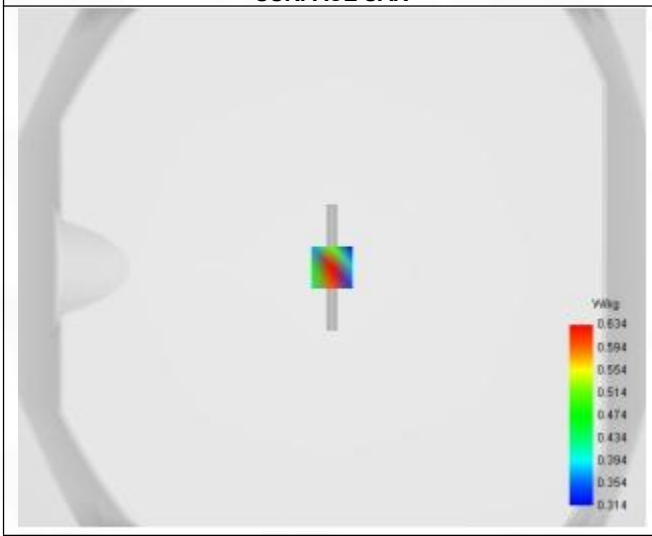
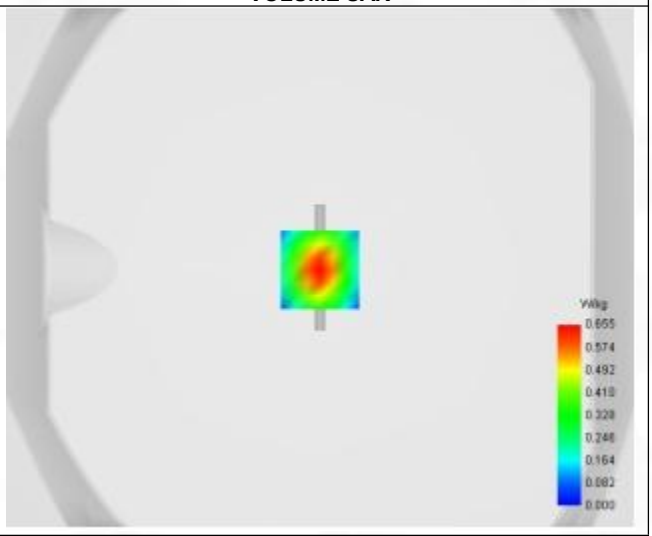
A. Experimental conditions.

Probe	SN 04/22 EPGO365
ConvF	2.40
Area Scan	dx=8mm dy=8mm, Adaptative 1 max
Zoom Scan	5x5x7,dx=5mm dy=5mm dz=5mm,Complete
Phantom	Validation plane
Device Position	Dipole
Band	CW2600
Channels	Middle
Signal	CW

B. Permitivity

Frequency (MHz)	2600.000
Relative permitivity (real part)	38.880
Relative permitivity (imaginary part)	12.690
Conductivity (S/m)	1.970

C. SAR Surface and Volume

SURFACE SAR	VOLUME SAR
	

Maximum location: X=0.00, Y=-1.00 ; SAR Peak: 1.02 W/kg

D. SAR 1g & 10g

SAR 10g (W/Kg)	0.421
SAR 1g (W/Kg)	0.866
Variation (%)	2.980
Horizontal validation criteria: minimum distance (mm)	9.362
Vertical validation criteria: SAR ratio M2/M1 (%)	54.81%

E. Z Axis Scan

Z (mm)	0.00	4.00	9.00	14.00	19.00
SAR (W/Kg)	1.020	0.655	0.359	0.187	0.091

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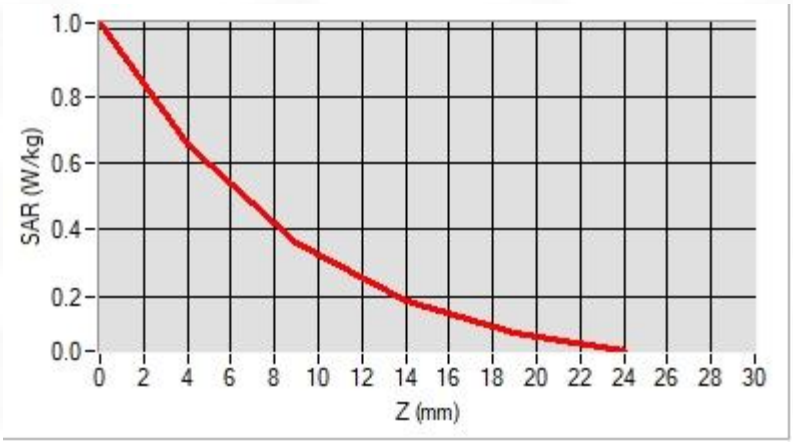
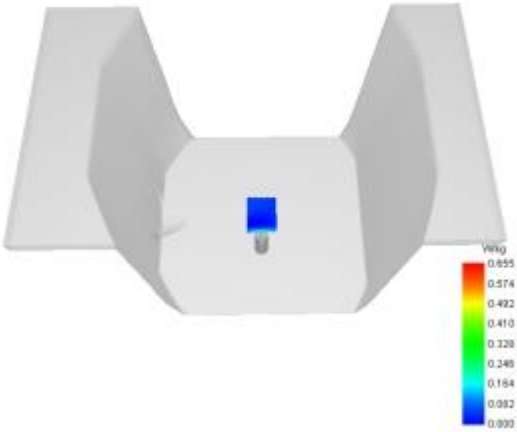
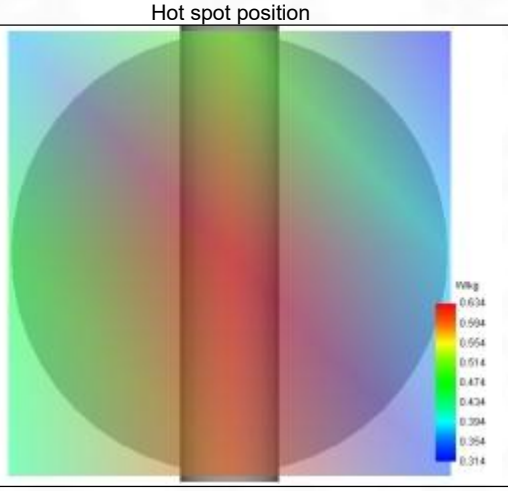


F. 3D Image

3D screen shot	Hot spot position
	

System Performance Check Data (5200 MHz)

System check at 5200 MHz

Date of measurement: 26/6/2024

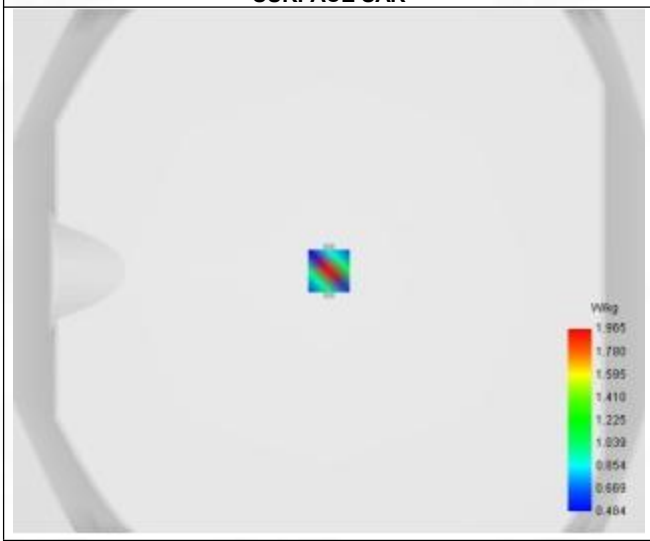
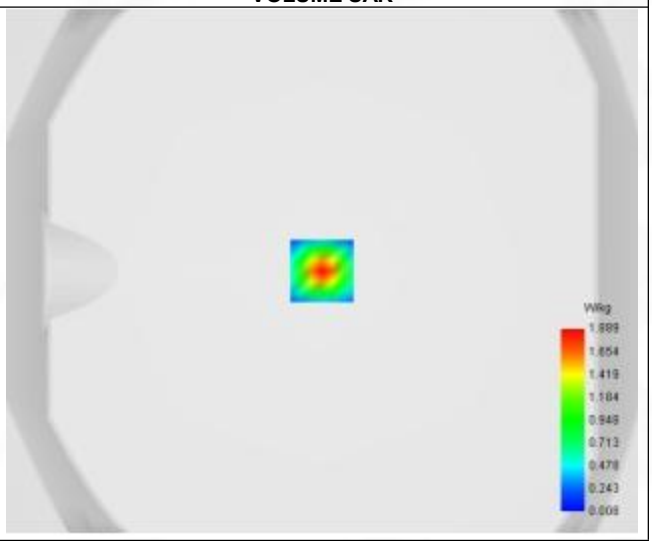
A. Experimental conditions.

Probe	SN 04/22 EPGO365
ConvF	2.24
Area Scan	dx=8mm dy=8mm, Adaptative 1 max
Zoom Scan	7x7x12,dx=4mm dy=4mm dz=2mm,Complete
Phantom	Validation plane
Device Position	Dipole
Band	CW5200
Channels	Middle
Signal	CW

B. Permitivity

Frequency (MHz)	5200.000
Relative permitivity (real part)	35.880
Relative permitivity (imaginary part)	16.250
Conductivity (S/m)	4.700

C. SAR Surface and Volume

SURFACE SAR	VOLUME SAR
	

Maximum location: X=0.00, Y=0.00 ; SAR Peak: 3.38 W/kg

D. SAR 1g & 10g

SAR 10g (W/Kg)	0.288
SAR 1g (W/Kg)	1.019
Variation (%)	-3.400
Horizontal validation criteria: minimum distance (mm)	6.287
Vertical validation criteria: SAR ratio M2/M1 (%)	54.05%

E. Z Axis Scan

Z (mm)	0.00	2.00	4.00	6.00	8.00	10.00	12.00	14.00	16.00
SAR (W/Kg)	3.268	1.889	1.021	0.523	0.266	0.142	0.085	0.060	0.052

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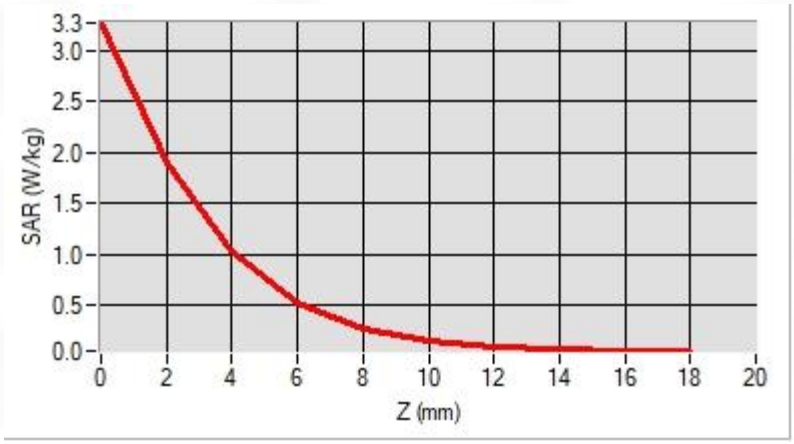
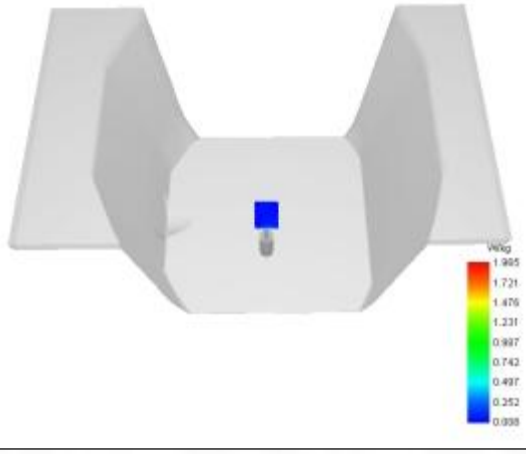
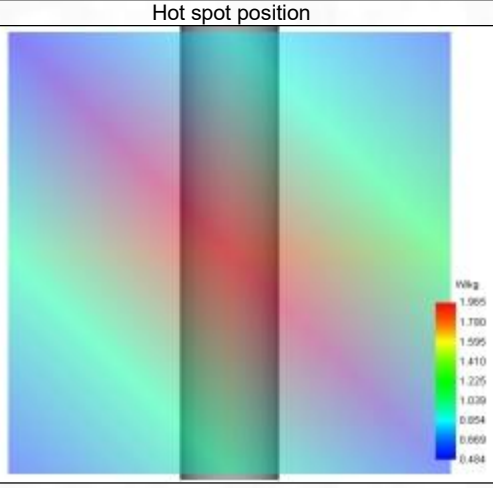


F. 3D Image

3D screen shot	Hot spot position
	

System Performance Check Data (5400 MHz)

System check at 5400 MHz

Date of measurement: 26/6/2024

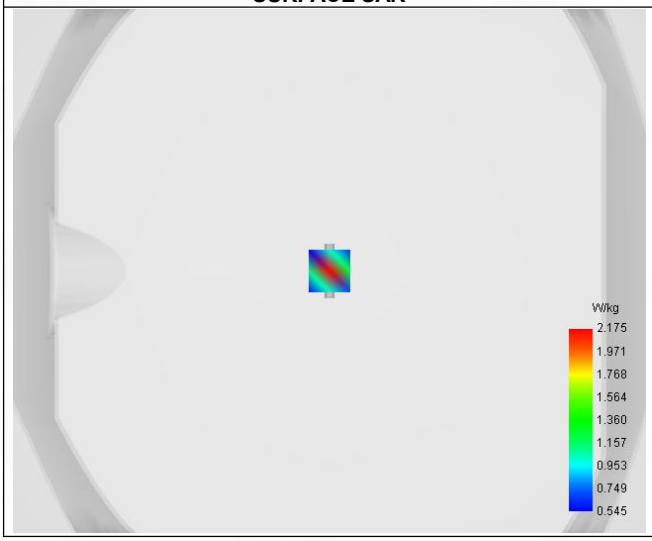
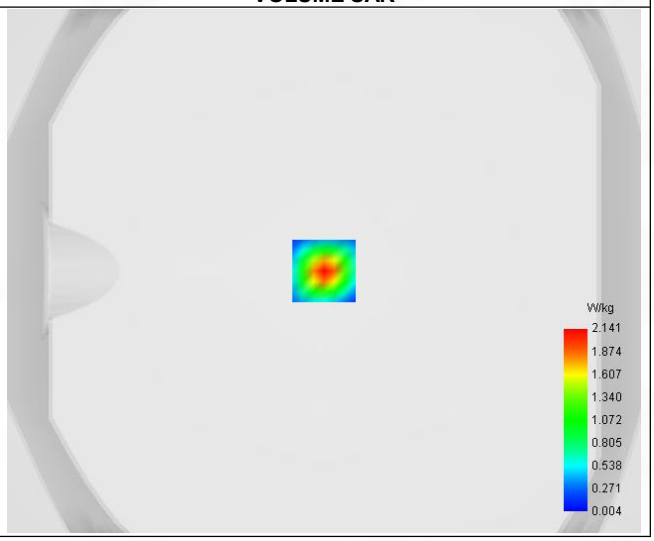
A. Experimental conditions.

Probe	SN 04/22 EPGO365
ConvF	2.12
Area Scan	dx=8mm dy=8mm, Adaptative 1 max
Zoom Scan	7x7x12,dx=4mm dy=4mm dz=2mm,Complete
Phantom	Validation plane
Device Position	Dipole
Band	CW5400
Channels	Middle
Signal	CW

B. Permitivity

Frequency (MHz)	5400.000
Relative permitivity (real part)	35.680
Relative permitivity (imaginary part)	16.320
Conductivity (S/m)	4.900

C. SAR Surface and Volume

SURFACE SAR	VOLUME SAR
	

Maximum location: X=0.00, Y=0.00 ; SAR Peak: 3.78 W/kg

D. SAR 1g & 10g

SAR 10g (W/Kg)	0.299
SAR 1g (W/Kg)	1.051
Variation (%)	-4.610
Horizontal validation criteria: minimum distance (mm)	6.274
Vertical validation criteria: SAR ratio M2/M1 (%)	54.97%

E. Z Axis Scan

Z (mm)	0.00	2.00	4.00	6.00	8.00	10.00	12.00	14.00	16.00
SAR (W/Kg)	3.660	2.141	1.177	0.614	0.317	0.169	0.098	0.065	0.050

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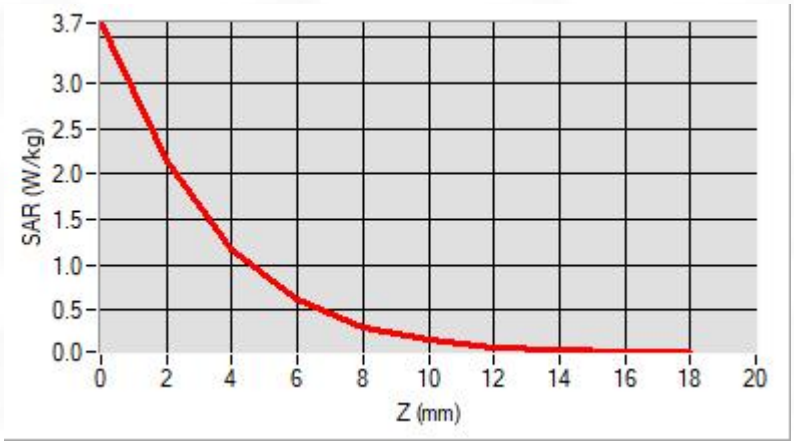
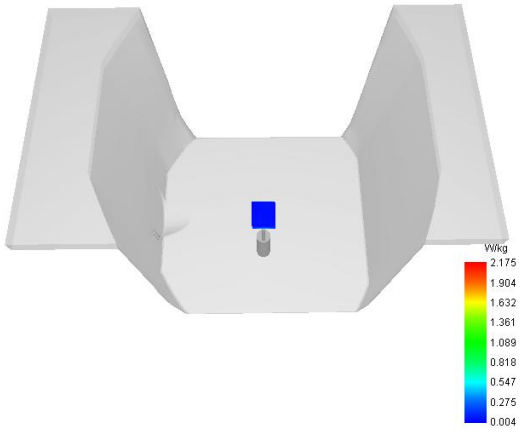
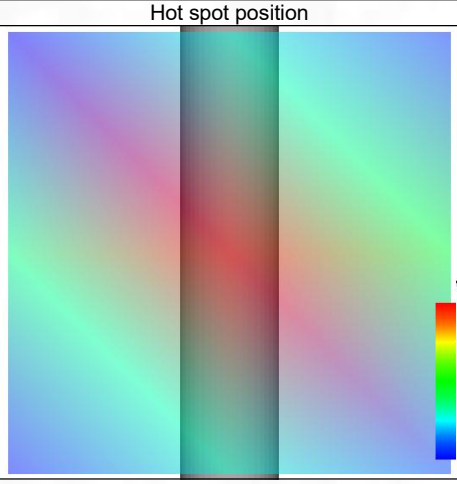


F. 3D Image

3D screen shot	Hot spot position
	

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System Performance Check Data (5600 MHz)

System check at 5600 MHz

Date of measurement: 27/6/2024

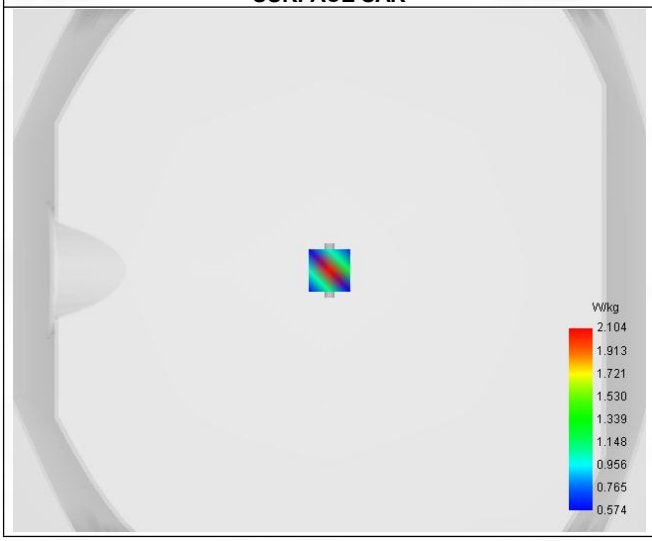
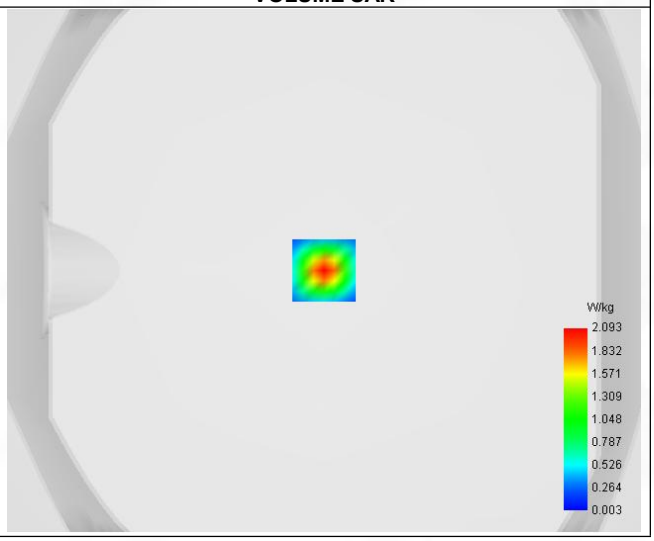
A. Experimental conditions.

Probe	SN 04/22 EPGO365
ConvF	2.18
Area Scan	dx=8mm dy=8mm, Adaptative 1 max
Zoom Scan	7x7x12,dx=4mm dy=4mm dz=2mm,Complete
Phantom	Validation plane
Device Position	Dipole
Band	CW5600
Channels	Middle
Signal	CW

B. Permitivity

Frequency (MHz)	5600.000
Relative permitivity (real part)	35.380
Relative permitivity (imaginary part)	16.420
Conductivity (S/m)	5.110

C. SAR Surface and Volume

SURFACE SAR	VOLUME SAR
	

Maximum location: X=0.00, Y=0.00 ; SAR Peak: 3.90 W/kg

D. SAR 1g & 10g

SAR 10g (W/Kg)	0.304
SAR 1g (W/Kg)	1.084
Variation (%)	-0.190
Horizontal validation criteria: minimum distance (mm)	7.214
Vertical validation criteria: SAR ratio M2/M1 (%)	51.31%

E. Z Axis Scan

Z (mm)	0.00	2.00	4.00	6.00	8.00	10.00	12.00	14.00	16.00
SAR (W/Kg)	3.748	2.093	1.074	0.514	0.243	0.122	0.072	0.056	0.056

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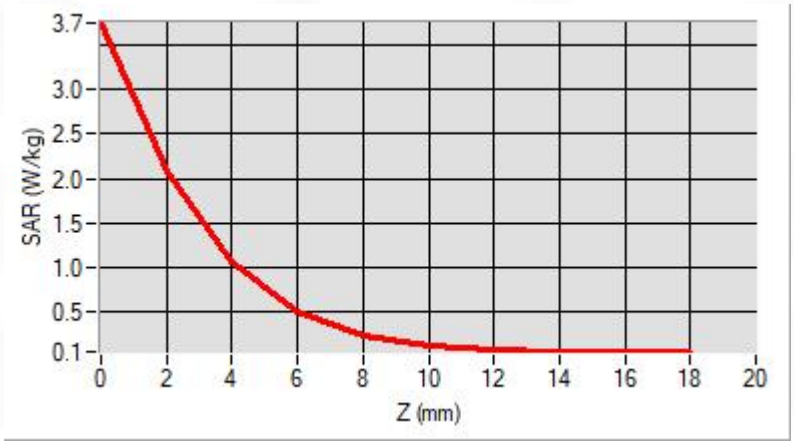
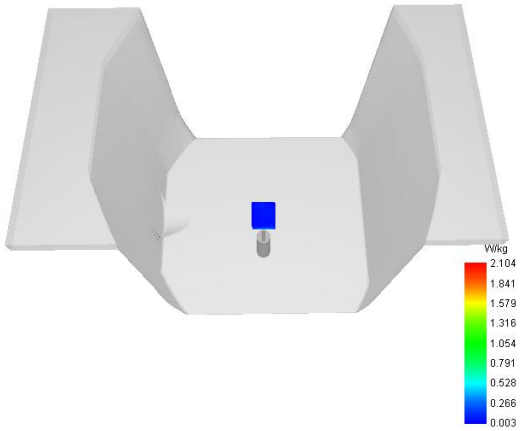
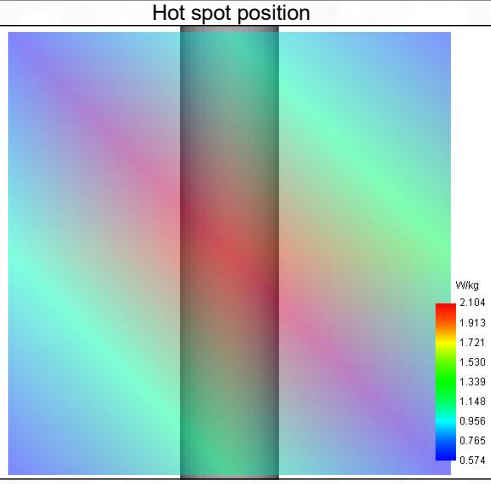


F. 3D Image

3D screen shot	Hot spot position
	

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System Performance Check Data (5800 MHz)

System check at 5800 MHz

Date of measurement: 27/6/2024

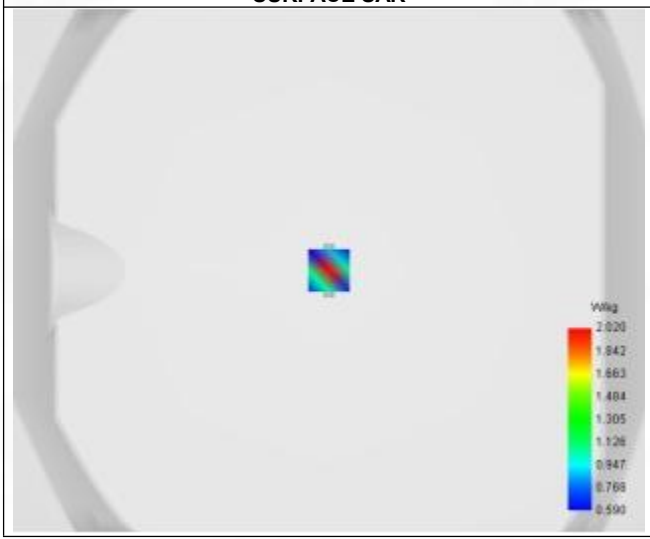
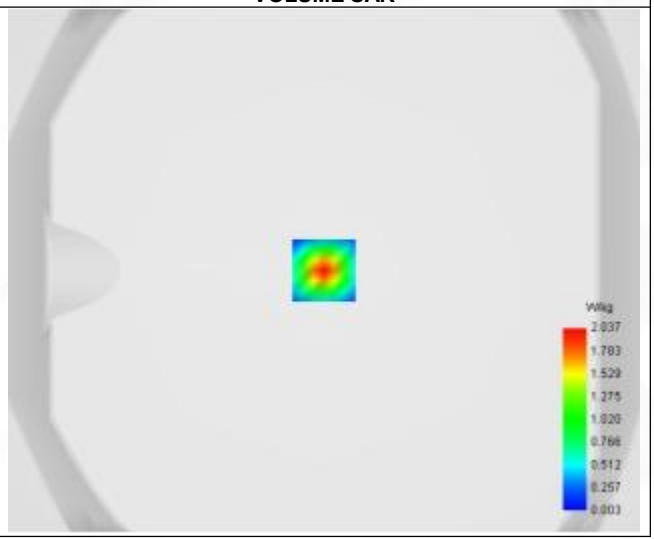
A. Experimental conditions.

Probe	SN 04/22 EPGO365
ConvF	2.04
Area Scan	dx=8mm dy=8mm, Adaptative 1 max
Zoom Scan	7x7x12,dx=4mm dy=4mm dz=2mm,Complete
Phantom	Validation plane
Device Position	Dipole
Band	CW5800
Channels	Middle
Signal	CW

B. Permitivity

Frequency (MHz)	5800.000
Relative permitivity (real part)	35.180
Relative permitivity (imaginary part)	16.480
Conductivity (S/m)	5.310

C. SAR Surface and Volume

SURFACE SAR	VOLUME SAR
	

Maximum location: X=0.00, Y=0.00 ; SAR Peak: 4.17 W/kg

D. SAR 1g & 10g

SAR 10g (W/Kg)	0.277
SAR 1g (W/Kg)	0.981
Variation (%)	0.490
Horizontal validation criteria: minimum distance (mm)	7.145
Vertical validation criteria: SAR ratio M2/M1 (%)	44.92%

E. Z Axis Scan

Z (mm)	0.00	2.00	4.00	6.00	8.00	10.00	12.00	14.00	16.00
SAR (W/Kg)	3.948	2.037	0.915	0.361	0.135	0.055	0.033	0.037	0.059

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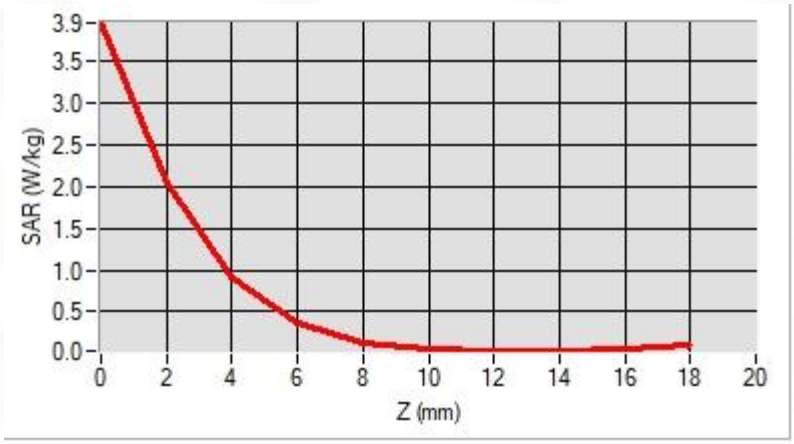
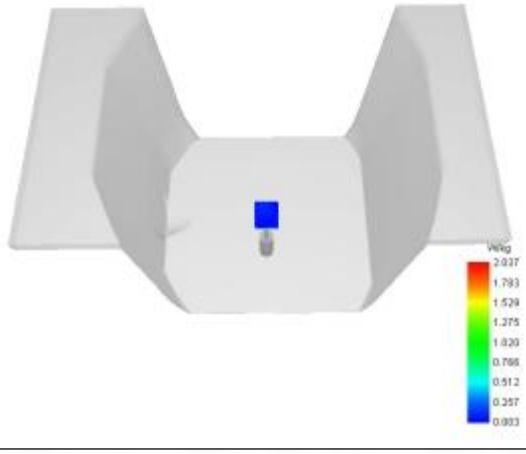
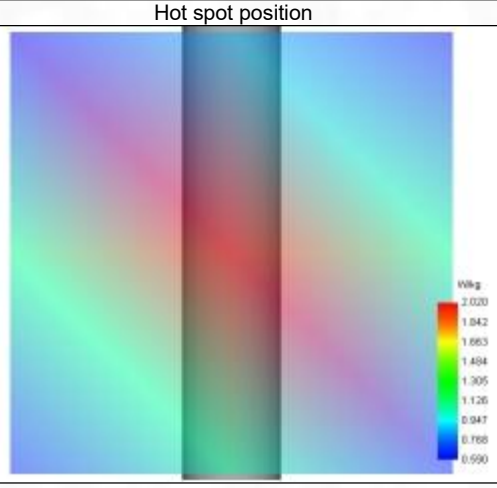


F. 3D Image

3D screen shot	Hot spot position
	

ANNEX C Test Data

1-Head with front position in dist. 0mm on Channel 251 in GSM850 voice

SAR Measurement at GSM850 (Cheek, Right)

Date of measurement: 18/6/2024

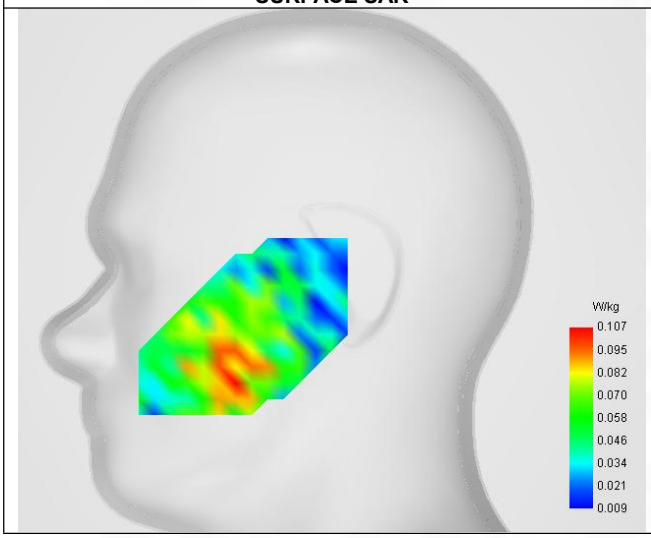
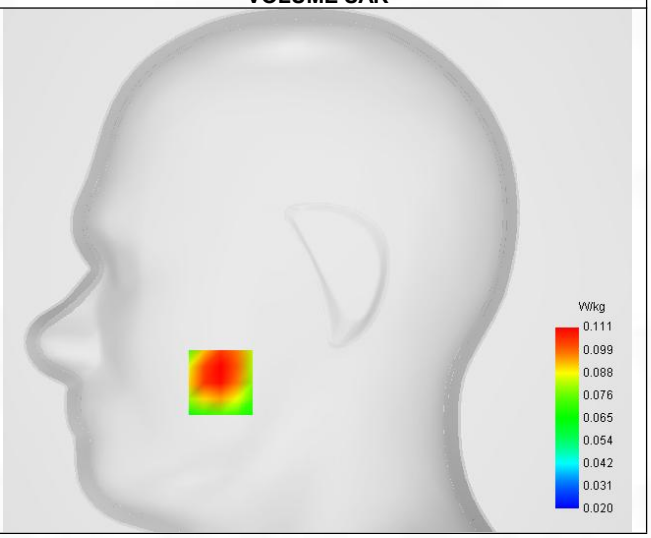
A. Experimental conditions.

Probe	SN 04/22 EPGO365
ConvF	1.68
Area Scan	dx=8mm dy=8mm, Adaptative 1 max
Zoom Scan	5x5x7,dx=8mm dy=8mm dz=5mm,Complete
Phantom	Right head
Device Position	Cheek
Band	GSM850
Channels	Higher (251)
Signal	TDMA (GSM)
Modulation	GMSK

B. Permitivity

Frequency (MHz)	848.800
Relative permitivity (real part)	41.389
Relative permitivity (imaginary part)	19.413
Conductivity (S/m)	0.877

C. SAR Surface and Volume

SURFACE SAR	VOLUME SAR
	

Maximum location: X=-48.00, Y=-56.00 ; SAR Peak: 0.16 W/kg

D. SAR 1g & 10g

SAR 10g (W/Kg)	0.079
SAR 1g (W/Kg)	0.109
Variation (%)	2.960
Horizontal validation criteria: minimum distance (mm)	8.956
Vertical validation criteria: SAR ratio M2/M1 (%)	61.26%

E. Z Axis Scan

Z (mm)	0.00	4.00	9.00	14.00	19.00
SAR (W/Kg)	0.235	0.111	0.068	0.063	0.053

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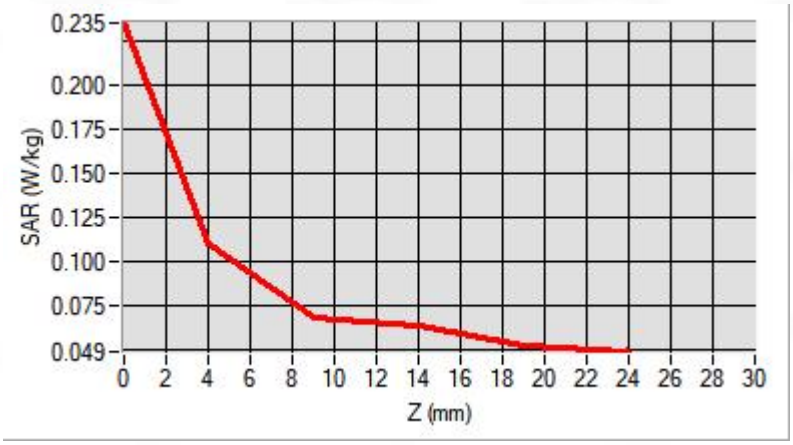
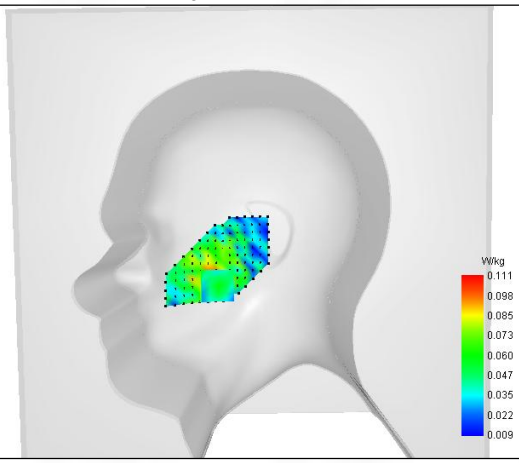
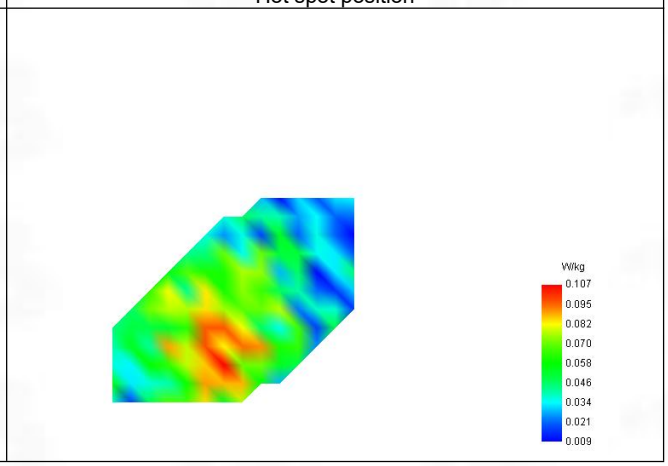


F. 3D Image

3D screen shot	Hot spot position
	

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2-Body with back position in dist. 10mm on Channel 128 in GPRS850+2slots

SAR Measurement at GPRS850 (Body, Validation Plane)

Date of measurement: 18/6/2024

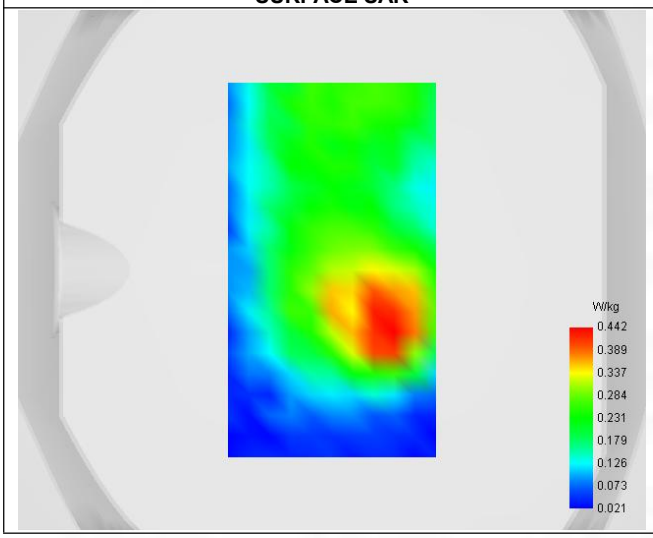
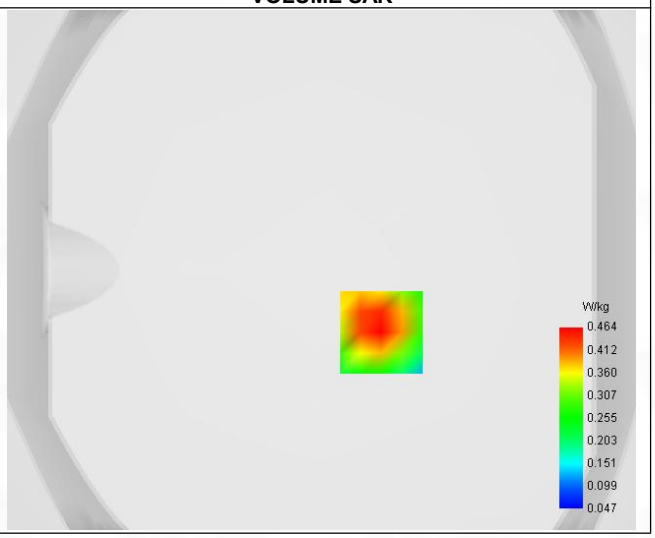
A. Experimental conditions.

Probe	SN 04/22 EPGO365
ConvF	1.68
Area Scan	dx=8mm dy=8mm, Adaptative 1 max
Zoom Scan	5x5x7,dx=8mm dy=8mm dz=5mm,Complete
Phantom	Validation plane
Device Position	Body
Band	GPRS850
Channels	Lower (128)
Signal	TDMA (GPRS)
Modulation	GMSK (CS-1)
TX-slots	2

B. Permitivity

Frequency (MHz)	824.200
Relative permitivity (real part)	41.460
Relative permitivity (imaginary part)	19.740
Conductivity (S/m)	0.869

C. SAR Surface and Volume

SURFACE SAR	VOLUME SAR
	

Maximum location: X=23.00, Y=-24.00 ; SAR Peak: 0.68 W/kg

D. SAR 1g & 10g

SAR 10g (W/Kg)	0.281
SAR 1g (W/Kg)	0.444
Variation (%)	-2.570
Horizontal validation criteria: minimum distance (mm)	9.633
Vertical validation criteria: SAR ratio M2/M1 (%)	62.50%

E. Z Axis Scan

Z (mm)	0.00	4.00	9.00	14.00	19.00
SAR (W/Kg)	0.677	0.464	0.290	0.190	0.134

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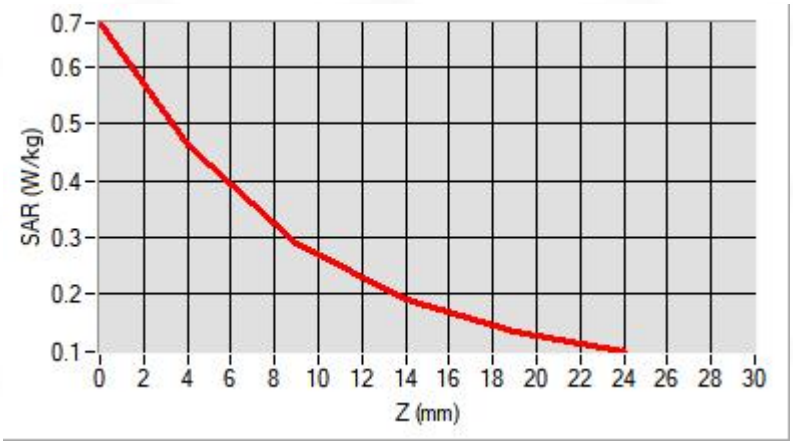
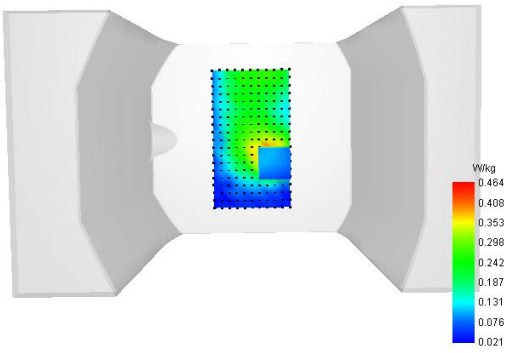
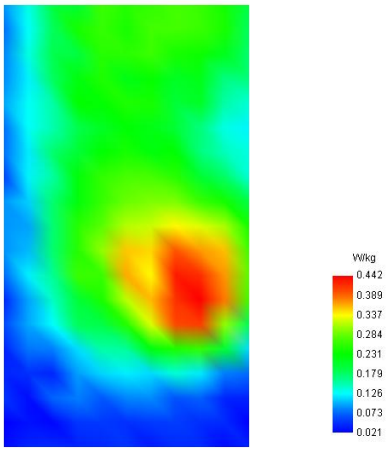


F. 3D Image

3D screen shot	Hot spot position
	

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3-Head with front position in dist. 0mm on Channel 512 in GSM1900 voice

SAR Measurement at GSM1900 (Cheek, Right)

Date of measurement: 20/6/2024

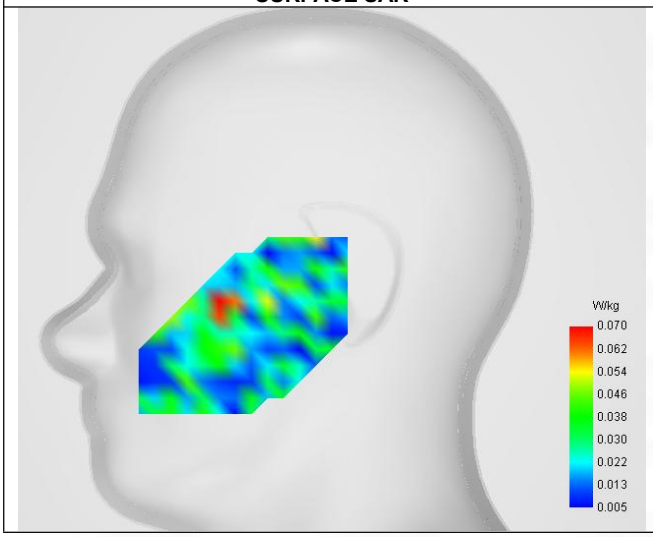
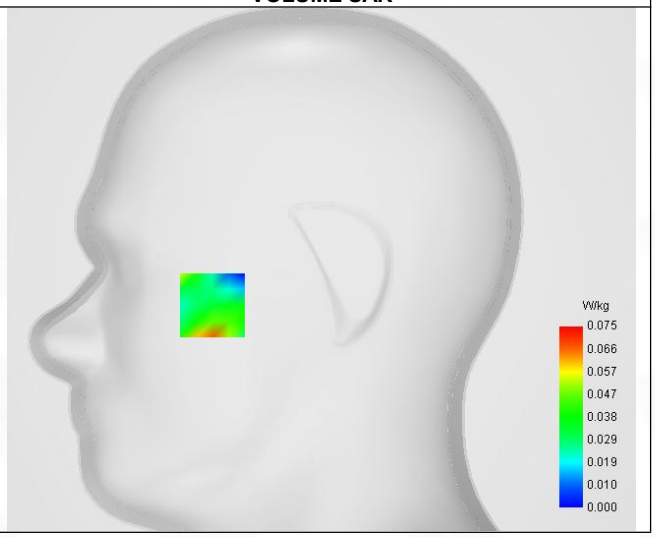
A. Experimental conditions.

Probe	SN 04/22 EPGO365
ConvF	2.07
Area Scan	dx=8mm dy=8mm, Adaptative 1 max
Zoom Scan	5x5x7,dx=8mm dy=8mm dz=5mm,Complete
Phantom	Right head
Device Position	Cheek
Band	GSM1900
Channels	Lower (512)
Signal	TDMA (GSM)
Modulation	GMSK

B. Permitivity

Frequency (MHz)	1850.200
Relative permitivity (real part)	39.895
Relative permitivity (imaginary part)	13.734
Conductivity (S/m)	1.390

C. SAR Surface and Volume

SURFACE SAR	VOLUME SAR
	

Maximum location: X=-54.00, Y=-18.00 ; SAR Peak: 0.12 W/kg

D. SAR 1g & 10g

SAR 10g (W/Kg)	0.038
SAR 1g (W/Kg)	0.055
Variation (%)	2.250
Horizontal validation criteria: minimum distance (mm)	8.798
Vertical validation criteria: SAR ratio M2/M1 (%)	70.15%

E. Z Axis Scan

Z (mm)	0.00	4.00	9.00	14.00	19.00
SAR (W/Kg)	-0.077	0.067	0.047	0.020	0.048

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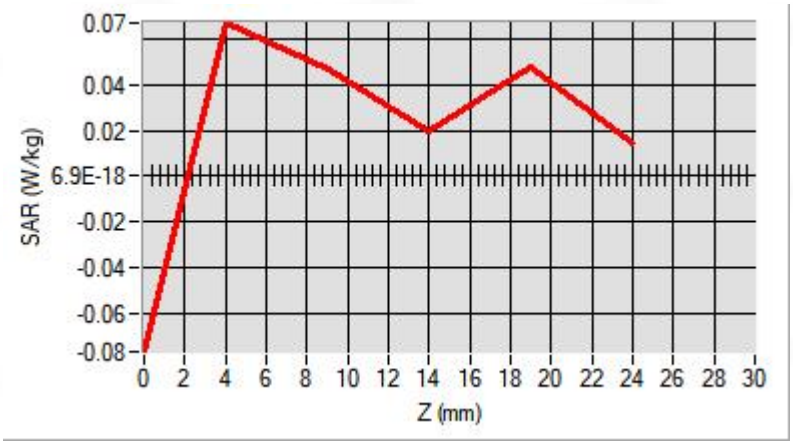
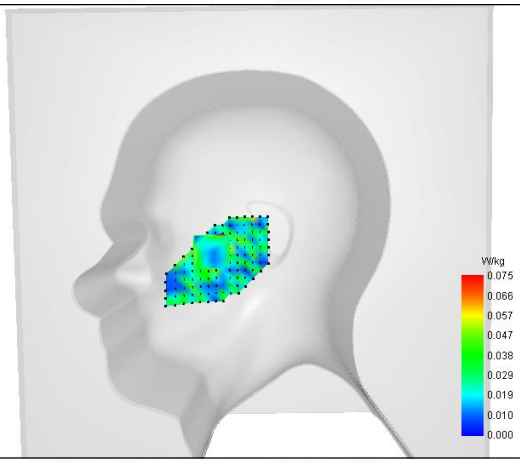
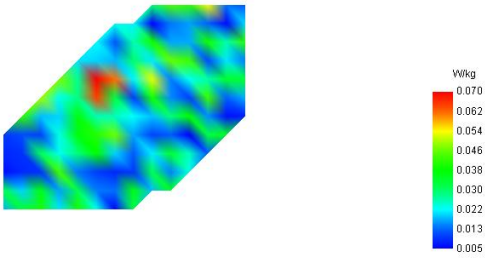


F. 3D Image

3D screen shot	Hot spot position
	

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4-Body with bottom position in dist. 10mm on Channel 512 in GPRS1900+3slots

SAR Measurement at GPRS1900 (Body, Validation Plane)

Date of measurement: 20/6/2024

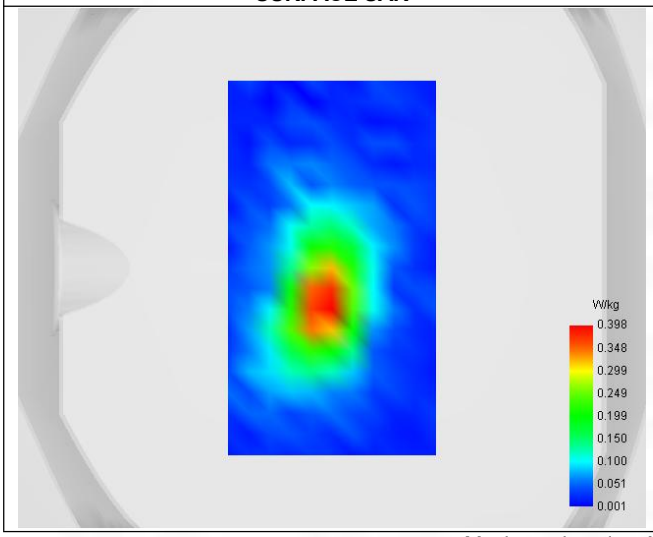
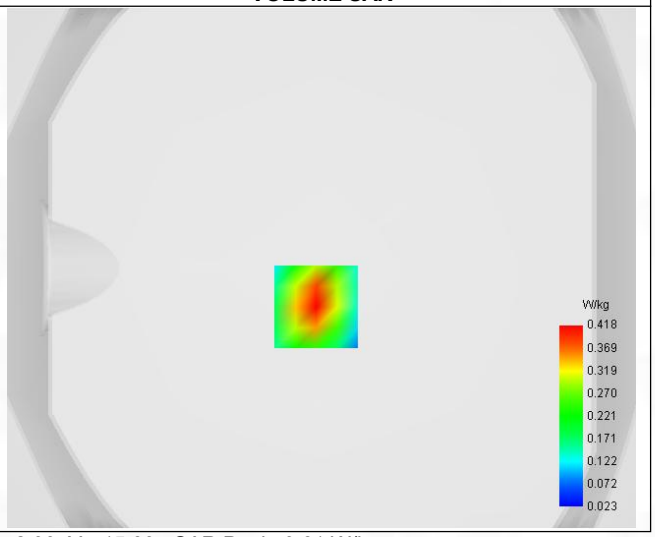
A. Experimental conditions.

Probe	SN 04/22 EPGO365
ConvF	2.07
Area Scan	dx=8mm dy=8mm, Adaptative 1 max
Zoom Scan	5x5x7,dx=8mm dy=8mm dz=5mm,Complete
Phantom	Validation plane
Device Position	Body
Band	GPRS1900
Channels	Lower (512)
Signal	TDMA (GPRS)
Modulation	GMSK (CS-1)
TX-slots	3

B. Permitivity

Frequency (MHz)	1850.200
Relative permitivity (real part)	39.895
Relative permitivity (imaginary part)	13.734
Conductivity (S/m)	1.390

C. SAR Surface and Volume

SURFACE SAR	VOLUME SAR
	

Maximum location: X=-2.00, Y=-15.00 ; SAR Peak: 0.61 W/kg

D. SAR 1g & 10g

SAR 10g (W/Kg)	0.221
SAR 1g (W/Kg)	0.390
Variation (%)	-3.090
Horizontal validation criteria: minimum distance (mm)	8.744
Vertical validation criteria: SAR ratio M2/M1 (%)	63.16%

E. Z Axis Scan

Z (mm)	0.00	4.00	9.00	14.00	19.00
SAR (W/Kg)	0.601	0.418	0.264	0.169	0.112

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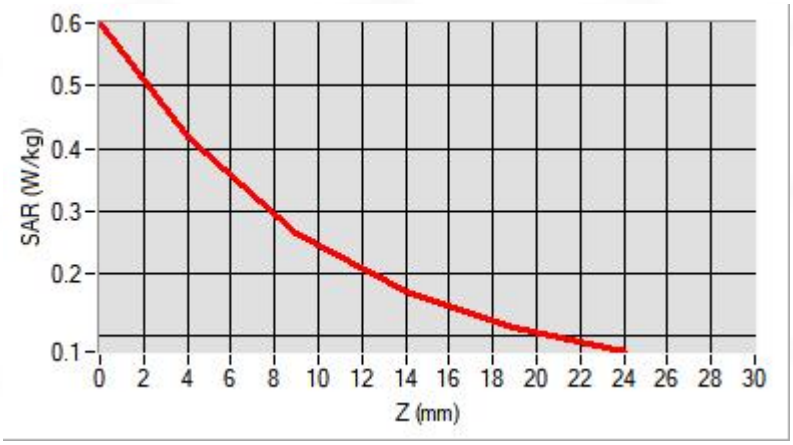
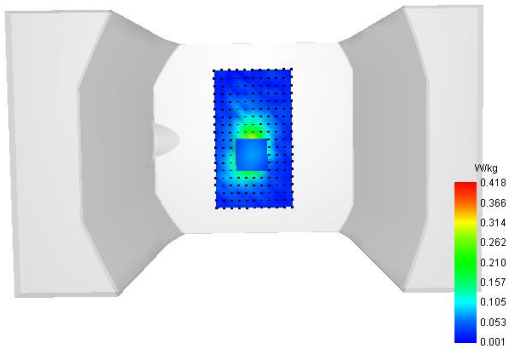
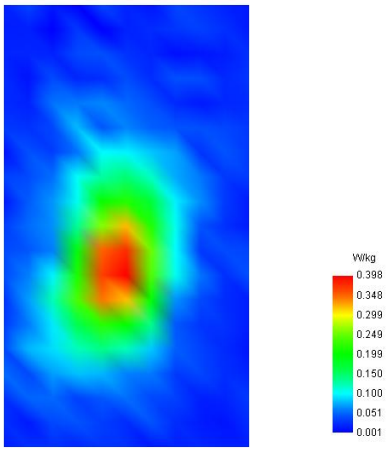


F. 3D Image

3D screen shot	Hot spot position
	

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